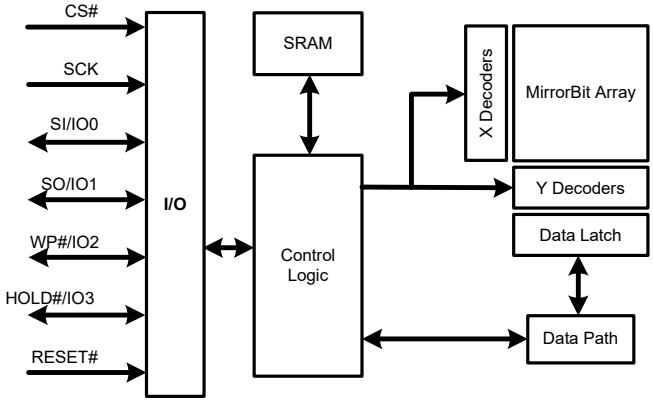
S25FL512S

512 Mbit (64 Mbyte), 3.0 V SPI Flash Memory

Features

- CMOS 3.0 Volt Core with versatile I/O
- Serial Peripheral Interface (SPI) with Multi-I/O
- Density
  - 512 Mbits (64 Mbytes)
- SPI
  - SPI Clock polarity and phase modes 0 and 3
  - Double Data Rate (DDR) option
  - Extended Addressing: 32-bit address
  - Serial Command set and footprint compatible with S25FL-A, S25FL-K, and S25FL-P SPI families
  - Multi I/O Command set and footprint compatible with S25FL-P SPI family
- READ Commands
  - Normal, Fast, Dual, Quad, Fast DDR, Dual DDR, Quad DDR
  - AutoBoot - power up or reset and execute a Normal or Quad read command automatically at a preselected address
  - Common Flash Interface (CFI) data for configuration information.
- Programming (1.5 MB/s)
  - 512-byte Page Programming buffer
  - Quad-Input Page Programming (QPP) for slow clock systems
  - Automatic ECC -internal hardware Error Correction Code generation with single bit error correction
- Erase (0.5 to 0.65 MB/s)
  - Uniform 256-kbyte sectors
- Cycling Endurance
  - 100,000 Program-Erase Cycles, minimum
- Data Retention
  - 20 Year Data Retention, minimum
- Security features
  - OTP array of 1024 bytes
  - Block Protection:
    - Status Register bits to control protection against program or erase of a contiguous range of sectors.
    - Hardware and software control options
  - Advanced Sector Protection (ASP)
    - Individual sector protection controlled by boot code or password
- Cypress® 65 nm MirrorBit® Technology with Eclipse™ Architecture
- Core Supply Voltage: 2.7 V to 3.6 V
- I/O Supply Voltage: 1.65 V to 3.6 V
  - SO16 and FBGA packages
- Temperature Range:
  - Industrial (–40 °C to +85 °C)
  - Industrial Plus (–40 °C to +105 °C)
  - Automotive, AEC-Q100 Grade 3 (–40 °C to +85 °C)
  - Automotive, AEC-Q100 Grade 2 (–40 °C to +105 °C)
  - Automotive, AEC-Q100 Grade 1 (–40 °C to +125 °C)
- Packages (all Pb-free)
  - 16-lead SOIC (300 mil)
  - BGA-24 6 × 8 mm
    - 5 × 5 ball (FAB024) and 4 × 6 ball (FAC024) footprint options
  - Known Good Die and Known Tested Die

Logic Block Diagram



Performance Summary

Maximum Read Rates with the Same Core and I/O Voltage (V_{IO} = V_{CC} = 2.7 V to 3.6 V)

Command	Clock Rate (MHz)	Mbps
Read	50	6.25
Fast Read	133	16.6
Dual Read	104	26
Quad Read	104	52

Maximum Read Rates with Lower I/O Voltage (V_{IO} = 1.65 V to 2.7 V, V_{CC} = 2.7 V to 3.6 V)

Command	Clock Rate (MHz)	Mbps
Read	50	6.25
Fast Read	66	8.25
Dual Read	66	16.5
Quad Read	66	33

Maximum Read Rates DDR (V_{IO} = V_{CC} = 3 V to 3.6 V)

Command	Clock Rate (MHz)	Mbps
Fast Read DDR	80	20
Dual Read DDR	80	40
Quad Read DDR	80	80

Typical Program and Erase Rates

Operation	kbytes/s
Page Programming (512-byte page buffer - Uniform Sector Option)	1500
256-kbyte Logical Sector Erase (Uniform Sector Option)	500

Current Consumption

Operation	Clock Rate (MHz)
Serial Read 50 MHz	16 (max)
Serial Read 133 MHz	33 (max)
Quad Read 104 MHz	61 (max)
Program	100 (max)
Erase	100 (max)
Standby	0.07 (typ)

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1. Overview

1.1 General Description

The Cypress S25FL512S device is a flash nonvolatile memory product using:

- MirrorBit technology - that stores two data bits in each memory array transistor
- Eclipse architecture - that dramatically improves program and erase performance
- 65 nm process lithography

This device connects to a host system via a Serial Peripheral Interface (SPI). Traditional SPI single bit serial input and output (Single I/O or SIO) is supported as well as optional two bit (Dual I/O or DIO) and four bit (Quad I/O or QIO) serial commands. This multiple width interface is called SPI Multi-I/O or MIO. In addition, the FL-S family adds support for Double Data Rate (DDR) read commands for SIO, DIO, and QIO that transfer address and read data on both edges of the clock.

The Eclipse architecture features a Page Programming Buffer that allows up to 256 words (512 bytes) to be programmed in one operation, resulting in faster effective programming and erase than prior generation SPI program or erase algorithms.

Executing code directly from flash memory is often called Execute-In-Place or XIP. By using FL-S devices at the higher clock rates supported, with QIO or DDR-QIO commands, the instruction read transfer rate can match or exceed traditional parallel interface, asynchronous, NOR flash memories while reducing signal count dramatically.

The S25FL512S product offers high densities coupled with the flexibility and fast performance required by a variety of embedded applications. It is ideal for code shadowing, XIP, and data storage.

1.2 Migration Notes

1.2.1 Features Comparison

The S25FL512S device is command set and footprint compatible with prior generation FL-K and FL-P families.

Table 1. FL Generations Comparison

Parameter	FL-K	FL-P	FL-S
Technology Node	90 nm	90 nm	65 nm
Architecture	Floating Gate	MirrorBit	MirrorBit Eclipse
Release Date	In Production	In Production	In Production
Density	4 Mb - 128 Mb	32 Mb - 256 Mb	512 Mb
Bus Width	x1, x2, x4	x1, x2, x4	x1, x2, x4
Supply Voltage	2.7 V - 3.6 V	2.7 V - 3.6 V	2.7 V - 3.6 V / 1.65 V - 3.6 V V_{IO}
Normal Read Speed (SDR)	6 MB/s (50 MHz)	5 MB/s (40 MHz)	6 MB/s (50 MHz)
Fast Read Speed (SDR)	13 MB/s (104 MHz)	13 MB/s (104 MHz)	17 MB/s (133 MHz)
Dual Read Speed (SDR)	26 MB/s (104 MHz)	20 MB/s (80 MHz)	26 MB/s (104 MHz)
Quad Read Speed (SDR)	52 MB/s (104 MHz)	40 MB/s (80 MHz)	52 MB/s (104 MHz)
Fast Read Speed (DDR)	–	–	20 MB/s (80 MHz)
Dual Read Speed (DDR)	–	–	40 MB/s (80 MHz)
Quad Read Speed (DDR)	–	–	80 MB/s (80 MHz)
Program Buffer Size	256B	256B	512B
Erase Sector Size	4 kB / 32 kB / 64 kB	64 kB / 256 kB	256 kB
Parameter Sector Size	4 kB	4 kB	–
Sector Erase Time (typ.)	30 ms (4 kB), 150 ms (64 kB)	500 ms (64 kB)	520 ms (256 kB)
Page Programming Time (typ.)	700 µs (256B)	1500 µs (256B)	340 µs (512B)

Table 1. FL Generations Comparison (Continued)

Parameter	FL-K	FL-P	FL-S
OTP	768B (3 x 256B)	506B	1024B
Advanced Sector Protection	No	No	Yes
Auto Boot Mode	No	No	Yes
Erase Suspend/Resume	Yes	No	Yes
Program Suspend/Resume	Yes	No	Yes
Operating Temperature	–40 °C to +85 °C	–40 °C to +85 °C / +105 °C	–40 °C to +85 °C / +105 °C

Notes
1. 256B program page option only for 128-Mb and 256-Mb density FL-S devices.
2. FL-P column indicates FL129P MIO SPI device (for 128-Mb density).
3. 64 kB sector erase option only for 128-Mb/256-Mb density FL-P and FL-S devices.
4. FL-K family devices can erase 4-kB sectors in groups of 32 kB or 64 kB.
5. Refer to individual data sheets for further details.

1.2.2 Known Differences from Prior Generations

1.2.2.1 Error Reporting

Prior generation FL memories either do not have error status bits or do not set them if program or erase is attempted on a protected sector. The FL-S family does have error reporting status bits for program and erase operations. These can be set when there is an internal failure to program or erase or when there is an attempt to program or erase a protected sector. In either case the program or erase operation did not complete as requested by the command.

1.2.2.2 Secure Silicon Region (OTP)

The size and format (address map) of the One Time Program area is different from prior generations. The method for protecting each portion of the OTP area is different. For additional details see Secure Silicon Region (OTP) on page 58.

1.2.2.3 Configuration Register Freeze Bit

The configuration register Freeze bit CR1[0], locks the state of the Block Protection bits as in prior generations. In the FL-S family it also locks the state of the configuration register TBPARM bit CR1[2], TBPROT bit CR1[5], and the Secure Silicon Region (OTP) area.

1.2.2.4 Sector Erase Commands

The command for erasing an 8-kbyte area (two 4-kbyte sectors) is not supported.

The command for erasing a 4-kbyte sector is not supported in the 512-Mbit density FL-S device.

The erase command for 64-kbyte sectors is not supported in the 512-Mbit density FL-S device.

1.2.2.5 Deep Power-Down

The Deep Power Down (DPD) function is not supported in FL-S family devices.

The legacy DPD (B9h) command code is instead used to enable legacy SPI memory controllers, that can issue the former DPD command, to access a new bank address register. The bank address register allows SPI memory controllers that do not support more than 24 bits of address, the ability to provide higher order address bits for commands, as needed to access the larger address space of the 256-Mbit density FL-S device. For additional information see Extended Address on page 45.

1.2.2.6 New Features

The FL-S family introduces several new features to SPI category memories:

- Extended address for access to higher memory density.
- AutoBoot for simpler access to boot code following power up.
- Enhanced High Performance read commands using mode bits to eliminate the overhead of SIO instructions when repeating the same type of read command.
- Multiple options for initial read latency (number of dummy cycles) for faster initial access time or higher clock rate read commands.
- DDR read commands for SIO, DIO, and QIO.
- Automatic ECC for enhanced data integrity.
- Advanced Sector Protection for individually controlling the protection of each sector. This is very similar to the Advanced Sector Protection feature found in several other Cypress parallel interface NOR memory families.

1.3 Glossary

Command	All information transferred between the host system and memory during one period while CS# is low. This includes the instruction (sometimes called an operation code or opcode) and any required address, mode bits, latency cycles, or data.
DDP (Dual Die Package)	Two die stacked within the same package to increase the memory capacity of a single package. Often also referred to as a Multi-Chip Package (MCP).
DDR (Double Data Rate)	When input and output are latched on every edge of SCK.
ECC	ECC Unit = 16 byte aligned and length data groups in the main Flash array and OTP array, each of which has its own hidden ECC syndrome to enable error correction on each group.
Flash	The name for a type of Electrical Erase Programmable Read Only Memory (EEPROM) that erases large blocks of memory bits in parallel, making the erase operation much faster than early EEPROM.
High	A signal voltage level ≥ V_{IH} or a logic level representing a binary one (1).
Instruction	The 8 bit code indicating the function to be performed by a command (sometimes called an operation code or opcode). The instruction is always the first 8 bits transferred from host system to the memory in any command.
Low	A signal voltage level ≤ V_{IL} or a logic level representing a binary zero (0).
LSB (Least Significant Bit)	Generally the right most bit, with the lowest order of magnitude value, within a group of bits of a register or data value.
MSB (Most Significant Bit)	Generally the left most bit, with the highest order of magnitude value, within a group of bits of a register or data value.
Nonvolatile	No power is needed to maintain data stored in the memory.
OPN (Ordering Part Number)	The alphanumeric string specifying the memory device type, density, package, factory nonvolatile configuration, etc. used to select the desired device.
Page	512 bytes aligned and length group of data.
PCB	Printed Circuit Board.
Register Bit References	Are in the format: Register_name[bit_number] or Register_name[bit_range_MSB: bit_range_LSB].
SDR (Single Data Rate)	When input is latched on the rising edge and output on the falling edge of SCK.
Sector	Erase unit size 256 kbytes.
Write	An operation that changes data within volatile or nonvolatile registers bits or nonvolatile flash memory. When changing nonvolatile data, an erase and reprogramming of any unchanged nonvolatile data is done, as part of the operation, such that the nonvolatile data is modified by the write operation, in the same way that volatile data is modified – as a single operation. The nonvolatile data appears to the host system to be updated by the single write command, without the need for separate commands for erase and reprogram of adjacent, but unaffected data.

1.4 Other Resources

1.4.1 Cypress Flash Memory Roadmap

www.cypress.com/product-roadmaps/cypress-flash-memory-roadmap

1.4.2 Links to Software

www.cypress.com/software-and-drivers-cypress-flash-memory

1.4.3 Links to Application Notes

www.cypress.com/cypressappnotes

Hardware Interface

Serial Peripheral Interface with Multiple Input / Output (SPI-MIO)

Many memory devices connect to their host system with separate parallel control, address, and data signals that require a large number of signal connections and larger package size. The large number of connections increase power consumption due to so many signals switching and the larger package increases cost.

The S25FL512S device reduces the number of signals for connection to the host system by serially transferring all control, address, and data information over 4 to 6 signals. This reduces the cost of the memory package, reduces signal switching power, and either reduces the host connection count or frees host connectors for use in providing other features.

The S25FL512S device uses the industry standard single bit Serial Peripheral Interface (SPI) and also supports optional extension commands for two bit (Dual) and four bit (Quad) wide serial transfers. This multiple width interface is called SPI Multi-I/O or SPI-MIO.

2. Signal Descriptions

2.1 Input/Output Summary

Table 2. Signal List

Signal Name	Type	Description
RESET#	Input	**Hardware Reset:** Low = device resets and returns to standby state, ready to receive a command. The signal has an internal pull-up resistor and may be left unconnected in the host system if not used.
SCK	Input	**Serial Clock.**
CS#	Input	**Chip Select.**
SI / IO0	I/O	**Serial Input** for single bit data commands or IO0 for Dual or Quad commands.
SO / IO1	I/O	**Serial Output** for single bit data commands. IO1 for Dual or Quad commands.
WP# / IO2	I/O	**Write Protect** when not in Quad mode. IO2 in Quad mode. The signal has an internal pull-up resistor and may be left unconnected in the host system if not used for Quad commands.
HOLD# / IO3	I/O	**Hold** (pause) serial transfer in single bit or Dual data commands. IO3 in Quad-I/O mode. The signal has an internal pull-up resistor and may be left unconnected in the host system if not used for Quad commands.
V_{CC}	Supply	**Core Power Supply.**
V_{IO}	Supply	**Versatile I/O Power Supply.**
V_{SS}	Supply	**Ground.**
NC	Unused	**Not Connected.** No device internal signal is connected to the package connector nor is there any future plan to use the connector for a signal. The connection may safely be used for routing space for a signal on a Printed Circuit Board (PCB). However, any signal connected to an NC must not have voltage levels higher than V_{IO}.
RFU	Reserved	**Reserved for Future Use.** No device internal signal is currently connected to the package connector but there is potential future use of the connector for a signal. It is recommended to not use RFU connectors for PCB routing channels so that the PCB may take advantage of future enhanced features in compatible footprint devices.
DNU	Reserved	**Do Not Use.** A device internal signal may be connected to the package connector. The connection may be used by Cypress for test or other purposes and is not intended for connection to any host system signal. Any DNU signal related function will be inactive when the signal is at V_{IL}. The signal has an internal pull-down resistor and may be left unconnected in the host system or may be tied to V_{SS}. Do not use these connections for PCB signal routing channels. Do not connect any host system signal to this connection.

2.2 Address and Data Configuration

Traditional SPI single bit wide commands (Single or SIO) send information from the host to the memory only on the SI signal. Data may be sent back to the host serially on the Serial Output (SO) signal.

Dual or Quad Output commands send information from the host to the memory only on the SI signal. Data will be returned to the host as a sequence of bit pairs on IO0 and IO1 or four bit (nibble) groups on IO0, IO1, IO2, and IO3.

Dual or Quad Input/Output (I/O) commands send information from the host to the memory as bit pairs on IO0 and IO1 or four bit (nibble) groups on IO0, IO1, IO2, and IO3. Data is returned to the host similarly as bit pairs on IO0 and IO1 or four bit (nibble) groups on IO0, IO1, IO2, and IO3.

2.3 RESET#

The RESET# input provides a hardware method of resetting the device to standby state, ready for receiving a command. When RESET# is driven to logic low (V_{IL}) for at least a period of t_{RP}, the device:

- terminates any operation in progress,
- tristates all outputs,
- resets the volatile bits in the Configuration Register,
- resets the volatile bits in the Status Registers,
- resets the Bank Address Register to zero,
- loads the Program Buffer with all ones,
- reloads all internal configuration information necessary to bring the device to standby mode,
- and resets the internal Control Unit to standby state.

RESET# causes the same initialization process as is performed when power comes up and requires t_{PU} time.

RESET# may be asserted low at any time. To ensure data integrity any operation that was interrupted by a hardware reset should be reinitiated once the device is ready to accept a command sequence.

When RESET# is first asserted Low, the device draws I_{CC1} (50 MHz value) during t_{PU}. If RESET# continues to be held at V_{SS} the device draws CMOS standby current (I_{SB}).

RESET# has an internal pull-up resistor and may be left unconnected in the host system if not used.

The RESET# input is not available on all packages options. When not available the RESET# input of the device is tied to the inactive state, inside the package.

2.4 Serial Clock (SCK)

This input signal provides the synchronization reference for the SPI interface. Instructions, addresses, or data input are latched on the rising edge of the SCK signal. Data output changes after the falling edge of SCK, in SDR commands, and after every edge in DDR commands.

2.5 Chip Select (CS#)

The chip select signal indicates when a command for the device is in process and the other signals are relevant for the memory device. When the CS# signal is at the logic high state, the device is not selected and all input signals are ignored and all output signals are high impedance. Unless an internal Program, Erase or Write Registers (WRR) embedded operation is in progress, the device will be in the Standby Power mode. Driving the CS# input to logic low state enables the device, placing it in the Active Power mode. After Power-up, a falling edge on CS# is required prior to the start of any command.

2.6 Serial Input (SI) / I/O0

This input signal is used to transfer data serially into the device. It receives instructions, addresses, and data to be programmed. Values are latched on the rising edge of serial SCK clock signal.

SI becomes I/O0 - an input and output during Dual and Quad commands for receiving instructions, addresses, and data to be programmed (values latched on rising edge of serial SCK clock signal) as well as shifting out data (on the falling edge of SCK, in SDR commands, and on every edge of SCK, in DDR commands).

2.7 Serial Output (SO) / I/O1

This output signal is used to transfer data serially out of the device. Data is shifted out on the falling edge of the serial SCK clock signal.

SO becomes IO1 - an input and output during Dual and Quad commands for receiving addresses, and data to be programmed (values latched on rising edge of serial SCK clock signal) as well as shifting out data (on the falling edge of SCK, in SDR commands, and on every edge of SCK, in DDR commands).

2.8 Write Protect (WP#) / I/O2

When WP# is driven Low (V_{IL}), during a WRR command and while the Status Register Write Disable (SRWD) bit of the Status Register is set to a 1, it is not possible to write to the Status and Configuration Registers. This prevents any alteration of the Block Protect (BP2, BP1, BP0) and TBPROT bits of the Status Register. As a consequence, all the data bytes in the memory area that are protected by the Block Protect and TBPROT bits, are also hardware protected against data modification if WP# is Low during a WRR command.

The WP# function is not available when the Quad mode is enabled (CR[1]=1). The WP# function is replaced by IO2 for input and output during Quad mode for receiving addresses, and data to be programmed (values are latched on rising edge of the SCK signal) as well as shifting out data (on the falling edge of SCK, in SDR commands, and on every edge of SCK, in DDR commands).

WP# has an internal pull-up resistor; when unconnected, WP# is at V_{IH} and may be left unconnected in the host system if not used for Quad mode.

2.9 Hold (HOLD#) / I/O3

The Hold (HOLD#) signal is used to pause any serial communications with the device without deselecting the device or stopping the serial clock.

To enter the Hold condition, the device must be selected by driving the CS# input to the logic low state. It is recommended that the user keep the CS# input low state during the entire duration of the Hold condition. This is to ensure that the state of the interface logic remains unchanged from the moment of entering the Hold condition. If the CS# input is driven to the logic high state while the device is in the Hold condition, the interface logic of the device will be reset. To restart communication with the device, it is necessary to drive HOLD# to the logic high state while driving the CS# signal into the logic low state. This prevents the device from going back into the Hold condition.

The Hold condition starts on the falling edge of the Hold (HOLD#) signal, provided that this coincides with SCK being at the logic low state. If the falling edge does not coincide with the SCK signal being at the logic low state, the Hold condition starts whenever the SCK signal reaches the logic low state. Taking the HOLD# signal to the logic low state does not terminate any Write, Program or Erase operation that is currently in progress.

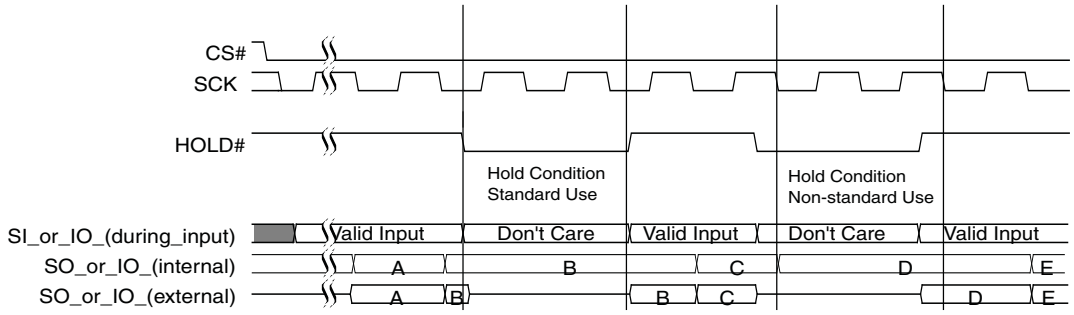
During the Hold condition, SO is in high impedance and both the SI and SCK input are Don't Care.

The Hold condition ends on the rising edge of the Hold (HOLD#) signal, provided that this coincides with the SCK signal being at the logic low state. If the rising edge does not coincide with the SCK signal being at the logic low state, the Hold condition ends whenever the SCK signal reaches the logic low state.

The HOLD# function is not available when the Quad mode is enabled (CR1[1] =1). The Hold function is replaced by I/O3 for input and output during Quad mode for receiving addresses, and data to be programmed (values are latched on rising edge of the SCK signal) as well as shifting out data (on the falling edge of SCK, in SDR commands, and on every edge of SCK, in DDR commands).

The HOLD# signal has an internal pull-up resistor and may be left unconnected in the host system if not used for Quad mode.

Figure 1. HOLD Mode Operation



2.10 Core Voltage Supply (V_{CC})

V_{CC} is the voltage source for all device internal logic. It is the single voltage used for all device internal functions including read, program, and erase. The voltage may vary from 2.7V to 3.6V.

2.11 Versatile I/O Power Supply (V_{IO})

The Versatile I/O (V_{IO}) supply is the voltage source for all device input receivers and output drivers and allows the host system to set the voltage levels that the device tolerates on all inputs and drives on outputs (address, control, and I/O signals). The V_{IO} range is 1.65V to V_{CC}. V_{IO} cannot be greater than V_{CC}.

For example, a V_{IO} of 1.65 V - 3.6 V allows for I/O at the 1.8 V, 2.5 V or 3 V levels, driving and receiving signals to and from other 1.8 V, 2.5 V or 3 V devices on the same data bus. V_{IO} may be tied to V_{CC} so that interface signals operate at the same voltage as the core of the device. V_{IO} is not available in all package options, when not available the V_{IO} supply is tied to V_{CC} internal to the package.

During the rise of power supplies the V_{IO} supply voltage must remain less than or equal to the V_{CC} supply voltage.

This supply is not available in all package options. For a backward compatible with the SO16 package, the V_{IO} supply is tied to V_{CC} inside the package; thus, the I/O will function at V_{CC} level.

2.12 Supply and Signal Ground (V_{SS})

V_{SS} is the common voltage drain and ground reference for the device core, input signal receivers, and output drivers.

2.13 Not Connected (NC)

No device internal signal is connected to the package connector nor is there any future plan to use the connector for a signal. The connection may safely be used for routing space for a signal on a Printed Circuit Board (PCB). However, any signal connected to an NC must not have voltage levels higher than V_{IO}.

2.14 Reserved for Future Use (RFU)

No device internal signal is currently connected to the package connector but is there potential future use of the connector. It is recommended to not use RFU connectors for PCB routing channels so that the PCB may take advantage of future enhanced features in compatible footprint devices.

2.15 Do Not Use (DNU)

A device internal signal may be connected to the package connector. The connection may be used by Cypress for test or other purposes and is not intended for connection to any host system signal. Any DNU signal related function will be inactive when the signal is at V_{IL}. The signal has an internal pull-down resistor and may be left unconnected in the host system or may be tied to V_{SS}. Do not use these connections for PCB signal routing channels. Do not connect any host system signal to these connections.

2.16 Block Diagrams

Figure 2. Bus Master and Memory Devices on the SPI Bus — Single Bit Data Path

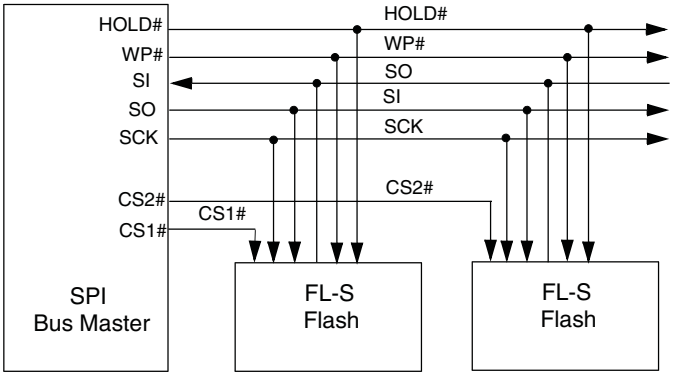


Figure 3. Bus Master and Memory Devices on the SPI Bus — Dual Bit Data Path

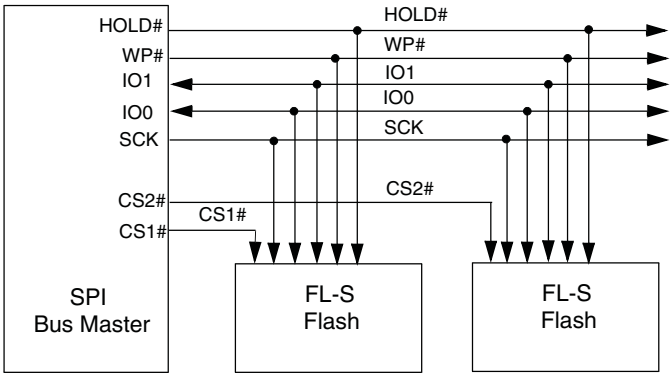
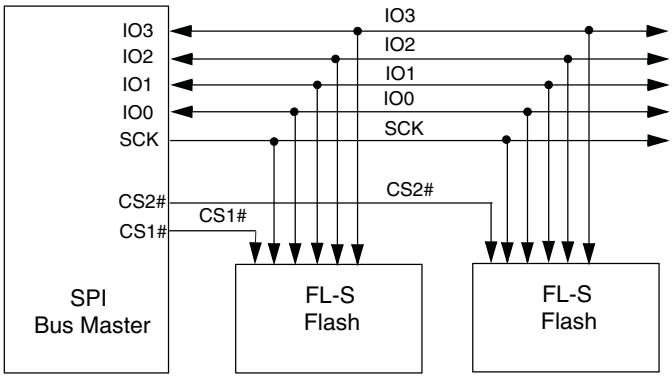


Figure 4. Bus Master and Memory Devices on the SPI Bus — Quad Bit Data Path



3. Signal Protocols

3.1 SPI Clock Modes

3.1.1 Single Data Rate (SDR)

The S25FL512S device can be driven by an embedded microcontroller (bus master) in either of the two following clocking modes.

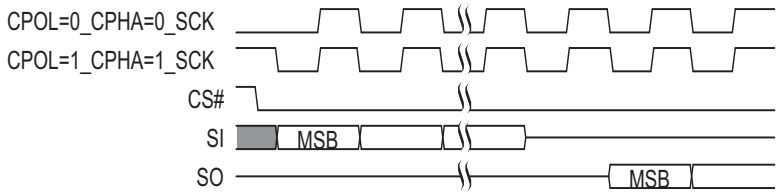
- **Mode 0** with Clock Polarity (CPOL) = 0 and, Clock Phase (CPHA) = 0
- **Mode 3** with CPOL = 1 and, CPHA = 1

For these two modes, input data into the device is always latched in on the rising edge of the SCK signal and the output data is always available from the falling edge of the SCK clock signal.

The difference between the two modes is the clock polarity when the bus master is in standby mode and not transferring any data.

- SCK will stay at logic low state with CPOL = 0, CPHA = 0
- SCK will stay at logic high state with CPOL = 1, CPHA = 1

Figure 5. SPI SDR Modes Supported



Timing diagrams throughout the remainder of the document are generally shown as both mode 0 and 3 by showing SCK as both high and low at the fall of CS#. In some cases a timing diagram may show only mode 0 with SCK low at the fall of CS#. In such a case, mode 3 timing simply means clock is high at the fall of CS# so no SCK rising edge set up or hold time to the falling edge of CS# is needed for mode 3.

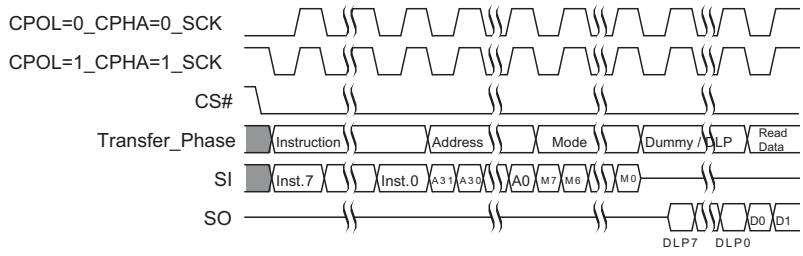
SCK cycles are measured (counted) from one falling edge of SCK to the next falling edge of SCK. In mode 0 the beginning of the first SCK cycle in a command is measured from the falling edge of CS# to the first falling edge of SCK because SCK is already low at the beginning of a command.

3.1.2 Double Data Rate (DDR)

Mode 0 and Mode 3 are also supported for DDR commands. In DDR commands, the instruction bits are always latched on the rising edge of clock, the same as in SDR commands. However, the address and input data that follow the instruction are latched on both the rising and falling edges of SCK. The first address bit is latched on the first rising edge of SCK following the falling edge at the end of the last instruction bit. The first bit of output data is driven on the falling edge at the end of the last access latency (dummy) cycle.

SCK cycles are measured (counted) in the same way as in SDR commands, from one falling edge of SCK to the next falling edge of SCK. In mode 0 the beginning of the first SCK cycle in a command is measured from the falling edge of CS# to the first falling edge of SCK because SCK is already low at the beginning of a command.

Figure 6. SPI DDR Modes Supported



3.2 Command Protocol

All communication between the host system and S25FL512S memory device is in the form of units called commands.

All commands begin with an instruction that selects the type of information transfer or device operation to be performed. Commands may also have an address, instruction modifier, latency period, data transfer to the memory, or data transfer from the memory. All instruction, address, and data information is transferred serially between the host system and memory device.

All instructions are transferred from host to memory as a single bit serial sequence on the SI signal.

Single bit wide commands may provide an address or data sent only on the SI signal. Data may be sent back to the host serially on the SO signal.

Dual or Quad Output commands provide an address sent to the memory only on the SI signal. Data will be returned to the host as a sequence of bit pairs on I/O0 and I/O1 or four bit (nibble) groups on I/O0, I/O1, I/O2, and I/O3.

Dual or Quad Input/Output (I/O) commands provide an address sent from the host as bit pairs on I/O0 and I/O1 or, four-bit (nibble) groups on I/O0, I/O1, I/O2, and I/O3. Data is returned to the host similarly as bit pairs on I/O0 and I/O1 or, four bit (nibble) groups on I/O0, I/O1, I/O2, and I/O3.

Commands are structured as follows:

- Each command begins with CS# going low and ends with CS# returning high. The memory device is selected by the host driving the Chip Select (CS#) signal low throughout a command.
- The serial clock (SCK) marks the transfer of each bit or group of bits between the host and memory.
- Each command begins with an 8-bit (byte) instruction. The instruction is always presented only as a single bit serial sequence on the Serial Input (SI) signal with one bit transferred to the memory device on each SCK rising edge. The instruction selects the type of information transfer or device operation to be performed.
- The instruction may be stand alone or may be followed by address bits to select a location within one of several address spaces in the device. The instruction determines the address space used. The address may be either a 24-bit or a 32-bit byte boundary, address. The address transfers occur on SCK rising edge, in SDR commands, or on every SCK edge, in DDR commands.
- The width of all transfers following the instruction are determined by the instruction sent. Following transfers may continue to be single bit serial on only the SI or Serial Output (SO) signals, they may be done in 2-bit groups per (dual) transfer on the I/O0 and I/O1 signals, or they may be done in 4-bit groups per (quad) transfer on the I/O0-I/O3 signals. Within the dual or quad groups the least significant bit is on I/O0. More significant bits are placed in significance order on each higher numbered I/O signal. Single bits or parallel bit groups are transferred in most to least significant bit order.
- Some instructions send an instruction modifier called mode bits, following the address, to indicate that the next command will be of the same type with an implied, rather than an explicit, instruction. The next command thus does not provide an instruction byte, only a new address and mode bits. This reduces the time needed to send each command when the same command type is repeated in a sequence of commands. The mode bit transfers occur on SCK rising edge, in SDR commands, or on every SCK edge, in DDR commands.
- The address or mode bits may be followed by write data to be stored in the memory device or by a read latency period before read data is returned to the host.
- Write data bit transfers occur on SCK rising edge, in SDR commands, or on every SCK edge, in DDR commands.
- SCK continues to toggle during any read access latency period. The latency may be zero to several SCK cycles (also referred to as dummy cycles). At the end of the read latency cycles, the first read data bits are driven from the outputs on SCK falling edge at the end of the last read latency cycle. The first read data bits are considered transferred to the host on the following SCK rising edge. Each following transfer occurs on the next SCK rising edge, in SDR commands, or on every SCK edge, in DDR commands.
- If the command returns read data to the host, the device continues sending data transfers until the host takes the CS# signal high. The CS# signal can be driven high after any transfer in the read data sequence. This will terminate the command.

- At the end of a command that does not return data, the host drives the CS# input high. The CS# signal must go high after the eighth bit, of a stand alone instruction or, of the last write data byte that is transferred. That is, the CS# signal must be driven high when the number of clock cycles after CS# signal was driven low is an exact multiple of eight cycles. If the CS# signal does not go high exactly at the eight SCK cycle boundary of the instruction or write data, the command is rejected and not executed.
- All instruction, address, and mode bits are shifted into the device with the Most Significant Bits (MSB) first. The data bits are shifted in and out of the device MSB first. All data is transferred in byte units with the lowest address byte sent first. Following bytes of data are sent in lowest to highest byte address order i.e. the byte address increments.
- All attempts to read the flash memory array during a program, erase, or a write cycle (embedded operations) are ignored. The embedded operation will continue to execute without any affect. A very limited set of commands are accepted during an embedded operation. These are discussed in the individual command descriptions.
- Depending on the command, the time for execution varies. A command to read status information from an executing command is available to determine when the command completes execution and whether the command was successful.

3.2.1 Command Sequence Examples

Figure 7. Stand Alone Instruction Command

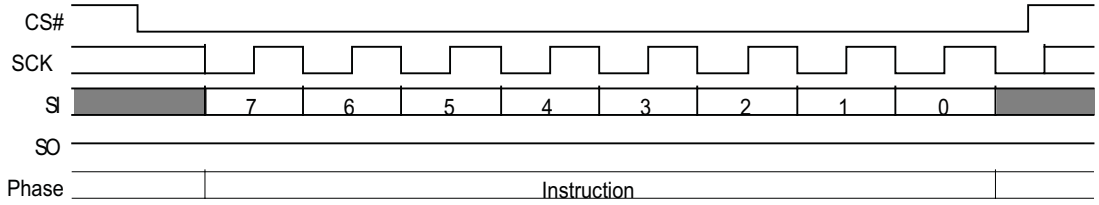


Figure 8. Single Bit Wide Input Command

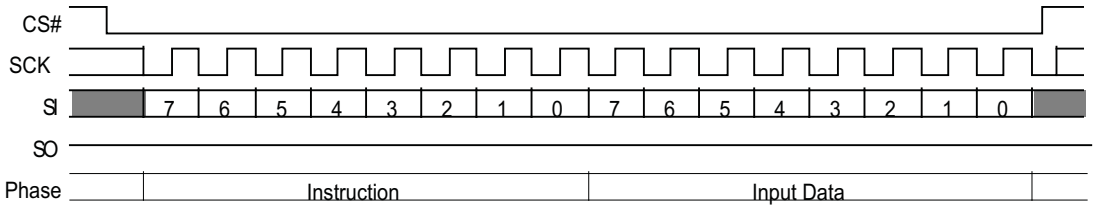


Figure 9. Single Bit Wide Output Command

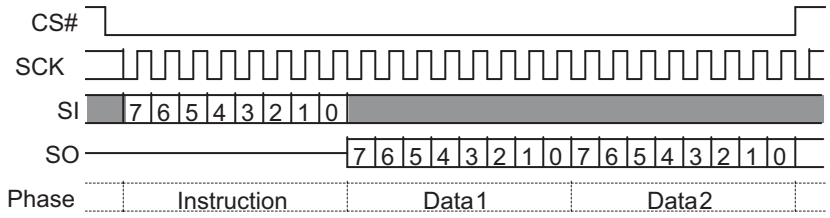


Figure 10. Single Bit Wide I/O Command without Latency

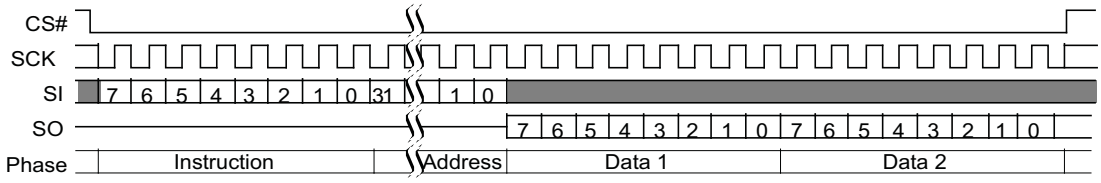


Figure 11. Single Bit Wide I/O Command with Latency

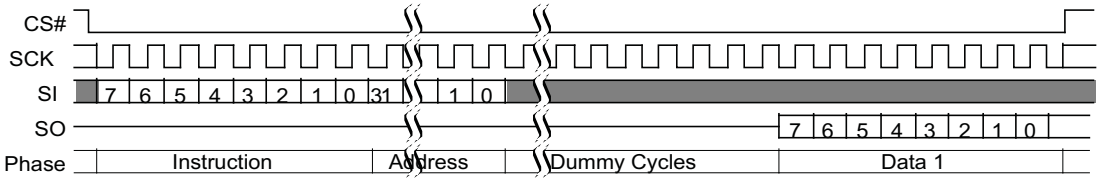


Figure 12. Dual Output Command

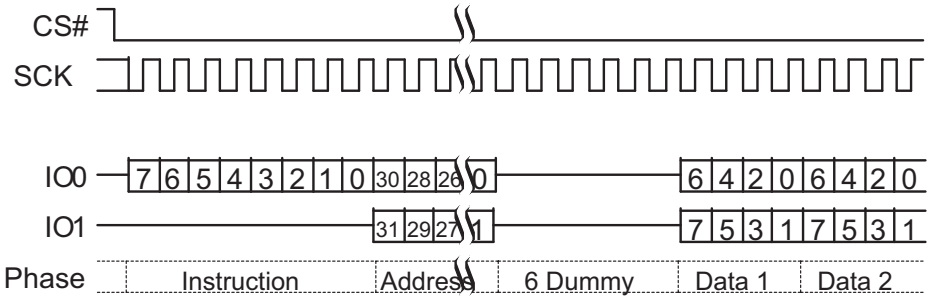


Figure 13. Quad Output Command without Latency

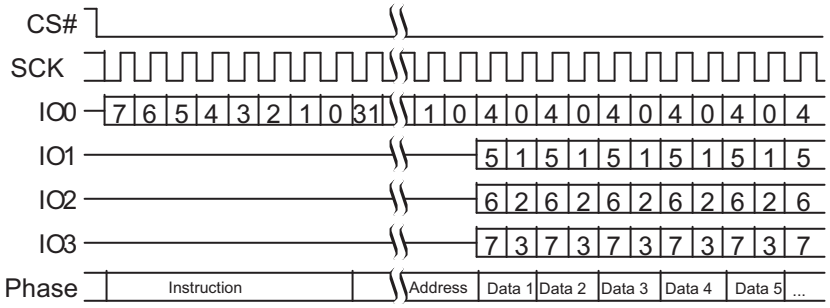


Figure 14. Dual I/O Command

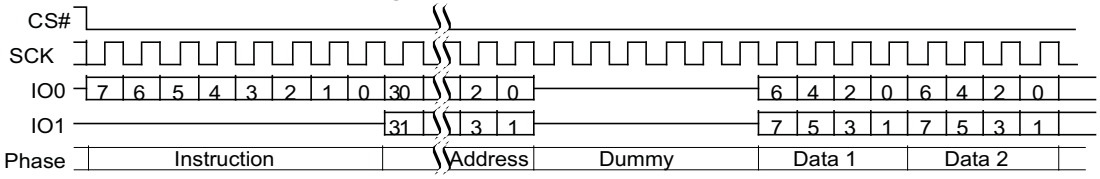


Figure 15. Quad I/O Command

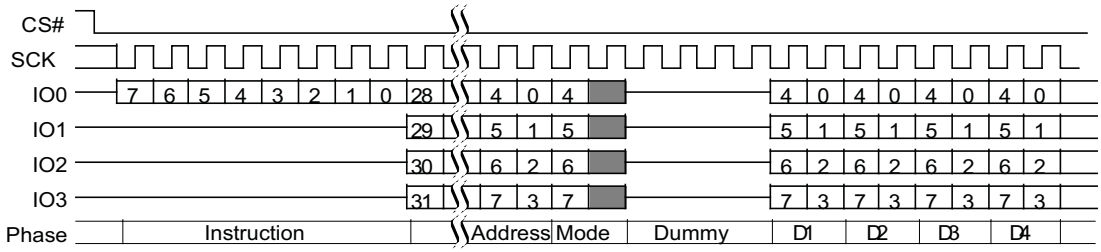


Figure 16. DDR Fast Read with EHPLC = 00b

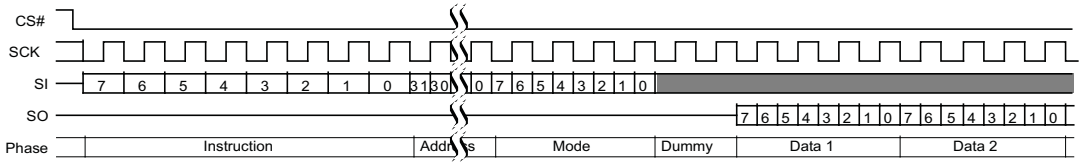


Figure 17. DDR Dual I/O Read with EHPLC = 01b and DLP

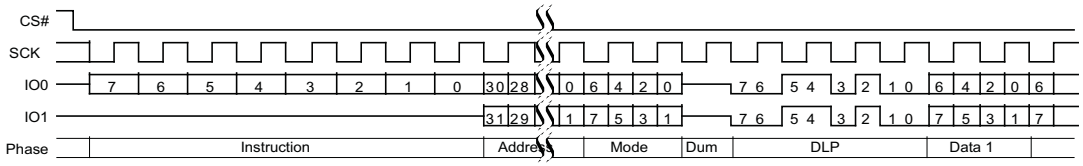
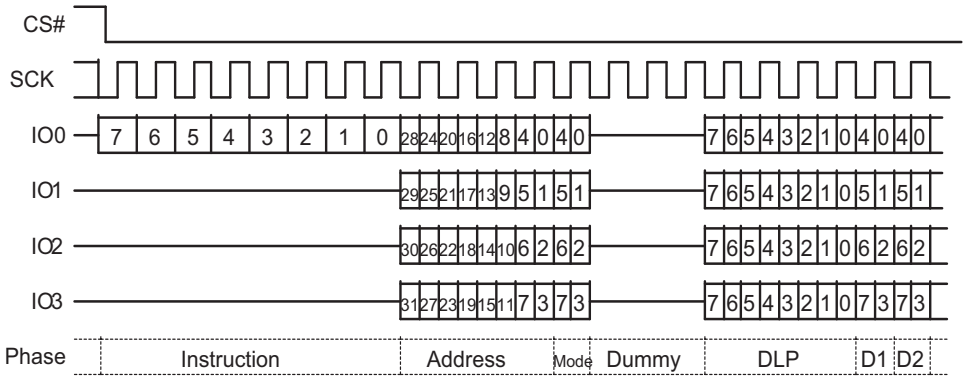


Figure 18. DDR Quad I/O Read



Additional sequence diagrams, specific to each command, are provided in Commands on page 64.

3.3 Interface States

This section describes the input and output signal levels as related to the SPI interface behavior.

Table 3. Interface States Summary

Interface State	V_{CC}	V_{IO}	RESET#	SCK	CS#	HOLD# / I/O3	WP# / z I/O2	SO / I/O1	SI / I/O0
Power-Off	< V_{CC} (low)	≤ V_{CC}	X	X	X	X	X	Z	X
Low Power Hardware Data Protection	< V_{CC} (cut-off)	≤ V_{CC}	X	X	X	X	X	Z	X
Power-On (Cold) Reset	≥ V_{CC} (min)	≥ V_{IO} (min) ≤ V_{CC}	X	X	X	X	X	Z	X
Hardware (Warm) Reset	≥ V_{CC} (min)	≥ V_{IO} (min) ≤ V_{CC}	HL	X	X	X	X	Z	X
Interface Standby	≥ V_{CC} (min)	≥ V_{IO} (min) ≤ V_{CC}	HH	X	HH	X	X	Z	X
Instruction Cycle	≥ V_{CC} (min)	≥ V_{IO} (min) ≤ V_{CC}	HH	HT	HL	HH	HV	Z	HV

Table 3. Interface States Summary (Continued)

Interface State	V_{CC}	V_{IO}	RESET#	SCK	CS#	HOLD# / I/O3	WP# / z I/O2	SO / I/O1	SI / I/O0
Hold Cycle	≥ V_{CC} (min)	≥ V_{IO} (min) ≤ V_{CC}	HH	HV or HT	HL	HL	X	X	X
Single Input Cycle Host to Memory Transfer	≥ V_{CC} (min)	≥ V_{IO} (min) ≤ V_{CC}	HH	HT	HL	HH	X	Z	HV
Single Latency (Dummy) Cycle	≥ V_{CC} (min)	≥ V_{IO} (min) ≤ V_{CC}	HH	HT	HL	HH	X	Z	X
Single Output Cycle Memory to Host Transfer	≥ V_{CC} (min)	≥ V_{IO} (min) ≤ V_{CC}	HH	HT	HL	HH	X	MV	X
Dual Input Cycle Host to Memory Transfer	≥ V_{CC} (min)	≥ V_{IO} (min) ≤ V_{CC}	HH	HT	HL	HH	X	HV	HV
Dual Latency (Dummy) Cycle	≥ V_{CC} (min)	≥ V_{IO} (min) ≤ V_{CC}	HH	HT	HL	HH	X	X	X
Dual Output Cycle Memory to Host Transfer	≥ V_{CC} (min)	≥ V_{IO} (min) ≤ V_{CC}	HH	HT	HL	HH	X	MV	MV
QPP Address Input Cycle Host to Memory Transfer	≥ V_{CC} (min)	≥ V_{IO} (min) ≤ V_{CC}	HH	HT	HL	X	X	X	HV
Quad Input Cycle Host to Memory Transfer	≥ V_{CC} (min)	≥ V_{IO} (min) ≤ V_{CC}	HH	HT	HL	HV	HV	HV	HV
Quad Latency (Dummy) Cycle	≥ V_{CC} (min)	≥ V_{IO} (min) ≤ V_{CC}	HH	HT	HL	X	X	X	X
Quad Output Cycle Memory to Host Transfer	≥ V_{CC} (min)	≥ V_{IO} (min) ≤ V_{CC}	HH	HT	HL	MV	MV	MV	MV
DDR Single Input Cycle Host to Memory Transfer	≥ V_{CC} (min)	≥ V_{IO} (min) ≤ V_{CC}	HH	HT	HL	X	X	X	HV
DDR Dual Input Cycle Host to Memory Transfer	≥ V_{CC} (min)	≥ V_{IO} (min) ≤ V_{CC}	HH	HT	HL	X	X	HV	HV
DDR Quad Input Cycle Host to Memory Transfer	≥ V_{CC} (min)	≥ V_{IO} (min) ≤ V_{CC}	HH	HT	HL	HV	HV	HV	HV
DDR Latency (Dummy) Cycle	≥ V_{CC} (min)	≥ V_{IO} (min) ≤ V_{CC}	HH	HT	HL	MV or Z	MV or Z	MV or Z	MV or Z
DDR Single Output Cycle Memory to Host Transfer	≥ V_{CC} (min)	≥ V_{IO} (min) ≤ V_{CC}	HH	HT	HL	Z	Z	MV	X
DDR Dual Output Cycle Memory to Host Transfer	≥ V_{CC} (min)	≥ V_{IO} (min) ≤ V_{CC}	HH	HT	HL	Z	Z	MV	MV
DDR Quad Output Cycle Memory to Host Transfer	≥ V_{CC} (min)	≥ V_{IO} (min) ≤ V_{CC}	HH	HT	HL	MV	MV	MV	MV

Legend:
Z = no driver - floating signal
HL = Host driving V_{IL}
HH = Host driving V_{IH}
HV = either HL or HH
X = HL or HH or Z
HT = Toggling between HL and HH
ML = Memory driving V_{IL}
MH = Memory driving V_{IH}
MV = either ML or MH

3.3.1 Power-Off

When the core supply voltage is at or below the V_{CC} (low) voltage, the device is considered to be powered off. The device does not react to external signals, and is prevented from performing any program or erase operation.

3.3.2 Low Power Hardware Data Protection

When V_{CC} is less than V_{CC} (cut-off) the memory device will ignore commands to ensure that program and erase operations can not start when the core supply voltage is out of the operating range.

3.3.3 Power-On (Cold) Reset

When the core voltage supply remains at or below the V_{CC} (low) voltage for ≥ t_{PD} time, then rises to ≥ $V_{CC\ (Minimum)}$ the device will begin its Power-On Reset (POR) process. POR continues until the end of t_{PU}. During t_{PU} the device does not react to external input signals nor drive any outputs. Following the end of t_{PU} the device transitions to the Interface Standby state and can accept commands. For additional information on POR see Power-On (Cold) Reset on page 30.

3.3.4 Hardware (Warm) Reset

Some of the device package options provide a RESET# input. When RESET# is driven low for t_{RP} time the device starts the hardware reset process. The process continues for t_{RPH} time. Following the end of both t_{RPH} and the reset hold time following the rise of RESET# (t_{RH}) the device transitions to the Interface Standby state and can accept commands. For additional information on hardware reset see POR followed by Hardware Reset on page 30.

3.3.5 Interface Standby

When CS# is high the SPI interface is in standby state. Inputs other than RESET# are ignored. The interface waits for the beginning of a new command. The next interface state is Instruction Cycle when CS# goes low to begin a new command.

While in interface standby state the memory device draws standby current (I_{SB}) if no embedded algorithm is in progress. If an embedded algorithm is in progress, the related current is drawn until the end of the algorithm when the entire device returns to standby current draw.

3.3.6 Instruction Cycle

When the host drives the MSB of an instruction and CS# goes low, on the next rising edge of SCK the device captures the MSB of the instruction that begins the new command. On each following rising edge of SCK the device captures the next lower significance bit of the 8 bit instruction. The host keeps RESET# high, CS# low, HOLD# high, and drives Write Protect (WP#) signal as needed for the instruction. However, WP# is only relevant during instruction cycles of a WRR command and is otherwise ignored.

Each instruction selects the address space that is operated on and the transfer format used during the remainder of the command. The transfer format may be Single, Dual output, Quad output, Dual I/O, Quad I/O, DDR Single I/O, DDR Dual I/O, or DDR Quad I/O. The expected next interface state depends on the instruction received.

Some commands are stand alone, needing no address or data transfer to or from the memory. The host returns CS# high after the rising edge of SCK for the eighth bit of the instruction in such commands. The next interface state in this case is Interface Standby.

3.3.7 Hold

When Quad mode is not enabled (CR[1]=0) the HOLD# / I/O3 signal is used as the HOLD# input. The host keeps RESET# high, HOLD# low, SCK may be at a valid level or continue toggling, and CS# is low. When HOLD# is low a command is paused, as though SCK were held low. SI / I/O0 and SO / I/O1 ignore the input level when acting as inputs and are high impedance when acting as outputs during hold state. Whether these signals are input or output depends on the command and the point in the command sequence when HOLD# is asserted low.

When HOLD# returns high the next state is the same state the interface was in just before HOLD# was asserted low.

When Quad mode is enabled the HOLD# / I/O3 signal is used as I/O3.

During DDR commands the HOLD# and WP# inputs are ignored.

3.3.8 Single Input Cycle - Host to Memory Transfer

Several commands transfer information after the instruction on the single serial input (SI) signal from host to the memory device. The dual output, and quad output commands send address to the memory using only SI but return read data using the I/O signals. The host keeps RESET# high, CS# low, HOLD# high, and drives SI as needed for the command. The memory does not drive the Serial Output (SO) signal.

The expected next interface state depends on the instruction. Some instructions continue sending address or data to the memory using additional Single Input Cycles. Others may transition to Single Latency, or directly to Single, Dual, or Quad Output.

3.3.9 Single Latency (Dummy) Cycle

Read commands may have zero to several latency cycles during which read data is read from the main flash memory array before transfer to the host. The number of latency cycles are determined by the Latency Code in the configuration register (CR[7:6]). During the latency cycles, the host keeps RESET# high, CS# low, and HOLD# high. The Write Protect (WP#) signal is ignored. The host may drive the SI signal during these cycles or the host may leave SI floating. The memory does not use any data driven on SI / I/O0 or other I/O signals during the latency cycles. In dual or quad read commands, the host must stop driving the I/O signals on the falling edge at the end of the last latency cycle. It is recommended that the host stop driving I/O signals during latency cycles so that there is sufficient time for the host drivers to turn off before the memory begins to drive at the end of the latency cycles. This prevents driver conflict between host and memory when the signal direction changes. The memory does not drive the Serial Output (SO) or I/O signals during the latency cycles.

The next interface state depends on the command structure i.e. the number of latency cycles, and whether the read is single, dual, or quad width.

3.3.10 Single Output Cycle - Memory to Host Transfer

Several commands transfer information back to the host on the single Serial Output (SO) signal. The host keeps RESET# high, CS# low, and HOLD# high. The Write Protect (WP#) signal is ignored. The memory ignores the Serial Input (SI) signal. The memory drives SO with data.

The next interface state continues to be Single Output Cycle until the host returns CS# to high ending the command.

3.3.11 Dual Input Cycle - Host to Memory Transfer

The Read Dual I/O command transfers two address or mode bits to the memory in each cycle. The host keeps RESET# high, CS# low, HOLD# high. The Write Protect (WP#) signal is ignored. The host drives address on SI / I/O0 and SO / I/O1.

The next interface state following the delivery of address and mode bits is a Dual Latency Cycle if there are latency cycles needed or Dual Output Cycle if no latency is required.

3.3.12 Dual Latency (Dummy) Cycle

Read commands may have zero to several latency cycles during which read data is read from the main flash memory array before transfer to the host. The number of latency cycles are determined by the Latency Code in the configuration register (CR[7:6]). During the latency cycles, the host keeps RESET# high, CS# low, and HOLD# high. The Write Protect (WP#) signal is ignored. The host may drive the SI / I/O0 and SO / I/O1 signals during these cycles or the host may leave SI / I/O0 and SO / I/O1 floating. The memory does not use any data driven on SI / I/O0 and SO / I/O1 during the latency cycles. The host must stop driving SI / I/O0 and SO / I/O1 on the falling edge at the end of the last latency cycle. It is recommended that the host stop driving them during all latency cycles so that there is sufficient time for the host drivers to turn off before the memory begins to drive at the end of the latency cycles. This prevents driver conflict between host and memory when the signal direction changes. The memory does not drive the SI / I/O0 and SO / I/O1 signals during the latency cycles.

The next interface state following the last latency cycle is a Dual Output Cycle.

3.3.13 Dual Output Cycle - Memory to Host Transfer

The Read Dual Output and Read Dual I/O return data to the host two bits in each cycle. The host keeps RESET# high, CS# low, and HOLD# high. The Write Protect (WP#) signal is ignored. The memory drives data on the SI / I/O0 and SO / I/O1 signals during the dual output cycles.

The next interface state continues to be Dual Output Cycle until the host returns CS# to high ending the command.

3.3.14 QPP or QOR Address Input Cycle

The Quad Page Program and Quad Output Read commands send address to the memory only on I/O0. The other I/O signals are ignored because the device must be in Quad mode for these commands thus the Hold and Write Protect features are not active. The host keeps RESET# high, CS# low, and drives I/O0.

For QPP the next interface state following the delivery of address is the Quad Input Cycle.

For QOR the next interface state following address is a Quad Latency Cycle if there are latency cycles needed or Quad Output Cycle if no latency is required.

3.3.15 Quad Input Cycle - Host to Memory Transfer

The Quad I/O Read command transfers four address or mode bits to the memory in each cycle. The Quad Page Program command transfers four data bits to the memory in each cycle. The host keeps RESET# high, CS# low, and drives the I/O signals.

For Quad I/O Read the next interface state following the delivery of address and mode bits is a Quad Latency Cycle if there are latency cycles needed or Quad Output Cycle if no latency is required. For Quad Page Program the host returns CS# high following the delivery of data to be programmed and the interface returns to standby state.

3.3.16 Quad Latency (Dummy) Cycle

Read commands may have zero to several latency cycles during which read data is read from the main flash memory array before transfer to the host. The number of latency cycles are determined by the Latency Code in the configuration register (CR[7:6]). During the latency cycles, the host keeps RESET# high, CS# low. The host may drive the I/O signals during these cycles or the host may leave the I/O floating. The memory does not use any data driven on I/O during the latency cycles. The host must stop driving the I/O signals on the falling edge at the end of the last latency cycle. It is recommended that the host stop driving them during all latency cycles so that there is sufficient time for the host drivers to turn off before the memory begins to drive at the end of the latency cycles. This prevents driver conflict between host and memory when the signal direction changes. The memory does not drive the I/O signals during the latency cycles.

The next interface state following the last latency cycle is a Quad Output Cycle.

3.3.17 Quad Output Cycle - Memory to Host Transfer

The Quad Output Read and Quad I/O Read return data to the host four bits in each cycle. The host keeps RESET# high, and CS# low. The memory drives data on I/O0-I/O3 signals during the Quad output cycles.

The next interface state continues to be Quad Output Cycle until the host returns CS# to high ending the command.

3.3.18 DDR Single Input Cycle - Host to Memory Transfer

The DDR Fast Read command sends address, and mode bits to the memory only on the I/O0 signal. One bit is transferred on the rising edge of SCK and one bit on the falling edge in each cycle. The host keeps RESET# high, and CS# low. The other I/O signals are ignored by the memory.

The next interface state following the delivery of address and mode bits is a DDR Latency Cycle.

3.3.19 DDR Dual Input Cycle - Host to Memory Transfer

The DDR Dual I/O Read command sends address, and mode bits to the memory only on the I/O0 and I/O1 signals. Two bits are transferred on the rising edge of SCK and two bits on the falling edge in each cycle. The host keeps RESET# high, and CS# low. The I/O2 and I/O3 signals are ignored by the memory.

The next interface state following the delivery of address and mode bits is a DDR Latency Cycle.

3.3.20 DDR Quad Input Cycle - Host to Memory Transfer

The DDR Quad I/O Read command sends address, and mode bits to the memory on all the I/O signals. Four bits are transferred on the rising edge of SCK and four bits on the falling edge in each cycle. The host keeps RESET# high, and CS# low.

The next interface state following the delivery of address and mode bits is a DDR Latency Cycle.

3.3.21 DDR Latency Cycle

DDR Read commands may have one to several latency cycles during which read data is read from the main flash memory array before transfer to the host. The number of latency cycles are determined by the Latency Code in the configuration register (CR[7:6]). During the latency cycles, the host keeps RESET# high and CS# low. The host may not drive the I/O signals during these cycles. So that there is sufficient time for the host drivers to turn off before the memory begins to drive. This prevents driver conflict between host and memory when the signal direction changes. The memory has an option to drive all the I/O signals with a Data Learning Pattern (DLP) during the last 4 latency cycles. The DLP option should not be enabled when there are fewer than five latency cycles so that there is at least one cycle of high impedance for turn around of the I/O signals before the memory begins driving the DLP. When there are more than 4 cycles of latency the memory does not drive the I/O signals until the last four cycles of latency.

The next interface state following the last latency cycle is a DDR Single, Dual, or Quad Output Cycle, depending on the instruction.

3.3.22 DDR Single Output Cycle - Memory to Host Transfer

The DDR Fast Read command returns bits to the host only on the SO / I/O1 signal. One bit is transferred on the rising edge of SCK and one bit on the falling edge in each cycle. The host keeps RESET# high, and CS# low. The other I/O signals are not driven by the memory.

The next interface state continues to be DDR Single Output Cycle until the host returns CS# to high ending the command.

3.3.23 DDR Dual Output Cycle - Memory to Host Transfer

The DDR Dual I/O Read command returns bits to the host only on the I/O0 and I/O1 signals. Two bits are transferred on the rising edge of SCK and two bits on the falling edge in each cycle. The host keeps RESET# high, and CS# low. The I/O2 and I/O3 signals are not driven by the memory.

The next interface state continues to be DDR Dual Output Cycle until the host returns CS# to high ending the command.

3.3.24 DDR Quad Output Cycle - Memory to Host Transfer

The DDR Quad I/O Read command returns bits to the host on all the I/O signals. Four bits are transferred on the rising edge of SCK and four bits on the falling edge in each cycle. The host keeps RESET# high, and CS# low.

The next interface state continues to be DDR Quad Output Cycle until the host returns CS# to high ending the command.

3.4 Configuration Register Effects on the Interface

The configuration register bits 7 and 6 (CR1[7:6]) select the latency code for all read commands. The latency code selects the number of mode bit and latency cycles for each type of instruction.

The configuration register bit 1 (CR1[1]) selects whether Quad mode is enabled to ignore HOLD# and WP# and allow Quad Page Program, Quad Output Read, and Quad I/O Read commands. Quad mode must also be selected to allow Read DDR Quad I/O commands.

3.5 Data Protection

Some basic protection against unintended changes to stored data are provided and controlled purely by the hardware design. These are described below. Other software managed protection methods are discussed in the software section (page 45) of this document.

3.5.1 Power-Up

When the core supply voltage is at or below the V_{CC} (low) voltage, the device is considered to be powered off. The device does not react to external signals, and is prevented from performing any program or erase operation. Program and erase operations continue to be prevented during the Power-on Reset (POR) because no command is accepted until the exit from POR to the Interface Standby state.

3.5.2 Low Power

When V_{CC} is less than V_{CC} (cut-off) the memory device will ignore commands to ensure that program and erase operations can not start when the core supply voltage is out of the operating range.

3.5.3 Clock Pulse Count

The device verifies that all program, erase, and Write Registers (WRR) commands consist of a clock pulse count that is a multiple of eight before executing them. A command not having a multiple of 8 clock pulse count is ignored and no error status is set for the command.

4. Electrical Specifications

4.1 Absolute Maximum Ratings

Table 4. Absolute Maximum Ratings

Storage Temperature Plastic Packages	–65°C to +150°C
Ambient Temperature with Power Applied	–65°C to +125°C
V_{CC}	–0.5V to +4.0V
V_{IO} (Note 1)	–0.5V to +4.0V
Input Voltage with Respect to Ground (V_{SS}) (Note 2)	–0.5V to +(V_{IO} + 0.5V)
Output Short Circuit Current (Note 3)	100 mA

Notes
1. V_{IO} must always be less than or equal V_{CC} + 200 mV.
2. See Input Signal Overshoot on page 25 for allowed maximums during signal transition.
3. No more than one output may be shorted to ground at a time. Duration of the short circuit should not be greater than one second.
4. Stresses above those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those indicated in the operational sections of this data sheet is not implied. Exposure of the device to absolute maximum rating conditions for extended periods may affect device reliability.

4.2 Thermal Resistance

Table 5. Thermal Resistance

Parameter	Description	SO3016	FAB024	FAC024	Unit
Theta JA	Thermal resistance (junction to ambient)	30.6	36	36.5	°C/W

4.3 Operating Ranges

Operating ranges define those limits between which the functionality of the device is guaranteed.

4.3.1 Power Supply Voltages

Some package options provide access to a separate input and output buffer power supply called V_{IO}. Packages which do not provide the separate V_{IO} connection, internally connect the device V_{IO} to V_{CC}. For these packages the references to V_{IO} are then also references to V_{CC}.

V_{CC}	2.7V to 3.6V
V_{IO}	1.65V to V_{CC} +200 mV

4.3.2 Temperature Ranges

Parameter	Symbol	Device	Spec		Unit
			Min	Max	
Ambient Temperature	T_A	Industrial (I)	–40	+85	°C
		Industrial Plus (V)	–40	+105	
		Automotive, AEC-Q100 Grade 3 (A)	–40	+85	
		Automotive, AEC-Q100 Grade 2 (B)	–40	+105	
		Automotive, AEC-Q100 Grade 1 (M)	–40	+125	

Note
1. Industrial Plus operating and performance parameters will be determined by device characterization and may vary from standard industrial temperature range devices as currently shown in this specification.

4.3.3 Input Signal Overshoot

During DC conditions, input or I/O signals should remain equal to or between V_{SS} and V_{IO}. During voltage transitions, inputs or I/Os may overshoot V_{SS} to –2.0V or overshoot to V_{IO} +2.0V, for periods up to 20 ns.

Figure 19. Maximum Negative Overshoot Waveform

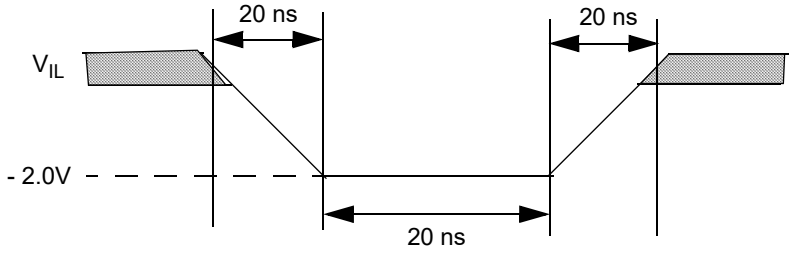
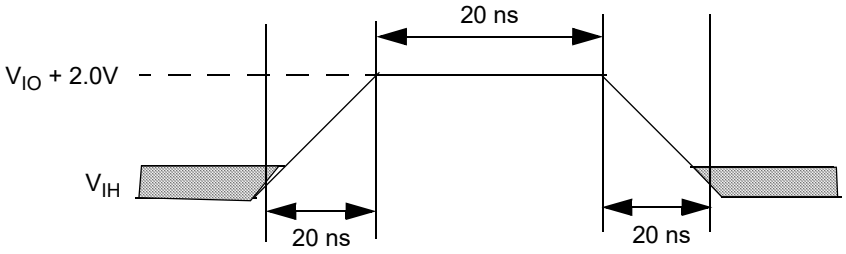


Figure 20. Maximum Positive Overshoot Waveform



4.4 Power-Up and Power-Down

The device must not be selected at power-up or power-down (that is, CS# must follow the voltage applied on V_{CC}) until V_{CC} reaches the correct value as follows:

- V_{CC} (min) at power-up, and then for a further delay of t_{PU}
- V_{SS} at power-down

A simple pull-up resistor (generally of the order of 100 kΩ) on Chip Select (CS#) can usually be used to insure safe and proper power-up and power-down.

The device ignores all instructions until a time delay of t_{PU} has elapsed after the moment that V_{CC} rises above the minimum V_{CC} threshold. See Figure 21. However, correct operation of the device is not guaranteed if V_{CC} returns below V_{CC} (min) during t_{PU}. No command should be sent to the device until the end of t_{PU}.

After power-up (t_{PU}), the device is in Standby mode (not Deep Power Down mode), draws CMOS standby current (I_{SB}), and the WEL bit is reset.

During power-down or voltage drops below V_{CC} (cut-off), the voltage must drop below V_{CC} (low) for a period of t_{PD} for the part to initialize correctly on power-up. See Figure 22. If during a voltage drop the V_{CC} stays above V_{CC} (cut-off) the part will stay initialized and will work correctly when V_{CC} is again above V_{CC} (min). In the event Power-on Reset (POR) did not complete correctly after power up, the assertion of the RESET# signal or receiving a software reset command (RESET) will restart the POR process.

Normal precautions must be taken for supply rail decoupling to stabilize the V_{CC} supply at the device. Each device in a system should have the V_{CC} rail decoupled by a suitable capacitor close to the package supply connection (this capacitor is generally of the order of 0.1 µf).

Table 6. Power-Up / Power-Down Voltage and Timing

Symbol	Parameter	Min	Max	Unit
V_{CC} (min)	V_{CC} (minimum operation voltage)	2.7	–	V
V_{CC} (cut-off)	V_{CC} (Cut 0ff where re-initialization is needed)	2.4	–	V
V_{CC} (low)	V_{CC} (low voltage for initialization to occur) V_{CC} (Low voltage for initialization to occur at embedded)	1.6 2.3	–	V
t_{PU}	V_{CC} (min) to Read operation	–	300	µs
t_{PD}	V_{CC} (low) time	10.0	–	µs

Figure 21. Power-Up

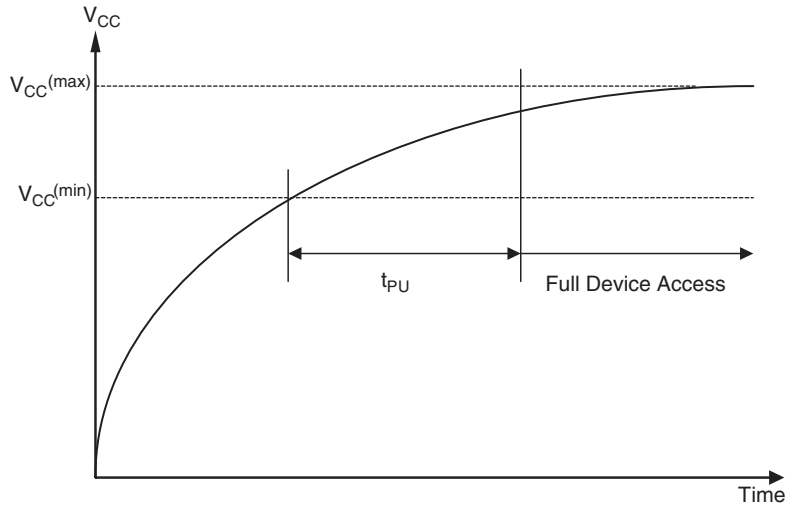
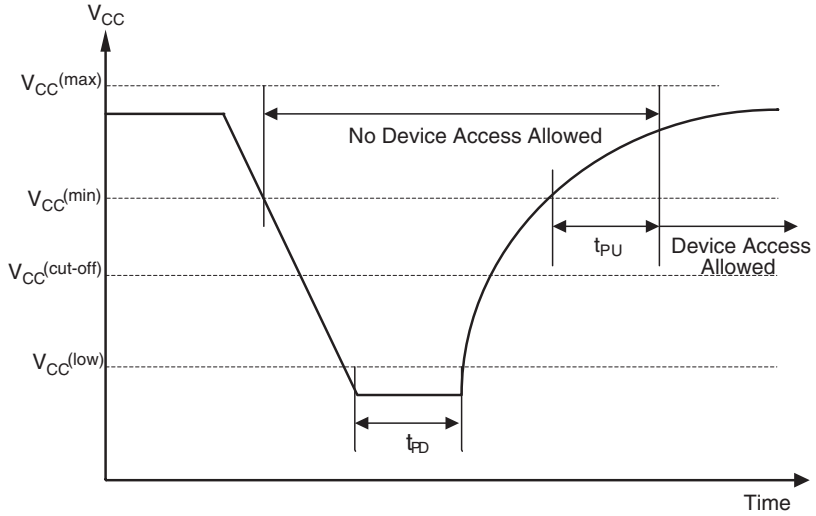


Figure 22. Power-Down and Voltage Drop



4.5 DC Characteristics

Applicable within operating ranges.

Table 7. DC Characteristics

Symbol	Parameter	Test Conditions	Min	Typ [1]	Max	Unit
V_{IL}	Input Low Voltage		-0.5	–	0.2 x V_{IO}	V
V_{IH}	Input High Voltage		0.7 x V_{IO}	–	V_{IO}+0.4	V
V_{OL}	Output Low Voltage	I_{OL} = 1.6 mA, V_{CC} = V_{CC} min		–	0.15 x V_{IO}	V
V_{OH}	Output High Voltage	I_{OH} = –0.1 mA	0.85 x V_{IO}	–		V
I_{LI}	Input Leakage Current	V_{CC} = V_{CC} Max, V_{IN} = V_{IH} or V_{IL}	–	–	±2	µA
I_{LO}	Output Leakage Current	V_{CC} = V_{CC} Max, V_{IN} = V_{IH} or V_{IL}	–	–	±2	µA
I_{CC1}	Active Power Supply Current (READ)	Serial SDR@50 MHz Serial SDR@133 MHz Quad SDR @ 80 MHz Quad SDR @104 MHz Quad DDR @ 66 MHz Quad DDR @80 MHz Outputs unconnected during read data return[2]	–	–	16 33/35 [3] 50 61 75 90	mA
I_{CC2}	Active Power Supply Current (Page Program)	CS# = V_{IO}	–	–	100	mA
I_{CC3}	Active Power Supply Current (WRR)	CS# = V_{IO}	–	–	100	mA
I_{CC4}	Active Power Supply Current (SE)	CS# = V_{IO}	–	–	100	mA
I_{CC5}	Active Power Supply Current (BE)	CS# = V_{IO}	–	–	100	mA
I_{SB} (Industrial)	Standby Current	RESET#, CS# = V_{IO}; SI, SCK = V_{IO} or V_{SS}, Industrial Temp	–	70	100	µA
I_{SB} (Industrial Plus)	Standby Current	RESET#, CS# = V_{IO}; SI, SCK = V_{IO} or V_{SS}, Industrial Plus Temp	–	70	300	µA

Notes

1. Typical values are at T_{AI} = 25°C and V_{CC} = V_{IO} = 3V.
2. Output switching current is not included.
3. Industrial temperature range / Industrial Plus temperature range.

4.5.1 Active Power and Standby Power Modes

The device is enabled and in the Active Power mode when Chip Select (CS#) is Low. When CS# is high, the device is disabled, but may still be in an Active Power mode until all program, erase, and write operations have completed. The device then goes into the Standby Power mode, and power consumption drops to I_{SB}.

5. Timing Specifications

5.1 Key to Switching Waveforms

Figure 23. Waveform Element Meanings

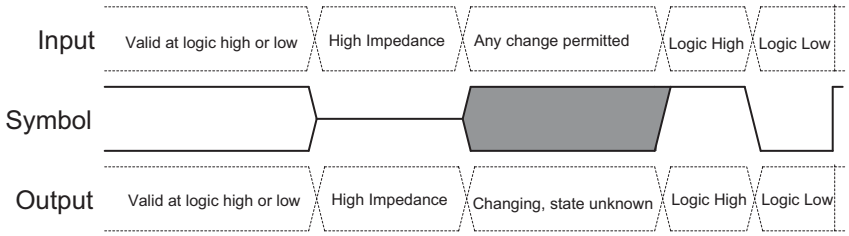
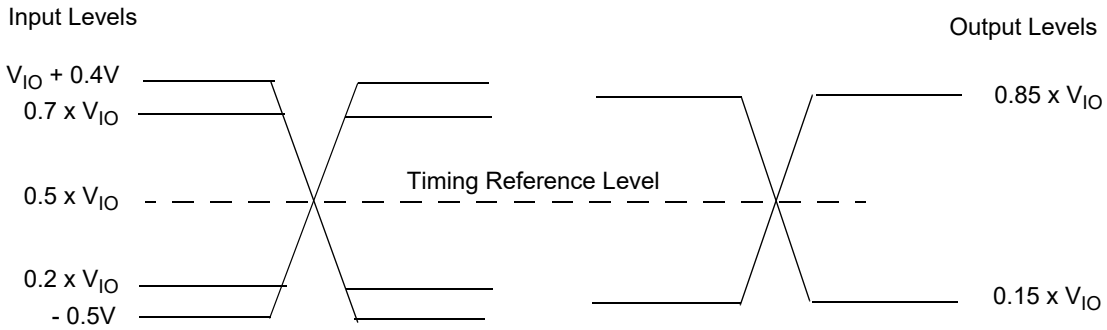


Figure 24. Input, Output, and Timing Reference Levels



5.2 AC Test Conditions

Figure 25. Test Setup

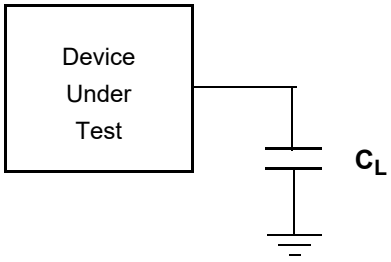


Table 8. AC Measurement Conditions

Symbol	Parameter	Min	Max	Unit
C_L	Load Capacitance	30 15 [4]		pF
	Input Rise and Fall Times	–	2.4	ns
	Input Pulse Voltage	0.2 x V_{IO} to 0.8 V_{IO}		V
	Input Timing Ref Voltage	0.5 V_{IO}		V
	Output Timing Ref Voltage	0.5 V_{IO}		V

Notes
1. Output High-Z is defined as the point where data is no longer driven.
2. Input slew rate: 1.5 V/ns.
3. AC characteristics tables assume clock and data signals have the same slew rate (slope).
4. DDR Operation.

5.2.1 Capacitance Characteristics

Table 9. Capacitance

	Parameter	Test Conditions	Min	Max	Unit
C_{IN}	Input Capacitance (applies to SCK, CS#, RESET#)	1 MHz, T_A = 25°C	–	8	pF
C_{OUT}	Output Capacitance (applies to All I/O)	1 MHz, T_A = 25°C	–	8	pF

Note
1. For more information on capacitance, please consult the IBIS models.

5.3 Reset

5.3.1 Power-On (Cold) Reset

The device executes a Power-On Reset (POR) process until a time delay of t_{PU} has elapsed after the moment that V_{CC} rises above the minimum V_{CC} threshold. See Figure 21 on page 26, Table 6 on page 26, and Table 10 on page 31. The device must not be selected (CS# to go high with V_{IO}) during power-up (t_{PU}), i.e. no commands may be sent to the device until the end of t_{PU}. RESET# is ignored during POR. If RESET# is low during POR and remains low through and beyond the end of t_{PU}, CS# must remain high until t_{RH} after RESET# returns high. RESET# must return high for greater than t_{RS} before returning low to initiate a hardware reset.

Figure 26. Reset Low at the End of POR

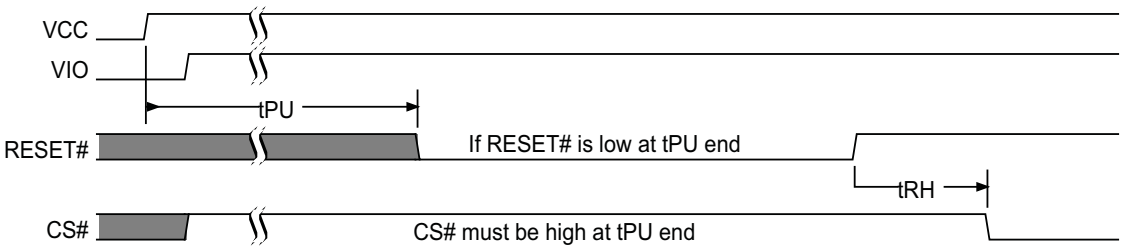


Figure 27. Reset High at the End of POR

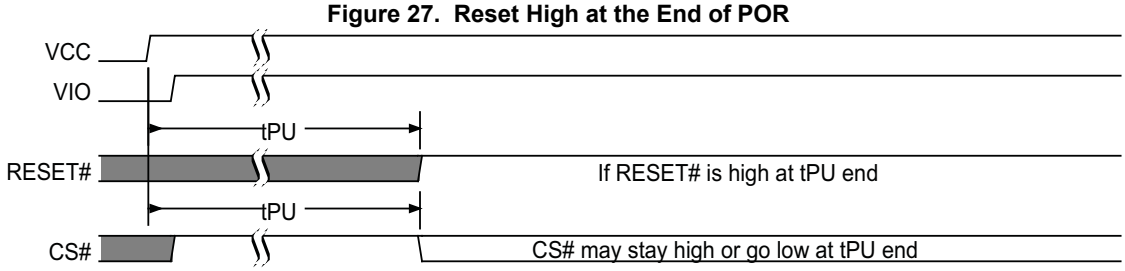
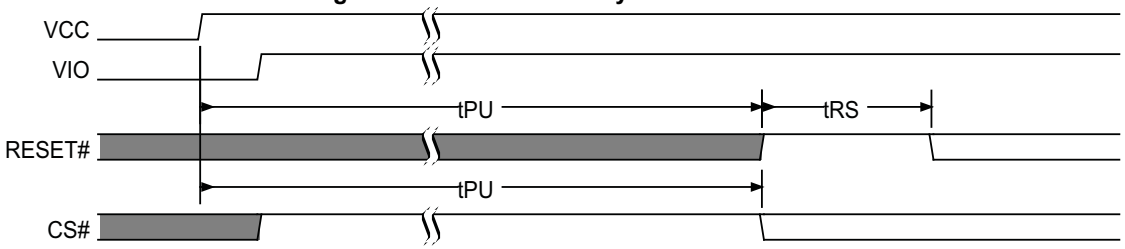


Figure 28. POR followed by Hardware Reset



5.3.2 Hardware (Warm) Reset

When the RESET# input transitions from V_{IH} to V_{IL} the device will reset register states in the same manner as power-on reset but, does not go through the full reset process that is performed during POR. The hardware reset process requires a period of t_{RPH} to complete. If the POR process did not complete correctly for any reason during power-up (t_{PU}), RESET# going low will initiate the full POR process instead of the hardware reset process and will require t_{PU} to complete the POR process.

The RESET# input provides a hardware method of resetting the flash memory device to standby state.

- RESET# must be high for t_{RS} following t_{PU} or t_{RPH}, before going low again to initiate a hardware reset.
- When RESET# is driven low for at least a minimum period of time (t_{RP}), the device terminates any operation in progress, tri-states all outputs, and ignores all read/write commands for the duration of t_{RPH}. The device resets the interface to standby state.

- If CS# is low at the time RESET# is asserted, CS# must return high during t_{RPH} before it can be asserted low again after t_{RH}.
- Hardware Reset is only offered in 16-lead SOIC and BGA packages.

Figure 29. Hardware Reset

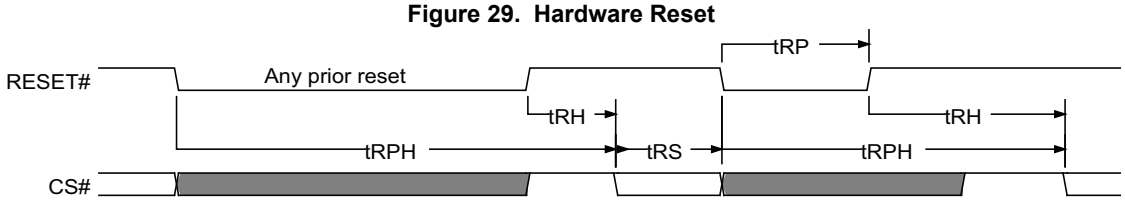


Table 10. Hardware Reset Parameters

Parameter	Description	Limit	Time	Unit
t_{RS}	Reset Setup - Prior Reset end and RESET# high before RESET# low	Min	50	ns
t_{RPH}	Reset Pulse Hold - RESET# low to CS# low	Min	35	µs
t_{RP}	RESET# Pulse Width	Min	200	ns
t_{RH}	Reset Hold - RESET# high before CS# low	Min	50	ns

Notes

1. RESET# Low is optional and ignored during Power-up (t_{PU}). If Reset# is asserted during the end of t_{PU}, the device will remain in the reset state and t_{RH} will determine when CS# may go Low.
2. Sum of t_{RP} and t_{RH} must be equal to or greater than t_{RPH}.

5.4 SDR AC Characteristics

Table 11. AC Characteristics (Single Die Package, V_{IO} = V_{CC} 2.7V to 3.6V)

Symbol	Parameter	Min	Typ	Max	Unit
$F_{SCK, R}$	SCK Clock Frequency for READ and 4READ instructions	DC	–	50	MHz
$F_{SCK, C}$	SCK Clock Frequency for single commands as shown in Table 39 on page 67 [4]	DC	–	133	MHz
$F_{SCK, C}$	SCK Clock Frequency for the following dual and quad commands: DOR, 4DOR, QOR, 4QOR, DIOR, 4DIOR, QIOR, 4QIOR	DC	–	104	MHz
$F_{SCK, QPP}$	SCK Clock Frequency for the QPP, 4QPP commands	DC	–	80	MHz
P_{SCK}	SCK Clock Period	1/ F_{SCK}	–	∞	
t_{WH}, t_{CH}	Clock High Time [5]	45% P_{SCK}	–	–	ns
t_{WL}, t_{CL}	Clock Low Time [5]	45% P_{SCK}	–	–	ns
t_{CRT}, t_{CLCH}	Clock Rise Time (slew rate)	0.1	–	–	V/ns
t_{CFT}, t_{CHCL}	Clock Fall Time (slew rate)	0.1	–	–	V/ns
t_{CS}	CS# High Time (Read Instructions) CS# High Time (Program/Erase)	10 50	–	–	ns
t_{CSS}	CS# Active Setup Time (relative to SCK)	3	–	–	ns
t_{CSH}	CS# Active Hold Time (relative to SCK)	3	–	–	ns
t_{SU}	Data in Setup Time	1.5	–	3000 [6]	ns
t_{HD}	Data in Hold Time	2	–		ns
t_V	Clock Low to Output Valid	–	–	8.0 [2] 7.65 [3] 6.5 [4]	ns
t_{HO}	Output Hold Time	2	–		ns
t_{DIS}	Output Disable Time	0	–	8	ns
t_{WPS}	WP# Setup Time	20 [1]	–	–	ns
t_{WPH}	WP# Hold Time	100 [1]	–	–	ns
t_{HLCH}	HOLD# Active Setup Time (relative to SCK)	3	–	–	ns
t_{CHHH}	HOLD# Active Hold Time (relative to SCK)	3	–	–	ns
t_{HHCH}	HOLD# Non Active Setup Time (relative to SCK)	3	–	–	ns
t_{CHHL}	HOLD# Non Active Hold Time (relative to SCK)	3	–	–	ns
t_{HZ}	HOLD# enable to Output Invalid	–	–	8	ns
t_{LZ}	HOLD# disable to Output Valid	–	–	8	ns

Notes

1. Only applicable as a constraint for WRR instruction when SRWD is set to a 1.
2. Full V_{CC} range (2.7 - 3.6V) and CL = 30 pF.
3. Regulated V_{CC} range (3.0 - 3.6V) and CL = 30 pF.
4. Regulated V_{CC} range (3.0 - 3.6V) and CL = 15 pF.
5. ±10% duty cycle is supported for frequencies ≤ 50 MHz.
6. Maximum value only applies during Program/Erase Suspend/Resume commands.

Table 12. AC Characteristics (Single Die Package, V_{IO} 1.65V to 2.7V, V_{CC} 2.7V to 3.6V)

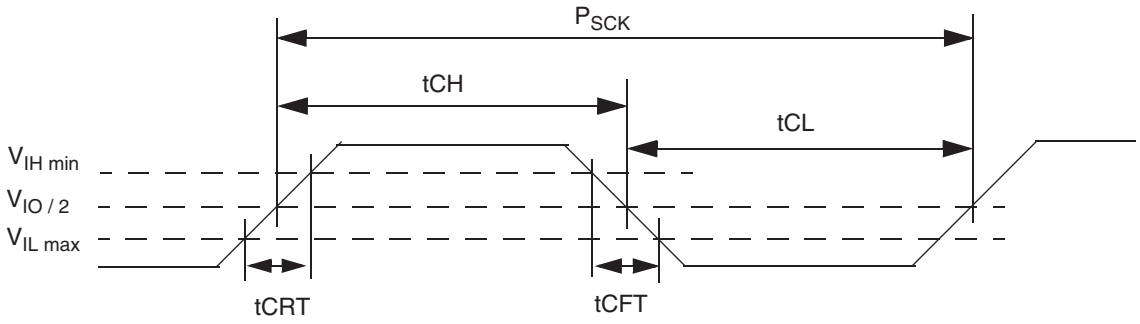
Symbol	Parameter	Min	Typ	Max	Unit
$F_{SCK, R}$	SCK Clock Frequency for READ, 4READ instructions	DC	–	50	MHz
$F_{SCK, C}$	SCK Clock Frequency for all others [3]	DC	–	66	MHz
P_{SCK}	SCK Clock Period	1/ F_{SCK}	–	∞	
t_{WH}, t_{CH}	Clock High Time [4]	45% P_{SCK}	–	–	ns
t_{WL}, t_{CL}	Clock Low Time [4]	45% P_{SCK}	–	–	ns
t_{CRT}, t_{CLCH}	Clock Rise Time (slew rate)	0.1	–	–	V/ns
t_{CFT}, t_{CHCL}	Clock Fall Time (slew rate)	0.1	–	–	V/ns
t_{CS}	CS# High Time (Read Instructions) CS# High Time (Program/Erase)	10 50	–	–	ns
t_{CSS}	CS# Active Setup Time (relative to SCK)	10	–	–	ns
t_{CSH}	CS# Active Hold Time (relative to SCK)	3	–	–	ns
t_{SU}	Data in Setup Time	5	–	3000 [5]	ns
t_{HD}	Data in Hold Time	4	–		ns
t_V	Clock Low to Output Valid	–	–	14.5 [2] 12.0 [3]	ns
t_{HO}	Output Hold Time	2	–		ns
t_{DIS}	Output Disable Time	0	–	14	ns
t_{WPS}	WP# Setup Time	20 [1]	–	–	ns
t_{WPH}	WP# Hold Time	100 [1]	–	–	ns
t_{HLCH}	HOLD# Active Setup Time (relative to SCK)	5	–	–	ns
t_{CHHH}	HOLD# Active Hold Time (relative to SCK)	5	–	–	ns
t_{HHCH}	HOLD# Non Active Setup Time (relative to SCK)	5	–	–	ns
t_{CHHL}	HOLD# Non Active Hold Time (relative to SCK)	5	–	–	ns
t_{HZ}	HOLD# enable to Output Invalid	–	–	14	ns
t_{LZ}	HOLD# disable to Output Valid	–	–	14	ns

Notes

1. Only applicable as a constraint for WRR instruction when SRWD is set to a 1.
2. CL = 30 pF.
3. CL = 15 pF.
4. ±10% duty cycle is supported for frequencies ≤ 50 MHz.
5. Maximum value only applies during Program/Erase Suspend/Resume commands.

5.4.1 Clock Timing

Figure 30. Clock Timing



5.4.2 Input / Output Timing

Figure 31. SPI Single Bit Input Timing

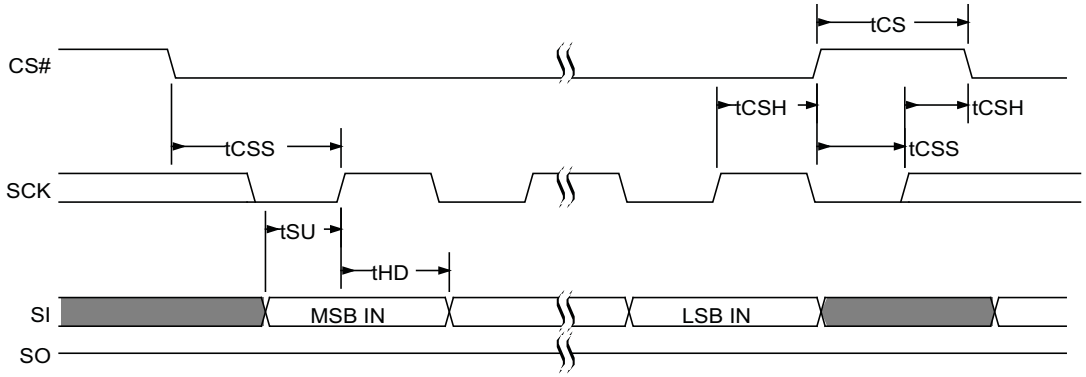


Figure 32. SPI Single Bit Output Timing

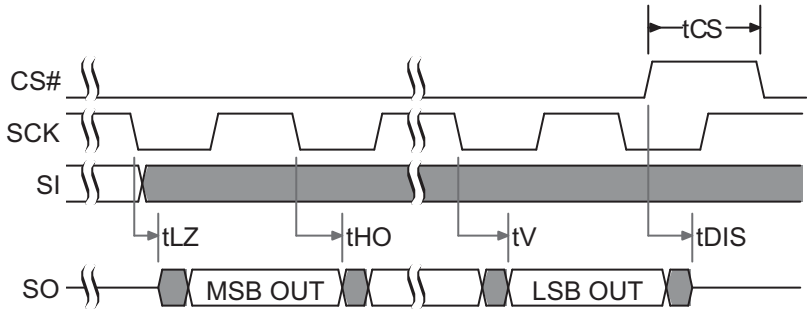


Figure 33. SPI SDR MIO Timing

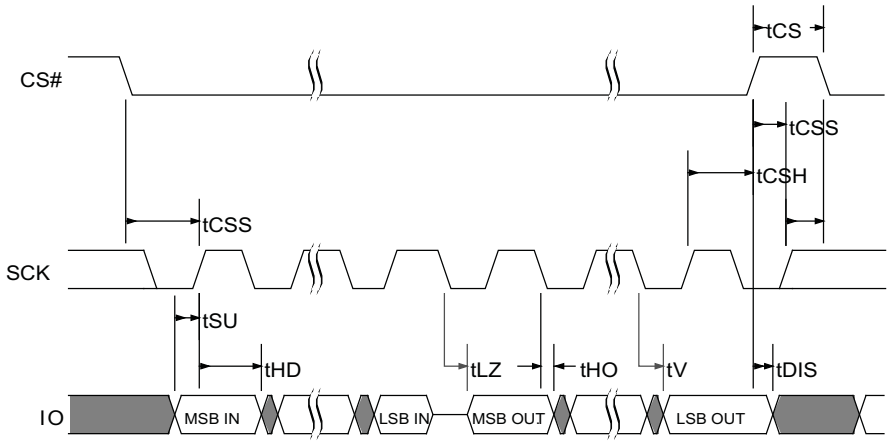


Figure 34. Hold Timing

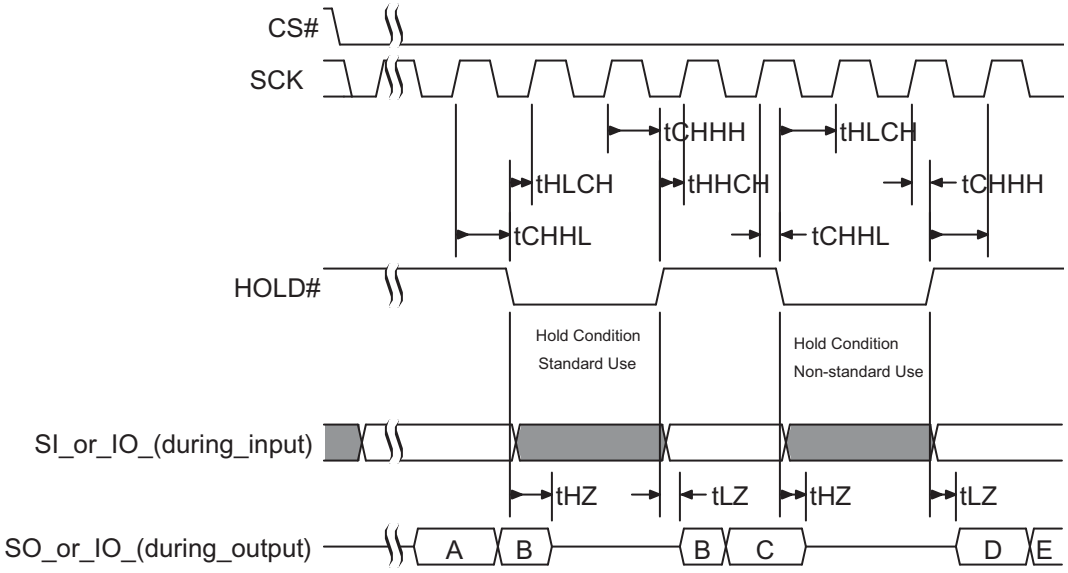
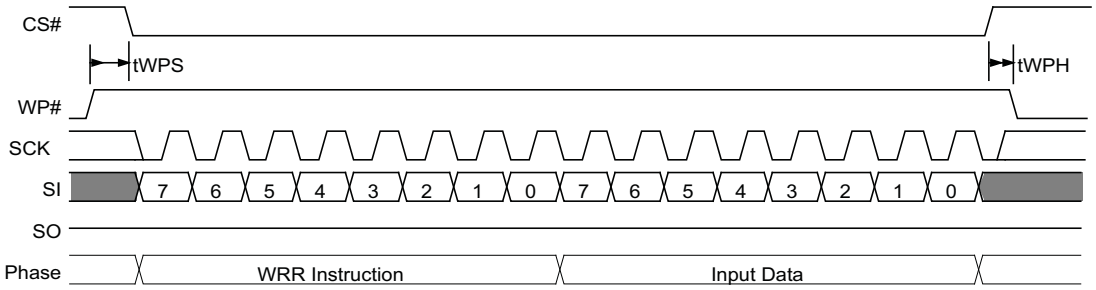


Figure 35. WP# Input Timing



5.5 DDR AC Characteristics

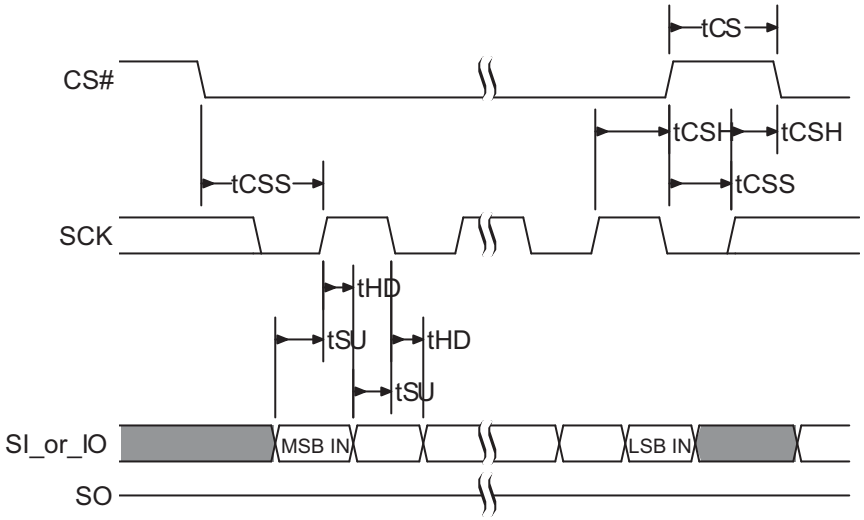
Table 13. AC Characteristics DDR Operation

Symbol	Parameter	66 MHz			80 MHz			Unit
		Min	Typ	Max	Min	Typ	Max	
$F_{SCK, R}$	SCK Clock Frequency for DDR READ instruction	DC	–	66	DC	–	80	MHz
$P_{SCK, R}$	SCK Clock Period for DDR READ instruction	15	–	∞	12.5	–	∞	ns
t_{WH}, t_{CH}	Clock High Time	45% P_{SCK}	–	–	45% P_{SCK}	–	–	ns
t_{WL}, t_{CL}	Clock Low Time	45% P_{SCK}	–	–	45% P_{SCK}	–	–	ns
t_{CS}	CS# High Time (Read Instructions)	10	–	–	10	–	–	ns
t_{CSS}	CS# Active Setup Time (relative to SCK)	3	–	–	3	–	–	ns
t_{CSH}	CS# Active Hold Time (relative to SCK)	3	–	–	3	–	–	ns
t_{SU}	I/O in Setup Time	2	–	3000 [2]	1.5	–	3000 [2]	ns
t_{HD}	I/O in Hold Time	2	–		1.5	–		ns
t_V	Clock Low to Output Valid		–	6.5 [1]		–	6.5 [1]	ns
t_{HO}	Output Hold Time	1.5	–		1.5	–		ns
t_{DIS}	Output Disable Time		–	8		–	8	ns
t_{LZ}	Clock to Output Low Impedance	0	–	8	0	–	8	ns
t_{IO_SKEW}	First Output to last Output data valid time	–	–	600	–	–	600	ps

Notes
1. Regulated V_{CC} range (3.0 - 3.6V) and CL =15 pF.
2. Maximum value only applies during Program/Erase Suspend/Resume commands.

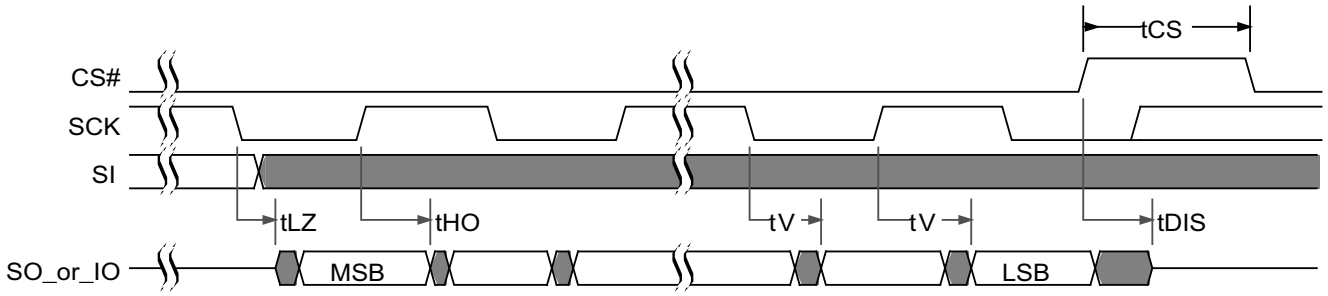
5.5.1 DDR Input Timing

Figure 36. SPI DDR Input Timing



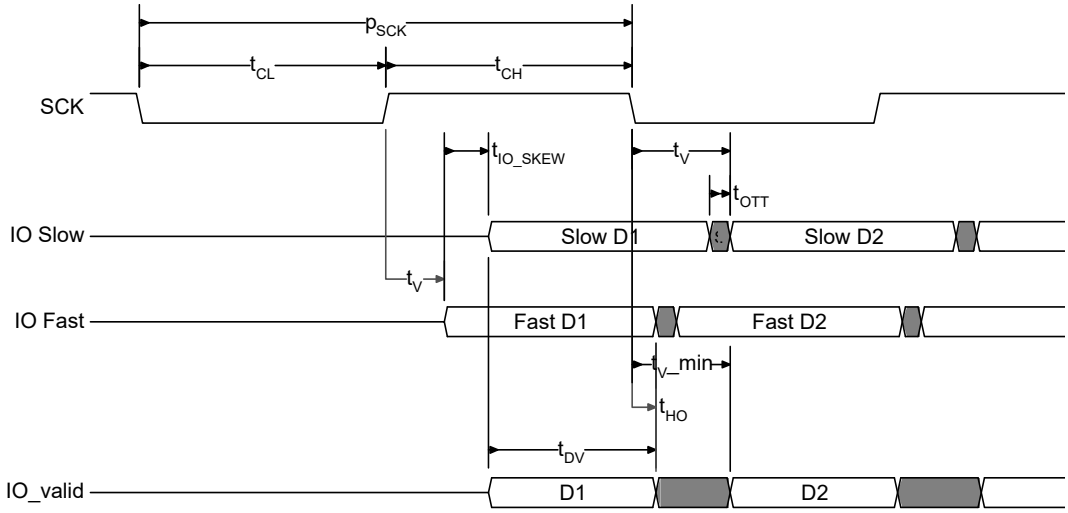
5.5.2 DDR Output Timing

Figure 37. SPI DDR Output Timing



5.5.3 DDR Data Valid Timing Using DLP

Figure 38. SPI DDR Data Valid Window



The minimum data valid window (t_{DV}) and t_V minimum can be calculated as follows:

t_{DV} = Minimum half clock cycle time (t_{CLH}) [1]- t_{OTT}[3] - t_{IO_SKEW}[2]

t_V _min = t_{HO} + t_{IO_SKEW} + t_{OTT}

Example:

80 MHz clock frequency = 12.5 ns clock period, DDR operations and duty cycle of 45% or higher

t_{CLH} = 0.45 x PSCK = 0.45 x 12.5 ns = 5.625 ns

Bus impedance of 45 ohm and capacitance of 22 pf, with timing reference of 0.75V_{CC}, the rise time from 0 to 1 or fall time 1 to 0 is 1.4[6] x RC time constant (Tau)[5] = 1.4 x 0.99 ns = 1.39 ns

t_{OTT} = rise time or fall time = 1.39 ns.

Data Valid Window

t_{DV} = t_{CLH} - t_{IO_SKEW} - t_{OTT} = 5.625 ns - 600 ps - 1.39 ns = 3.635 ns

t_V Minimum

t_V _min = t_{HO} + t_{IO_SKEW} + t_{OTT} = 1.0 ns + 600 ps + 1.39 ns = 2.99 ns

Notes

1. t_{CLH} is the shorter duration of t_{CL} or t_{CH}.
2. t_{IO_SKEW} is the maximum difference (delta) between the minimum and maximum t_V (output valid) across all IO signals.
3. t_{OTT} is the maximum Output Transition Time from one valid data value to the next valid data value on each IO. t_{OTT} is dependent on system level considerations including:
   a. Memory device output impedance (drive strength).
   b. System level parasitics on the IOs (primarily bus capacitance).
   c. Host memory controller input V_{IH} and V_{IL} levels at which 0 to 1 and 1 to 0 transitions are recognized.
   d. t_{OTT} is not a specification tested by Cypress, it is system dependent and must be derived by the system designer based on the above considerations.
4. t_{DV} is the data valid window.
5. Tau = R (Output Impedance) x C (Load capacitance)
6. Multiplier of Tau time for voltage to rise to 75% of V_{CC}

6. Physical Interface

Table 14. Model Specific Connections

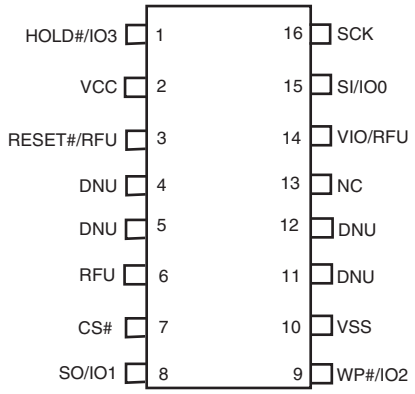
VIO / RFU	Versatile I/O or RFU — Some device models bond this connector to the device I/O power supply, other models bond the device I/O supply to Vcc within the package leaving this package connector unconnected.
RESET# / RFU	RESET# or RFU — Some device models bond this connector to the device RESET# signal, other models bond the RESET# signal to Vcc within the package leaving this package connector unconnected.

Note
1. Refer to Table 2 on page 8 for signal descriptions.

6.1 SOIC 16-Lead Package

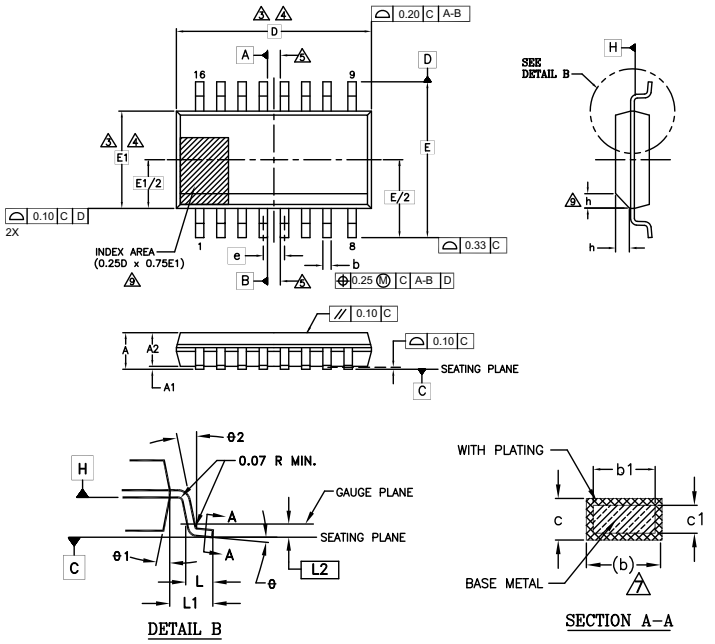
6.1.1 SOIC 16 Connection Diagram

Figure 39. 16-Lead SOIC Package, Top View



6.1.2 SOIC 16 Physical Diagram

Figure 40. SOIC 16-Lead, 300-mil Body Width (SO3016)



SYMBOL	DIMENSIONS		
	MIN.	NOM.	MAX.
A	2.35	-	2.65
A1	0.10	-	0.30
A2	2.05	-	2.55
b	0.31	-	0.51
b1	0.27	-	0.48
c	0.20	-	0.33
c1	0.20	-	0.30
D	10.30 BSC		
E	10.30 BSC		
E1	7.50 BSC		
e	1.27 BSC		
L	0.40	-	1.27
L1	1.40 REF		
L2	0.25 BSC		
N	16		
h	0.25	-	0.75
θ	0°	-	8°
θ1	5°	-	15°
θ2	0°	-	-

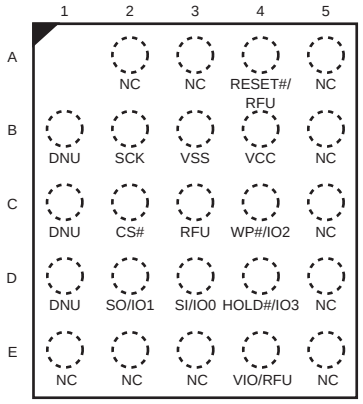
NOTES:

1. ALL DIMENSIONS ARE IN MILLIMETERS.
2. DIMENSIONING AND TOLERANCING PER ASME Y14.5M - 1994.
3. DIMENSION D DOES NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS. MOLD FLASH, PROTRUSIONS OR GATE BURRS SHALL NOT EXCEED 0.15 mm PER END. DIMENSION E1 DOES NOT INCLUDE INTERLEAD FLASH OR PROTRUSION. INTERLEAD FLASH OR PROTRUSION SHALL NOT EXCEED 0.25 mm PER SIDE. D AND E1 DIMENSIONS ARE DETERMINED AT DATUM H.
4. THE PACKAGE TOP MAY BE SMALLER THAN THE PACKAGE BOTTOM. DIMENSIONS D AND E1 ARE DETERMINED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY EXCLUSIVE OF MOLD FLASH, TIE BAR BURRS, GATE BURRS AND INTERLEAD FLASH, BUT INCLUSIVE OF ANY MISMATCH BETWEEN THE TOP AND BOTTOM OF THE PLASTIC BODY.
5. DATUMS A AND B TO BE DETERMINED AT DATUM H.
6. "N" IS THE MAXIMUM NUMBER OF TERMINAL POSITIONS FOR THE SPECIFIED PACKAGE LENGTH.
7. THE DIMENSIONS APPLY TO THE FLAT SECTION OF THE LEAD BETWEEN 0.10 TO 0.25 mm FROM THE LEAD TIP.
8. DIMENSION "b" DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.10 mm TOTAL IN EXCESS OF THE "b" DIMENSION AT MAXIMUM MATERIAL CONDITION. THE DAMBAR CANNOT BE LOCATED ON THE LOWER RADIUS OF THE LEAD FOOT.
9. THIS CHAMFER FEATURE IS OPTIONAL. IF IT IS NOT PRESENT, THEN A PIN 1 IDENTIFIER MUST BE LOCATED WITHIN THE INDEX AREA INDICATED.
10. LEAD COPLANARITY SHALL BE WITHIN 0.10 mm AS MEASURED FROM THE SEATING PLANE.

6.2 FAB024 24-Ball BGA Package

6.2.1 Connection Diagram

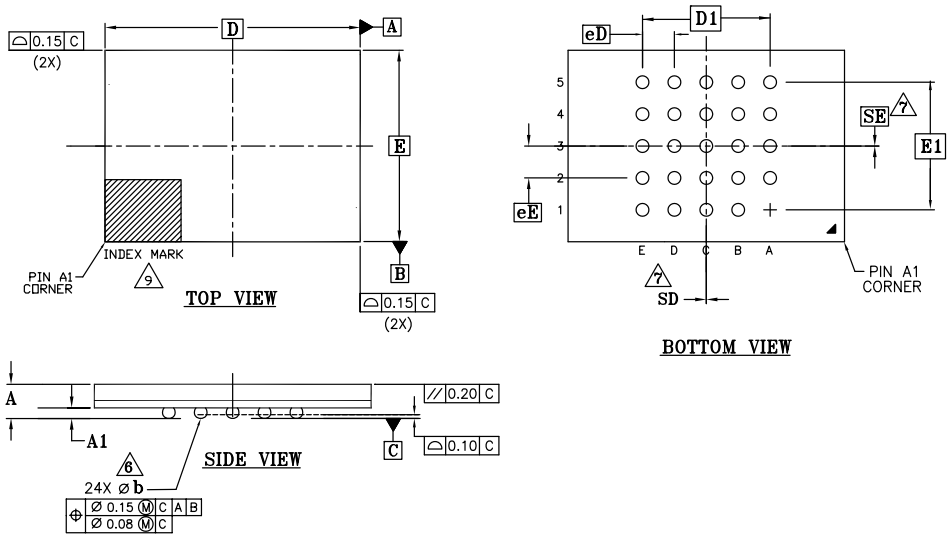
Figure 41. 24-Ball BGA, 5 x 5 Ball Footprint (FAB024), Top View



Note
1. Signal connections are in the same relative positions as FAC024 BGA, allowing a single PCB footprint to use either package.

6.2.2 FAB024 Physical Diagram

Figure 42. Ball Grid Array 24-Ball 6x8 mm (FAB024)



SYMBOL	DIMENSIONS		
	MIN.	NOM.	MAX.
A	-	-	1.20
A1	0.20	-	-
D		8.00 BSC	
E		6.00 BSC	
D1		4.00 BSC	
E1		4.00 BSC	
MD		5	
ME		5	
N		24	
⌀ b	0.35	0.40	0.45
eE		1.00 BSC	
eD		1.00 BSC	
SD		0.00 BSC	
SE		0.00 BSC	

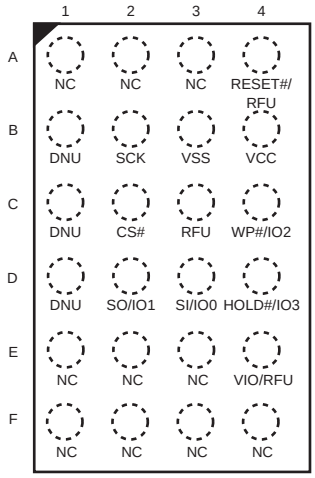
NOTES:

1. DIMENSIONING AND TOLERANCING METHODS PER ASME Y14.5M-1994.
2. ALL DIMENSIONS ARE IN MILLIMETERS.
3. BALL POSITION DESIGNATION PER JEP95, SECTION 3, SPP-020.
4. e REPRESENTS THE SOLDER BALL GRID PITCH.
5. SYMBOL "MD" IS THE BALL MATRIX SIZE IN THE "D" DIRECTION.
   SYMBOL "ME" IS THE BALL MATRIX SIZE IN THE "E" DIRECTION.
   N IS THE NUMBER OF POPULATED SOLDER BALL POSITIONS FOR MATRIX SIZE MD X ME.
6. DIMENSION "b" IS MEASURED AT THE MAXIMUM BALL DIAMETER IN A PLANE PARALLEL TO DATUM C.
7. "SD" AND "SE" ARE MEASURED WITH RESPECT TO DATUMS A AND B AND DEFINE THE POSITION OF THE CENTER SOLDER BALL IN THE OUTER ROW.
   WHEN THERE IS AN ODD NUMBER OF SOLDER BALLS IN THE OUTER ROW, "SD" OR "SE" = 0.
   WHEN THERE IS AN EVEN NUMBER OF SOLDER BALLS IN THE OUTER ROW, "SD" = eD/2 AND "SE" = eE/2.
8. "+" INDICATES THE THEORETICAL CENTER OF DEPOPULATED BALLS.
9. A1 CORNER TO BE IDENTIFIED BY CHAMFER, LASER OR INK MARK, METALLIZED MARK INDENTATION OR OTHER MEANS.

6.3 FAC024 24-Ball BGA Package

6.3.1 Connection Diagram

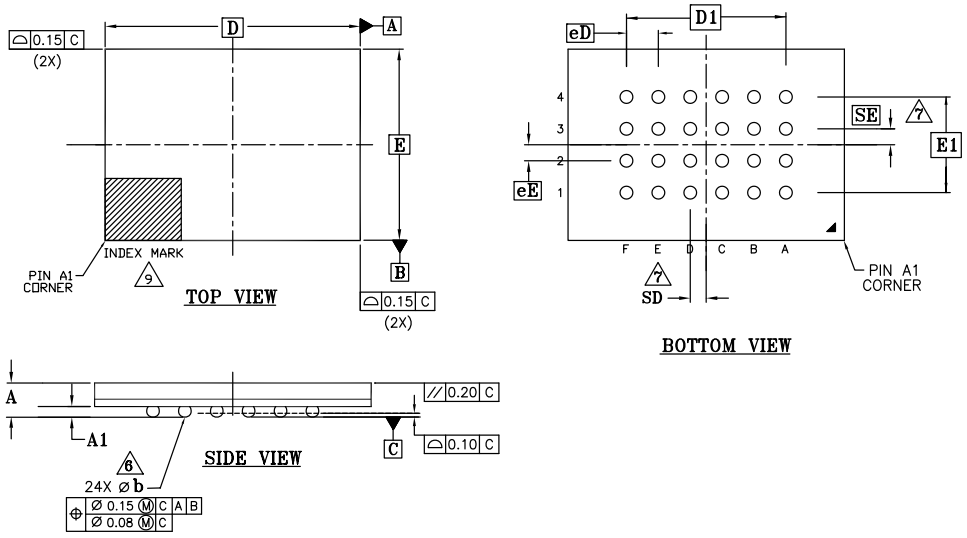
Figure 43. 24-Ball BGA, 4 x 6 Ball Footprint (FAC024), Top View



Note
1. Signal connections are in the same relative positions as FAB024 BGA, allowing a single PCB footprint to use either package.

6.3.2 FAC024 Physical Diagram

Figure 44. Ball Grid Array 24-Ball 6x8 mm (FAC024)



SYMBOL	DIMENSIONS		
	MIN.	NOM.	MAX.
A	-	-	1.20
A1	0.25	-	-
D	8.00 BSC		
E	6.00 BSC		
D1	5.00 BSC		
E1	3.00 BSC		
MD	6		
ME	4		
N	24		
Ø b	0.35	0.40	0.45
eE	1.00 BSC		
eD	1.00 BSC		
SD	0.50 BSC		
SE	0.50 BSC		

NOTES:

1. DIMENSIONING AND TOLERANCING METHODS PER ASME Y14.5M-1994.
2. ALL DIMENSIONS ARE IN MILLIMETERS.
3. BALL POSITION DESIGNATION PER JEP95, SECTION 3, SPP-020.
4. e REPRESENTS THE SOLDER BALL GRID PITCH.
5. SYMBOL "MD" IS THE BALL MATRIX SIZE IN THE "D" DIRECTION.
   SYMBOL "ME" IS THE BALL MATRIX SIZE IN THE "E" DIRECTION.
   N IS THE NUMBER OF POPULATED SOLDER BALL POSITIONS FOR MATRIX SIZE MD X ME.

6 DIMENSION "b" IS MEASURED AT THE MAXIMUM BALL DIAMETER IN A PLANE PARALLEL TO DATUM C.

7 "SD" AND "SE" ARE MEASURED WITH RESPECT TO DATUMS A AND B AND DEFINE THE POSITION OF THE CENTER SOLDER BALL IN THE OUTER ROW.
   WHEN THERE IS AN ODD NUMBER OF SOLDER BALLS IN THE OUTER ROW, "SD" OR "SE" = 0.
   WHEN THERE IS AN EVEN NUMBER OF SOLDER BALLS IN THE OUTER ROW, "SD" = eD/2 AND "SE" = eE/2.

8. "+" INDICATES THE THEORETICAL CENTER OF DEPOPULATED BALLS.

9. A1 CORNER TO BE IDENTIFIED BY CHAMFER, LASER OR INK MARK, METALLIZED MARK INDENTATION OR OTHER MEANS.

6.3.3 Special Handling Instructions for FBGA Packages

Flash memory devices in BGA packages may be damaged if exposed to ultrasonic cleaning methods. The package and/or data integrity may be compromised if the package body is exposed to temperatures above 150°C for prolonged periods of time.

Software Interface

This section discusses the features and behaviors most relevant to host system software that interacts with the S25FL512S memory device.

7. Address Space Maps

7.1 Overview

7.1.1 Extended Address

The S25FL512S device supports 32-bit addresses to enable higher density devices than allowed by previous generation (legacy) SPI devices that supported only 24-bit addresses. A 24-bit byte resolution address can access only 16 Mbytes (128 Mbits) of maximum density. A 32-bit byte resolution address allows direct addressing of up to a 4 Gbytes (32 Gbits) of address space.

Legacy commands continue to support 24-bit addresses for backward software compatibility. Extended 32-bit addresses are enabled in three ways:

- Bank address register — a software (command) loadable internal register that supplies the high order bits of address when legacy 24-bit addresses are in use.
- Extended address mode — a bank address register bit that changes all legacy commands to expect 32 bits of address supplied from the host system.
- New commands — that perform both legacy and new functions, which expect 32-bit address.

The default condition at power-up and after reset, is the Bank address register loaded with zeros and the extended address mode set for 24-bit addresses. This enables legacy software compatible access to the first 128 Mbits of a device.

7.1.2 Multiple Address Spaces

Many commands operate on the main flash memory array. Some commands operate on address spaces separate from the main flash array. Each separate address space uses the full 32-bit address but may only define a small portion of the available address space.

7.2 Flash Memory Array

The main flash array is divided into erase units called sectors. The sectors are organized as uniform 256-kbyte sectors.

Table 15. S25FL512S Sector and Memory Address Map, Uniform 256-kbyte Sectors

Sector Size (kbyte)	Sector Count	Sector Range	Address Range (8-bit)	Notes
256	256	SA00	00000000h-0003FFFFh	Sector Starting Address — Sector Ending Address
		:	:	
		SA255	03FC0000h-03FFFFFFh	

Note This is a condensed table that uses a sector as a reference. There are address ranges that are not explicitly listed. All 256-kB sectors have the pattern XXXX0000h-XXXXFFFFh.

7.3 ID-CFI Address Space

The RDIDJ command (9Fh) reads information from a separate flash memory address space for device identification (ID) and Common Flash Interface (CFI) information. See Device ID and Common Flash Interface (ID-CFI) Address Map on page 118 for the tables defining the contents of the ID-CFI address space. The ID-CFI address space is programmed by Cypress and read-only for the host system.

7.4 JEDEC JESD216 Serial Flash Discoverable Parameters (SFDP) Space.

The RSFDP command (5Ah) reads information from a separate Flash memory address space for device identification, feature, and configuration information, in accord with the JEDEC JESD216B standard for Serial Flash Discoverable Parameters. The ID-CFI address space is incorporated as one of the SFDP parameters.

See Serial Flash Discoverable Parameters (SFDP) Address Map on page 114 for the table defining the contents of the SFDP address space. The SFDP address space is programmed by Cypress and is read-only for the host system

7.5 OTP Address Space

Each S25FL512S memory device has a 1024-byte One Time Program (OTP) address space that is separate from the main flash array. The OTP area is divided into 32, individually lockable, 32-byte aligned and length regions.

In the 32-byte region starting at address zero:

- The 16 lowest address bytes are programmed by Cypress with a 128-bit random number. Only Cypress is able to program these bytes.
- The next 4 higher address bytes (OTP Lock Bytes) are used to provide one bit per OTP region to permanently protect each region from programming. The bytes are erased when shipped from Cypress. After an OTP region is programmed, it can be locked to prevent further programming, by programming the related protection bit in the OTP Lock Bytes.
- The next higher 12 bytes of the lowest address region are Reserved for Future Use (RFU). The bits in these RFU bytes may be programmed by the host system but it must be understood that a future device may use those bits for protection of a larger OTP space. The bytes are erased when shipped from Cypress.

The remaining regions are erased when shipped from Cypress, and are available for programming of additional permanent data.

Refer to Figure 45 on page 46 for a pictorial representation of the OTP memory space.

The OTP memory space is intended for increased system security. OTP values, such as the random number programmed by Cypress, can be used to “mate” a flash component with the system CPU/ASIC to prevent device substitution.

The configuration register FREEZE (CR1[0]) bit protects the entire OTP memory space from programming when set to 1. This allows trusted boot code to control programming of OTP regions then set the FREEZE bit to prevent further OTP memory space programming during the remainder of normal power-on system operation.

Figure 45. OTP Address Space

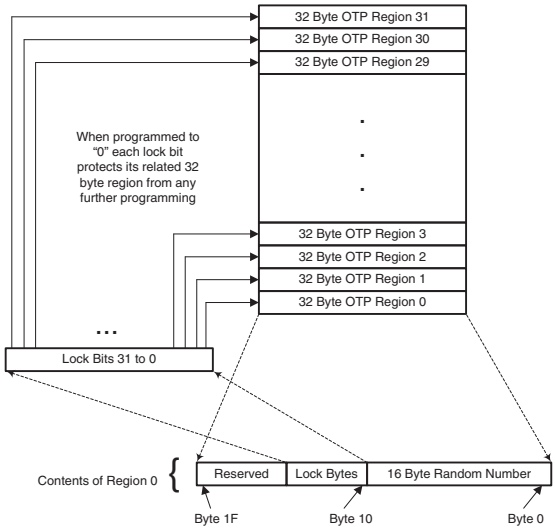


Table 16. OTP Address Map

Region	Byte Address Range (Hex)	Contents	Initial Delivery State (Hex)
Region 0	000	Least Significant Byte of Spansion Programmed Random Number	Spansion Programmed Random Number
	...	...	
	00F	Most Significant Byte of Spansion Programmed Random Number	
	010 to 013	Region Locking Bits Byte 10 [bit 0] locks region 0 from programming when = 0 ... Byte 13 [bit 7] locks region 31 from programming when = 0	All bytes = FF
	014 to 01F	Reserved for Future Use (RFU)	All bytes = FF
Region 1	020 to 03F	Available for User Programming	All bytes = FF
Region 2	040 to 05F	Available for User Programming	All bytes = FF
...	...	Available for User Programming	All bytes = FF
Region 31	3E0 to 3FF	Available for User Programming	All bytes = FF

7.6 Registers

Registers are small groups of memory cells used to configure how the S25FL512-S memory device operates or to report the status of device operations. The registers are accessed by specific commands. The commands (and hexadecimal instruction codes) used for each register are noted in each register description. The individual register bits may be volatile, nonvolatile, or One Time Programmable (OTP). The type for each bit is noted in each register description. The default state shown for each bit refers to the state after power-on reset, hardware reset, or software reset if the bit is volatile. If the bit is nonvolatile or OTP, the default state is the value of the bit when the device is shipped from Cypress. Nonvolatile bits have the same cycling (erase and program) endurance as the main flash array.

Table 17. Register Descriptions

Register	Abbreviation	Type	Bit Location
Status Register 1	SR1[7:0]	Volatile	7:0
Configuration Register 1	CR1[7:0]	Volatile	7:0
Status Register 2	SR2[7:0]	RFU	7:0
AutoBoot Register	ABRD[31:0]	Nonvolatile	31:0
Bank Address Register	BRAC[7:0]	Volatile	7:0
ECC Status Register	ECCSR[7:0]	Volatile	7:0
ASP Register	ASPR[15:1]	OTP	15:1
ASP Register	ASPR[0]	RFU	0
Password Register	PASS[63:0]	Nonvolatile OTP	63:0
PPB Lock Register	PPBL[7:1]	Volatile	7:1
PPB Lock Register	PPBL[0]	Volatile Read Only	0
PPB Access Register	PPBAR[7:0]	Nonvolatile	7:0
DYB Access Register	DYBAR[7:0]	Volatile	7:0
SPI DDR Data Learning Registers	NVDLR[7:0]	Nonvolatile	7:0
SPI DDR Data Learning Registers	VDLR[7:0]	Volatile	7:0

7.6.1 Status Register 1 (SR1)

Related Commands: Read Status Register (RDSR1 05h), Write Registers (WRR 01h), Write Enable (WREN 06h), Write Disable (WRDI 04h), Clear Status Register (CLSR 30h).

Table 18. Status Register-1 (SR1)

Bits	Field Name	Function	Type	Default State	Description
7	SRWD	Status Register Write Disable	Nonvolatile	0	1 = Locks state of SRWD, BP, and configuration register bits when WP# is low by ignoring WRR command 0 = No protection, even when WP# is low
6	P_ERR	Programming Error Occurred	Volatile, Read only	0	1 = Error occurred. 0 = No Error
5	E_ERR	Erase Error Occurred	Volatile, Read only	0	1 = Error occurred 0 = No Error
4	BP2	Block Protection	Volatile if CR1[3]=1, Nonvolatile if CR1[3]=0	1 if CR1[3]=1, 0 when shipped from Cypress	Protects selected range of sectors (Block) from Program or Erase
3	BP1				
2	BP0				
1	WEL	Write Enable Latch	Volatile	0	1 = Device accepts Write Registers (WRR), program or erase commands 0 = Device ignores Write Registers (WRR), program or erase commands This bit is not affected by WRR, only WREN and WRDI commands affect this bit
0	WIP	Write in Progress	Volatile, Read only	0	1 = Device Busy, a Write Registers (WRR), program, erase or other operation is in progress 0 = Ready Device is in standby mode and can accept commands

The Status Register contains both status and control bits:

Status Register Write Disable (SRWD) SR1[7]: Places the device in the Hardware Protected mode when this bit is set to 1 and the WP# input is driven low. In this mode, the SRWD, BP2, BP1, and BP0 bits of the Status Register become read-only bits and the Write Registers (WRR) command is no longer accepted for execution. If WP# is high the SRWD bit and BP bits may be changed by the WRR command. If SRWD is 0, WP# has no effect and the SRWD bit and BP bits may be changed by the WRR command. The SRWD bit has the same nonvolatile endurance as the main flash array.

Program Error (P_ERR) SR1[6]: The Program Error Bit is used as a program operation success or failure indication. When the Program Error bit is set to a 1 it indicates that there was an error in the last program operation. This bit will also be set when the user attempts to program within a protected main memory sector or locked OTP region. When the Program Error bit is set to a 1 this bit can be reset to 0 with the Clear Status Register (CLSR) command. This is a read-only bit and is not affected by the WRR command.

Erase Error (E_ERR) SR1[5]: The Erase Error Bit is used as an Erase operation success or failure indication. When the Erase Error bit is set to a 1 it indicates that there was an error in the last erase operation. This bit will also be set when the user attempts to erase an individual protected main memory sector. The Bulk Erase command will not set E_ERR if a protected sector is found during the command execution. When the Erase Error bit is set to a 1 this bit can be reset to 0 with the Clear Status Register (CLSR) command. This is a read-only bit and is not affected by the WRR command.

Block Protection (BP2, BP1, BP0) SR1[4:2]: These bits define the main flash array area to be software-protected against program and erase commands. The BP bits are either volatile or nonvolatile, depending on the state of the BP nonvolatile bit (BPNV) in the configuration register. When one or more of the BP bits is set to 1, the relevant memory area is protected against program and erase. The Bulk Erase (BE) command can be executed only when the BP bits are cleared to 0's. See Block Protection on page 59 for a description of how the BP bit values select the memory array area protected. The BP bits have the same nonvolatile endurance as the main flash array.

Write Enable Latch (WEL) SR1[1]: The WEL bit must be set to 1 to enable program, write, or erase operations as a means to provide protection against inadvertent changes to memory or register values. The Write Enable (WREN) command execution sets the Write Enable Latch to a 1 to allow any program, erase, or write commands to execute afterwards. The Write Disable (WRDI) command can be used to set the Write Enable Latch to a 0 to prevent all program, erase, and write commands from execution. The WEL bit is cleared to 0 at the end of any successful program, write, or erase operation. Following a failed operation the WEL bit may remain set and should be cleared with a WRDI command following a CLSR command. After a power down/power up sequence, hardware reset, or software reset, the Write Enable Latch is set to a 0 The WRR command does not affect this bit.

Write In Progress (WIP) SR1[0]: Indicates whether the device is performing a program, write, erase operation, or any other operation, during which a new operation command will be ignored. When the bit is set to a 1 the device is busy performing an operation. While WIP is 1, only Read Status (RDSR1 or RDSR2), Erase Suspend (ERSP), Program Suspend (PGSP), Clear Status Register (CLSR), and Software Reset (RESET) commands may be accepted. ERSP and PGSP will only be accepted if memory array erase or program operations are in progress. The status register E_ERR and P_ERR bits are updated while WIP = 1. When P_ERR or E_ERR bits are set to one, the WIP bit will remain set to one indicating the device remains busy and unable to receive new operation commands. A Clear Status Register (CLSR) command must be received to return the device to standby mode. When the WIP bit is cleared to 0 no operation is in progress. This is a read-only bit.

7.6.2 Configuration Register 1 (CR1)

Related Commands: Read Configuration Register (RDCR 35h), Write Registers (WRR 01h). The Configuration Register bits can be changed using the WRR command with sixteen input cycles.

The configuration register controls certain interface and data protection functions.

Table 19. Configuration Register (CR1)

Bits	Field Name	Function	Type	Default State	Description
7	LC1	Latency Code	Nonvolatile	0	Selects number of initial read latency cycles See Latency Code Tables
6	LC0			0	
5	TBPROT	Configures Start of Block Protection	OTP	0	1 = BP starts at bottom (Low address) 0 = BP starts at top (High address)
4	DNU	DNU	DNU	0	Do not Use
3	BPNV	Configures BP2-0 in Status Register	OTP	0	1 = Volatile 0 = Nonvolatile
2	RFU	RFU	RFU	0	Reserved for Future Use
1	QUAD	Puts the device into Quad I/O operation	Nonvolatile	0	1 = Quad 0 = Dual or Serial
0	FREEZE	Lock current state of BP2-0 bits in Status Register, TBPROT in Configuration Register, and OTP regions	Volatile	0	1 = Block Protection and OTP locked 0 = Block Protection and OTP un-locked

Latency Code (LC) CR1[7:6]: The Latency Code selects the number of mode and dummy cycles between the end of address and the start of read data output for all read commands.

Some read commands send mode bits following the address to indicate that the next command will be of the same type with an implied, rather than an explicit, instruction. The next command thus does not provide an instruction byte, only a new address and mode bits. This reduces the time needed to send each command when the same command type is repeated in a sequence of commands.

Dummy cycles provide additional latency that is needed to complete the initial read access of the flash array before data can be returned to the host system. Some read commands require additional latency cycles as the SCK frequency is increased.

The following latency code tables provide different latency settings that are configured by Cypress. The High Performance versus the Enhanced High Performance settings are selected by the ordering part number.

Where mode or latency (dummy) cycles are shown in the tables as a dash, that read command is not supported at the frequency shown. Read is supported only up to 50 MHz but the same latency value is assigned in each latency code and the command may be used when the device is operated at ≤ 50 MHz with any latency code setting. Similarly, only the Fast Read command is supported up to 133 MHz but the same 10b latency code is used for Fast Read up to 133 MHz and for the other dual and quad read commands up to 104 MHz. It is not necessary to change the latency code from a higher to a lower frequency when operating at lower frequencies where a particular command is supported. The latency code values for a higher frequency can be used for accesses at lower frequencies.

The High Performance settings provide latency options that are the same or faster than alternate source SPI memories. These settings provide mode bits only for the Quad I/O Read command.

The Enhanced High Performance settings similarly provide latency options the same or faster than additional alternate source SPI memories and adds mode bits for the Dual I/O Read, DDR Fast Read, and DDR
Dual I/O Read commands.

Read DDR Data Learning Pattern (DLP) bits may be placed within the dummy cycles immediately before the start of read data, if there are 5 or more dummy cycles. See Read Memory Array Commands on page 82 for more information on the DLP.

Table 20. Latency Codes for SDR High Performance

Freq. (MHz)	LC	Read (03h, 13h)		Fast Read (0Bh, 0Ch)		Read Dual Out (3Bh, 3Ch)		Read Quad Out (6Bh, 6Ch)		Dual I/O Read (BBh, BCh)		Quad I/O Read (EBh, ECh)	
		Mode	Dummy	Mode	Dummy	Mode	Dummy	Mode	Dummy	Mode	Dummy	Mode	Dummy
≤ 50	11	0	0	0	0	0	0	0	0	0	4	2	1
≤ 80	00	–	–	0	8	0	8	0	8	0	4	2	4
≤ 90	01	–	–	0	8	0	8	0	8	0	5	2	4
≤104	10	–	–	0	8	0	8	0	8	0	6	2	5
≤133	10	–	–	0	8	–	–	–	–	–	–	–	–

Table 21. Latency Codes for DDR High Performance

Freq. (MHz)	LC	DDR Fast Read (0Dh, 0Eh)		DDR Dual I/O Read (BDh, BEh)		Read DDR Quad I/O (EDh, EEh)	
		Mode	Dummy	Mode	Dummy	Mode	Dummy
≤ 50	11	0	4	0	4	1	3
≤ 66	00	0	5	0	6	1	6
≤ 66	01	0	6	0	7	1	7
≤ 66	10	0	7	0	8	1	8

Table 22. Latency Codes for SDR Enhanced High Performance

Freq. (MHz)	LC	Read (03h, 13h)		Fast Read (0Bh, 0Ch)		Read Dual Out (3Bh, 3Ch)		Read Quad Out (6Bh, 6Ch)		Dual I/O Read (BBh, BCh)		Quad I/O Read (EBh, ECh)	
		Mode	Dummy	Mode	Dummy	Mode	Dummy	Mode	Dummy	Mode	Dummy	Mode	Dummy
≤ 50	11	0	0	0	0	0	0	0	0	4	0	2	1
≤ 80	00	–	–	0	8	0	8	0	8	4	0	2	4
≤ 90	01	–	–	0	8	0	8	0	8	4	1	2	4
≤104	10	–	–	0	8	0	8	0	8	4	2	2	5
≤133	10	–	–	0	8	–	–	–	–	–	–	–	–

Table 23. Latency Codes for DDR Enhanced High Performance

Freq. (MHz)	LC	DDR Fast Read (0Dh, 0Eh)		DDR Dual I/O Read (BDh, BEh)		Read DDR Quad I/O (EDh, EEh)	
		Mode	Dummy	Mode	Dummy	Mode	Dummy
≤ 50	11	4	1	2	2	1	3
≤ 66	00	4	2	2	4	1	6
≤ 66	01	4	4	2	5	1	7
≤ 66	10	4	5	2	6	1	8
≤ 80	00	4	2	2	4	1	6
≤ 80	01	4	4	2	5	1	7
≤ 80	10	4	5	2	6	1	8

Note

1. When using DDR I/O commands with the Data Learning Pattern (DLP) enabled, a Latency Code that provides 5 or more dummy cycles should be selected to allow 1 cycle of additional time for the host to stop driving before the memory starts driving the 4 cycle DLP. It is recommended to use LC 10 for DDR Fast Read, LC 01 for DDR Dual I/O Read, and LC 00 for DDR Quad I/O Read, if the Data Learning Pattern (DLP) for DDR is used.

Top or Bottom Protection (TBPROT) CR1[5]: This bit defines the operation of the Block Protection bits BP2, BP1, and BP0 in the Status Register. As described in the status register section, the BP2-0 bits allow the user to optionally protect a portion of the array, ranging from 1/64, 1/4, 1/2, etc., up to the entire array. When TBPROT is set to a 0 the Block Protection is defined to start from the top (maximum address) of the array. When TBPROT is set to a 1 the Block Protection is defined to start from the bottom (zero address) of the array. The TBPROT bit is OTP and set to a 0 when shipped from Cypress. If TBPROT is programmed to 1, an attempt to change it back to 0 will fail and set the Program Error bit (P_ERR in SR1[6]).

The desired state of TBPROT must be selected during the initial configuration of the device during system manufacture; before the first program or erase operation on the main flash array. TBPROT must not be programmed after programming or erasing is done in the main flash array.

CR1[4]: Reserved for Future Use

Block Protection Nonvolatile (BPNV) CR1[3]: The BPNV bit defines whether or not the BP2-0 bits in the Status Register are volatile or nonvolatile. The BPNV bit is OTP and cleared to a0 with the BP bits cleared to 000 when shipped from Cypress. When BPNV is set to a 0 the BP2-0 bits in the Status Register are nonvolatile. When BPNV is set to a 1 the BP2-0 bits in the Status Register are volatile and will be reset to binary 111 after POR, hardware reset, or command reset. If BPNV is programmed to 1, an attempt to change it back to 0 will fail and set the Program Error bit (P_ERR in SR1[6]).

CR1[2]: Reserved for Future Use.

Quad Data Width (QUAD) CR1[1]: When set to 1, this bit switches the data width of the device to 4 bit - Quad mode. That is, WP# becomes I/O2 and HOLD# becomes I/O3. The WP# and HOLD# inputs are not monitored for their normal functions and are internally set to high (inactive). The commands for Serial, Dual Output, and Dual I/O Read still function normally but, there is no need to drive WP# and Hold# inputs for those commands when switching between commands using different data path widths. The QUAD bit must be set to one when using Read Quad Out, Quad I/O Read, Read DDR Quad I/O, and Quad Page Program commands. The QUAD bit is nonvolatile.

Freeze Protection (FREEZE) CR1[0]: The Freeze Bit, when set to 1, locks the current state of the BP2-0 bits in Status Register, the TBPROT and TBPARM bits in the Configuration Register, and the OTP address space. This prevents writing, programming, or erasing these areas. As long as the FREEZE bit remains cleared to logic 0 the other bits of the Configuration Register, including FREEZE, are writable, and the OTP address space is programmable. Once the FREEZE bit has been written to a logic 1 it can only be cleared to a logic 0 by a power-off to power-on cycle or a hardware reset. Software reset will not affect the state of the FREEZE bit. The FREEZE bit is volatile and the default state of FREEZE after power-on is 0. The FREEZE bit can be set in parallel with updating other values in CR1 by a single WRR command.

7.6.3 Status Register 2 (SR2)

Related Commands: Read Status Register 2 (RDSR2 07h).

Table 24. Status Register-2 (SR2)

Bits	Field Name	Function	Type	Default State	Description
7	RFU	Reserved	–	0	Reserved for Future Use
6	RFU	Reserved	–	0	Reserved for Future Use
5	RFU	Reserved	–	0	Reserved for Future Use
4	RFU	Reserved	–	0	Reserved for Future Use
3	RFU	Reserved	–	0	Reserved for Future Use
2	RFU	Reserved	–	0	Reserved for Future Use
1	ES	Erase Suspend	Volatile, Read only	0	1 = In erase suspend mode 0 = Not in erase suspend mode
0	PS	Program Suspend	Volatile, Read only	0	1 = In program suspend mode 0 = Not in program suspend mode

Erase Suspend (ES) SR2[1]: The Erase Suspend bit is used to determine when the device is in Erase Suspend mode. This is a status bit that cannot be written. When Erase Suspend bit is set to 1, the device is in erase suspend mode. When Erase Suspend bit is cleared to 0, the device is not in erase suspend mode. Refer to Erase Suspend and Resume Commands (75h) (7Ah) for details about the Erase Suspend/Resume commands.

Program Suspend (PS) SR2[0]: The Program Suspend bit is used to determine when the device is in Program Suspend mode. This is a status bit that cannot be written. When Program Suspend bit is set to 1, the device is in program suspend mode. When the Program Suspend bit is cleared to 0, the device is not in program suspend mode. Refer to Program Suspend (PGSP 85h) and Resume (PGRS 8Ah) on page 98 for details.

7.6.4 AutoBoot Register

Related Commands: AutoBoot Read (ABRD 14h) and AutoBoot Write (ABWR 15h).

The AutoBoot Register provides a means to automatically read boot code as part of the power on reset, hardware reset, or software reset process.

Table 25. AutoBoot Register

Bits	Field Name	Function	Type	Default State	Description
31 to 9	ABSA	AutoBoot Start Address	Nonvolatile	000000h	512 byte boundary address for the start of boot code access
8 to 1	ABSD	AutoBoot Start Delay	Nonvolatile	00h	Number of initial delay cycles between CS# going low and the first bit of boot code being transferred
0	ABE	AutoBoot Enable	Nonvolatile	0	1 = AutoBoot is enabled 0 = AutoBoot is not enabled

7.6.5 Bank Address Register

Related Commands: Bank Register Access (BRAC B9h), Write Register (WRR 01h), Bank Register Read (BRRD 16h) and Bank Register Write (BRWR 17h).

The Bank Address register supplies additional high order bits of the main flash array byte boundary address for legacy commands that supply only the low order 24 bits of address. The Bank Address is used as the high bits of address (above A23) for all 3-byte address commands when EXTADD=0. The Bank Address is not used when EXTADD = 1 and traditional 3-byte address commands are instead required to provide all four bytes of address.

Table 26. Bank Address Register (BAR)

Bits	Field Name	Function	Type	Default State	Description
7	EXTADD	Extended Address Enable	Volatile	0b	1 = 4-byte (32-bits) addressing required from command. 0 = 3-byte (24-bits) addressing from command + Bank Address
6 to 2	RFU	Reserved	Volatile	00000b	Reserved for Future Use
1	BA25	Bank Address	Volatile	0	A25 for 512 Mb device
0	BA24	Bank Address	Volatile	0	A24 for 512 Mb device

Extended Address (EXTADD) BAR[7]: EXTADD controls the address field size for legacy SPI commands. By default (power up reset, hardware reset, and software reset), it is cleared to 0 for 3 bytes (24 bits) of address. When set to 1, the legacy commands will require 4 bytes (32 bits) for the address field. This is a volatile bit.

7.6.6 ECC Status Register (ECCSR)

Related Commands: ECC Read (ECCRD 18h). ECCSR does not have user programmable nonvolatile bits. All defined bits are volatile read only status. The default state of these bits are set by hardware. See Automatic ECC on page 96.

The status of ECC in each ECC unit is provided by the 8-bit ECC Status Register (ECCSR). The ECC Register Read command is written followed by an ECC unit address. The contents of the status register then indicates, for the selected ECC unit, whether there is an error in the ECC unit eight bit error correction code, the ECC unit of 16 Bytes of data, or that ECC is disabled for that ECC unit.

Table 27. ECC Status Register (ECCSR)

Bits	Field Name	Function	Type	Default State	Description
7 to 3	RFU	Reserved		0	Reserved for Future Use
2	EECC	Error in ECC	Volatile, Read only	0	1 = Single Bit Error found in the ECC unit eight bit error correction code 0 = No error.
1	EECCD	Error in ECC unit data	Volatile, Read only	0	1 = Single Bit Error corrected in ECC unit data. 0 = No error.
0	ECCDI	ECC Disabled	Volatile, Read only	0	1 = ECC is disabled in the selected ECC unit. 0 = ECC is enabled in the selected ECC unit.

ECCSR[2] = 1 indicates an error was corrected in the ECC. ECCSR[1] = 1 indicates an error was corrected in the ECC unit data. ECCSR[0] = 1 indicates the ECC is disabled. The default state of “0” for all these bits indicates no failures and ECC is enabled.

ECCSR[7:3] are reserved. These have undefined high or low values that can change from one ECC status read to another. These bits should be treated as “don’t care” and ignored by any software reading status.

7.6.7 ASP Register (ASPR)

Related Commands: ASP Read (ASPRD 2Bh) and ASP Program (ASPP 2Fh).

The ASP register is a 16-bit OTP memory location used to permanently configure the behavior of Advanced Sector Protection (ASP) features.

Table 28. ASP Register (ASPR)

Bits	Field Name	Function	Type	Default State	Description
15 to 9	RFU	Reserved	OTP	1	Reserved for Future Use
8	RFU	Reserved	OTP	(Note 1)	Reserved for Future Use
7	RFU	Reserved	OTP	(Note 1)	Reserved for Future Use
6	RFU	Reserved	OTP	1	Reserved for Future Use
5	RFU	Reserved	OTP	(Note 1)	Reserved for Future Use
4	RFU	Reserved	OTP	(Note 1)	Reserved for Future Use
3	RFU	Reserved	OTP	(Note 1)	Reserved for Future Use
2	PWDMLB	Password Protection Mode Lock Bit	OTP	1	0 = Password Protection Mode permanently enabled. 1 = Password Protection Mode not permanently enabled.
1	PSTMLB	Persistent Protection Mode Lock Bit	OTP	1	0 = Persistent Protection Mode permanently enabled. 1 = Persistent Protection Mode not permanently enabled.
0	RFU	Reserved	OTP	1	Reserved for Future Use

Note
1. Default value depends on ordering part number, see Initial Delivery State on page 140.

Reserved for Future Use (RFU) ASPR[15:3, 0].

Password Protection Mode Lock Bit (PWDMLB) ASPR[2]: When programmed to 0, the Password Protection Mode is permanently selected.

Persistent Protection Mode Lock Bit (PSTMLB) ASPR[1]: When programmed to 0, the Persistent Protection Mode is permanently selected. PWDMLB and PSTMLB are mutually exclusive, only one may be programmed to zero.

7.6.8 Password Register (PASS)

Related Commands: Password Read (PASSRD E7h) and Password Program (PASSP E8h).

Table 29. Password Register (PASS)

Bits	Field Name	Function	Type	Default State	Description
63 to 0	PWD	Hidden Password	OTP	FFFFFFFF-FFFFFFFFh	Nonvolatile OTP storage of 64-bit password. The password is no longer readable after the password protection mode is selected by programming ASP register bit 2 to zero.

7.6.9 PPB Lock Register (PPBL)

Related Commands: PPB Lock Read (PLBRD A7h, PLBWR A6h)

Table 30. PPB Lock Register (PPBL)

Bits	Field Name	Function	Type	Default State	Description
7 to 1	RFU	Reserved	Volatile	00h	Reserved for Future Use
0	PPBLOCK	Protect PPB Array	Volatile	Persistent Protection Mode = 1 Password Protection Mode = 0	0 = PPB array protected until next power cycle or hardware reset 1 = PPB array may be programmed or erased.

7.6.10 PPB Access Register (PPBAR)

Related Commands: PPB Read (PPBRD E2h)

Table 31. PPB Access Register (PPBAR)

Bits	Field Name	Function	Type	Default State	Description
7 to 0	PPB	Read or Program per sector PPB	Nonvolatile	FFh	00h = PPB for the sector addressed by the PPBRD or PPBP command is programmed to 0, protecting that sector from program or erase operations. FFh = PPB for the sector addressed by the PPBRD or PPBP command is erased to 1, not protecting that sector from program or erase operations.

7.6.11 DYB Access Register (DYBAR)

Related Commands: DYB Read (DYBRD E0h) and DYB Program (DYBP E1h).

Table 32. DYB Access Register (DYBAR)

Bits	Field Name	Function	Type	Default State	Description
7 to 0	DYB	Read or Write per sector DYB	Volatile	FFh	00h = DYB for the sector addressed by the DYBRD or DYBP command is cleared to 0, protecting that sector from program or erase operations. FFh = DYB for the sector addressed by the DYBRD or DYBP command is set to 1, not protecting that sector from program or erase operations.

7.6.12 SPI DDR Data Learning Registers

Related Commands: Program NVDLR (PNVDLR 43h), Write VDLR (WVDLR 4Ah), Data Learning Pattern Read (DLPRD 41h).

The Data Learning Pattern (DLP) resides in an 8-bit Nonvolatile Data Learning Register (NVDLR) as well as an 8-bit Volatile Data Learning Register (VDLR). When shipped from Cypress, the NVDLR value is 00h. Once programmed, the NVDLR cannot be reprogrammed or erased; a copy of the data pattern in the NVDLR will also be written to the VDLR. The VDLR can be written to at any time, but on reset or power cycles the data pattern will revert back to what is in the NVDLR. During the learning phase described in the SPI DDR modes, the DLP will come from the VDLR. Each I/O will output the same DLP value for every clock edge. For example, if the DLP is 34h (or binary 00110100) then during the first clock edge all I/O's will output 0; subsequently, the 2nd clock edge all I/O's will output 0, the 3rd will output 1, etc.

When the VDLR value is 00h, no preamble data pattern is presented during the dummy phase in the DDR commands.

Table 33. Nonvolatile Data Learning Register (NVDLR)

Bits	Field Name	Function	Type	Default State	Description
7 to 0	NVDLP	Nonvolatile Data Learning Pattern	OTP	00h	OTP value that may be transferred to the host during DDR read command latency (dummy) cycles to provide a training pattern to help the host more accurately center the data capture point in the received data bits.

Table 34. Volatile Data Learning Register (NVDLR)

Bits	Field Name	Function	Type	Default State	Description
7 to 0	VDLP	Volatile Data Learning Pattern	Volatile	Takes the value of NVDLR during POR or Reset	Volatile copy of the NVDLP used to enable and deliver the Data Learning Pattern (DLP) to the outputs. The VDLP may be changed by the host during system operation.

8. Data Protection

8.1 Secure Silicon Region (OTP)

The device has a 1024-byte One Time Program (OTP) address space that is separate from the main flash array. The OTP area is divided into 32, individually lockable, 32-byte aligned and length regions.

The OTP memory space is intended for increased system security. OTP values can “mate” a flash component with the system CPU/ASIC to prevent device substitution. See OTP Address Space on page 46, One Time Program Array Commands on page 103, and OTP Read (OTPR 4Bh) on page 103.

8.1.1 Reading OTP Memory Space

The OTP Read command uses the same protocol as Fast Read. OTP Read operations outside the valid 1-kB OTP address range will yield indeterminate data.

8.1.2 Programming OTP Memory Space

The protocol of the OTP programming command is the same as Page Program. The OTP Program command can be issued multiple times to any given OTP address, but this address space can never be erased.

Automatic ECC is programmed on the first programming operation to each 16-byte region. Programming within a 16-byte region more than once disables the ECC. It is recommended to program each 16-byte portion of each 32-byte region once so that ECC remains enabled to provide the best data integrity.

The valid address range for OTP Program is depicted in Figure 45 on page 46. OTP Program operations outside the valid OTP address range will be ignored and the WEL in SR1 will remain high (set to 1). OTP Program operations while FREEZE = 1 will fail with P_ERR in SR1 set to 1.

8.1.3 Cypress Programmed Random Number

Cypress standard practice is to program the low order 16 bytes of the OTP memory space (locations 0x0 to 0xF) with a 128-bit random number using the Linear Congruential Random Number Method. The seed value for the algorithm is a random number concatenated with the day and time of tester insertion.

8.1.4 Lock Bytes

The LSB of each Lock byte protects the lowest address region related to the byte, the MSB protects the highest address region related to the byte. The next higher address byte similarly protects the next higher 8 regions. The LSB bit of the lowest address Lock Byte protects the higher address 16 bytes of the lowest address region. In other words, the LSB of location 0x10 protects all the Lock Bytes and RFU bytes in the lowest address region from further programming. See OTP Address Space on page 46.

8.2 Write Enable Command

The Write Enable (WREN) command must be written prior to any command that modifies nonvolatile data. The WREN command sets the Write Enable Latch (WEL) bit. The WEL bit is cleared to 0 (disables writes) during power-up, hardware reset, or after the device completes the following commands:

- Reset
- Page Program (PP)
- Sector Erase (SE)
- Bulk Erase (BE)
- Write Disable (WRDI)
- Write Registers (WRR)
- Quad-input Page Programming (QPP)
- OTP Byte Programming (OTPP)

8.3 Block Protection

The Block Protect bits (Status Register bits BP2, BP1, BP0) in combination with the Configuration Register TBPROT bit can be used to protect an address range of the main flash array from program and erase operations. The size of the range is determined by the value of the BP bits and the upper or lower starting point of the range is selected by the TBPROT bit of the configuration register.

Table 35. Upper Array Start of Protection (TBPROT = 0)

Status Register Content			Protected Fraction of Memory Array	Protected Memory (kbytes) FL512S 512 Mb
BP2	BP1	BP0		
0	0	0	None	0
0	0	1	Upper 64th	1024
0	1	0	Upper 32nd	2048
0	1	1	Upper 16th	4096
1	0	0	Upper 8th	8192
1	0	1	Upper 4th	16384
1	1	0	Upper Half	32768
1	1	1	All Sectors	65536

Table 36. Lower Array Start of Protection (TBPROT = 1)

Status Register Content			Protected Fraction of Memory Array	Protected Memory (kbytes) FL512S 512 Mb
BP2	BP1	BP0		
0	0	0	None	0
0	0	1	Lower 64th	1024
0	1	0	Lower 32nd	2048
0	1	1	Lower 16th	4096
1	0	0	Lower 8th	8192
1	0	1	Lower 4th	16384
1	1	0	Lower Half	32768
1	1	1	All Sectors	65536

When Block Protection is enabled (i.e., any BP2-0 are set to 1), Advanced Sector Protection (ASP) can still be used to protect sectors not protected by the Block Protection scheme. In the case that both ASP and Block Protection are used on the same sector the logical OR of ASP and Block Protection related to the sector is used. Recommendation: ASP and Block Protection should not be used concurrently. Use one or the other, but not both.

8.3.1 Freeze Bit

Bit 0 of the Configuration Register is the FREEZE bit. The FREEZE bit locks the BP2-0 bits in Status Register 1 and the TBPROT bit in the Configuration Register to their value at the time the FREEZE bit is set to 1. Once the FREEZE bit has been written to a logic 1 it cannot be cleared to a logic 0 until a power-on-reset is executed. As long as the FREEZE bit is cleared to logic 0 the status register BP bits and the TBPROT bit of the Configuration Register are writable. The FREEZE bit also protects the entire OTP memory space from programming when set to 1. Any attempt to change the BP bits with the WRR command while FREEZE = 1 is ignored and no error status is set.

8.3.2 Write Protect Signal

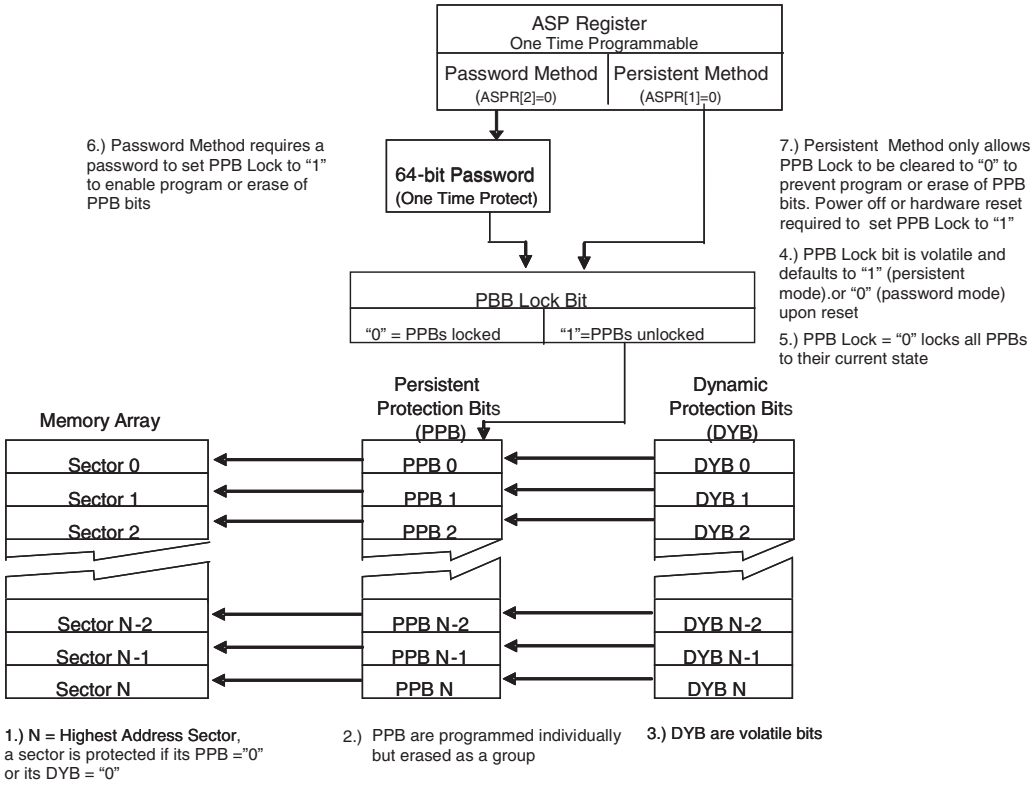
The Write Protect (WP#) input in combination with the Status Register Write Disable (SRWD) bit provide hardware input signal controlled protection. When WP# is Low and SRWD is set to 1 the Status and Configuration register is protected from alteration. This prevents disabling or changing the protection defined by the Block Protect bits.

8.4 Advanced Sector Protection

Advanced Sector Protection (ASP) is the name used for a set of independent hardware and software methods used to disable or enable programming or erase operations, individually, in any or all sectors. An overview of these methods is shown in Figure 46 on page 60.

Block Protection and ASP protection settings for each sector are logically OR'd to define the protection for each sector, i.e. if either mechanism is protecting a sector the sector cannot be programmed or erased. Refer to Block Protection on page 59 for full details of the BP2-0 bits.

Figure 46. Advanced Sector Protection Overview



Every main flash array sector has a nonvolatile (PPB) and a volatile (DYB) protection bit associated with it. When either bit is 0, the sector is protected from program and erase operations.

The PPB bits are protected from program and erase when the PPB Lock bit is 0. There are two methods for managing the state of the PPB Lock bit, Persistent Protection and Password Protection.

The Persistent Protection method sets the PPB Lock bit to 1 during POR, or Hardware Reset so that the PPB bits are unprotected by a device reset. There is a command to clear the PPB Lock bit to 0 to protect the PPB. There is no command in the Persistent Protection method to set the PPB Lock bit to 1, therefore the PPB Lock bit will remain at 0 until the next power-off or hardware reset. The Persistent Protection method allows boot code the option of changing sector protection by programming or erasing the PPB, then protecting the PPB from further change for the remainder of normal system operation by clearing the PPB Lock bit to 0. This is sometimes called Boot-code controlled sector protection.

The Password method clears the PPB Lock bit to 0 during POR, or Hardware Reset to protect the PPB. A 64-bit password may be permanently programmed and hidden for the password method. A command can be used to provide a password for comparison with the hidden password. If the password matches, the PPB Lock bit is set to 1 to unprotect the PPB. A command can be used to clear the PPB Lock bit to 0. This method requires use of a password to control PPB protection.

The selection of the PPB Lock bit management method is made by programming OTP bits in the ASP Register so as to permanently select the method used.

8.4.1 ASP Register

The ASP register is used to permanently configure the behavior of Advanced Sector Protection (ASP) features. See Table 28 on page 55.

As shipped from the factory, all devices default ASP to the Persistent Protection mode, with all sectors unprotected, when power is applied. The device programmer or host system must then choose which sector protection method to use. Programming either of the, one-time programmable, Protection Mode Lock Bits, locks the part permanently in the selected mode:

- ASPR[2:1] = 11 = No ASP mode selected, Persistent Protection Mode is the default.
- ASPR[2:1] = 10 = Persistent Protection Mode permanently selected.
- ASPR[2:1] = 01 = Password Protection Mode permanently selected.
- ASPR[2:1] = 00 = Illegal condition, attempting to program both bits to zero results in a programming failure.

ASP register programming rules:

- If the password mode is chosen, the password must be programmed prior to setting the Protection Mode Lock Bits.
- Once the Protection Mode is selected, the Protection Mode Lock Bits are permanently protected from programming and no further changes to the ASP register is allowed.

The programming time of the ASP Register is the same as the typical page programming time. The system can determine the status of the ASP register programming operation by reading the WIP bit in the Status Register. See Status Register 1 (SR1) on page 49 for information on WIP.

After selecting a sector protection method, each sector can operate in each of the following states:

- Dynamically Locked — A sector is protected and can be changed by a simple command.
- Persistently Locked — A sector is protected and cannot be changed if its PPB Bit is 0.
- Unlocked — The sector is unprotected and can be changed by a simple command.

8.4.2 Persistent Protection Bits

The Persistent Protection Bits (PPB) are located in a separate nonvolatile flash array. One of the PPB bits is related to each sector. When a PPB is 0, its related sector is protected from program and erase operations. The PPB are programmed individually but must be erased as a group, similar to the way individual words may be programmed in the main array but an entire sector must be erased at the same time. The PPB have the same program and erase endurance as the main flash memory array. Preprogramming and verification prior to erasure are handled by the device.

Programming a PPB bit requires the typical page programming time. Erasing all the PPBs requires typical sector erase time. During PPB bit programming and PPB bit erasing, status is available by reading the Status register. Reading of a PPB bit requires the initial access time of the device.

Notes

Each PPB is individually programmed to 0 and all are erased to 1 in parallel.

If the PPB Lock bit is 0, the PPB Program or PPB Erase command does not execute and fails without programming or erasing the PPB.

The state of the PPB for a given sector can be verified by using the PPB Read command.

8.4.3 Dynamic Protection Bits

Dynamic Protection Bits are volatile and unique for each sector and can be individually modified. DYB only control the protection for sectors that have their PPB set to 1. By issuing the DYB Write command, a DYB is cleared to 0 or set to 1, thus placing each sector in the protected or unprotected state respectively. This feature allows software to easily protect sectors against inadvertent changes, yet does not prevent the easy removal of protection when changes are needed. The DYBs can be set or cleared as often as needed as they are volatile bits.

8.4.4 PPB Lock Bit (PPBL[0])

The PPB Lock Bit is a volatile bit for protecting all PPB bits. When cleared to 0, it locks all PPBs and when set to 1, it allows the PPBs to be changed.

The PLBWR command is used to clear the PPB Lock bit to 0. The PPB Lock Bit must be cleared to 0 only after all the PPBs are configured to the desired settings.

In Persistent Protection mode, the PPB Lock is set to 1 during POR or a hardware reset. When cleared to 0, no software command sequence can set the PPB Lock bit to 1, only another hardware reset or power-up can set the PPB Lock bit.

In the Password Protection mode, the PPB Lock bit is cleared to 0 during POR or a hardware reset. The PPB Lock bit can only be set to 1 by the Password Unlock command.

8.4.5 Sector Protection States Summary

Each sector can be in one of the following protection states:

- Unlocked — The sector is unprotected and protection can be changed by a simple command. The protection state defaults to unprotected after a power cycle, software reset, or hardware reset.
- Dynamically Locked — A sector is protected and protection can be changed by a simple command. The protection state is not saved across a power cycle or reset.
- Persistently Locked — A sector is protected and protection can only be changed if the PPB Lock Bit is set to 1. The protection state is nonvolatile and saved across a power cycle or reset. Changing the protection state requires programming and or erase of the PPB bits

Table 37. Sector Protection States

Protection Bit Values			Sector State
PPB Lock	PPB	DYB	
1	1	1	Unprotected – PPB and DYB are changeable
1	1	0	Protected – PPB and DYB are changeable
1	0	1	Protected – PPB and DYB are changeable
1	0	0	Protected – PPB and DYB are changeable
0	1	1	Unprotected – PPB not changeable, DYB is changeable
0	1	0	Protected – PPB not changeable, DYB is changeable
0	0	1	Protected – PPB not changeable, DYB is changeable
0	0	0	Protected – PPB not changeable, DYB is changeable

8.4.6 Persistent Protection Mode

The Persistent Protection method sets the PPB Lock bit to 1 during POR or Hardware Reset so that the PPB bits are unprotected by a device hardware reset. Software reset does not affect the PPB Lock bit. The PLBWR command can clear the PPB Lock bit to 0 to protect the PPB. There is no command to set the PPB Lock bit therefore the PPB Lock bit will remain at 0 until the next power-off or hardware reset.

8.4.7 Password Protection Mode

Password Protection Mode allows an even higher level of security than the Persistent Sector Protection Mode, by requiring a 64-bit password for unlocking the PPB Lock bit. In addition to this password requirement, after power up and hardware reset, the PPB Lock bit is cleared to 0 to ensure protection at power-up. Successful execution of the Password Unlock command by entering the entire password clears the PPB Lock bit, allowing for sector PPB modifications.

Password Protection Notes

- Once the Password is programmed and verified, the Password Mode (ASPR[2]=0) must be set in order to prevent reading the password.
- The Password Program Command is only capable of programming ‘0’s. Programming a 1 after a cell is programmed as a 0 results in the cell left as a 0 with no programming error set.
- The password is all 1’s when shipped from Cypress. It is located in its own memory space and is accessible through the use of the Password Program and Password Read commands.
- All 64-bit password combinations are valid as a password.
- The Password Mode, once programmed, prevents reading the 64-bit password and further password programming. All further program and read commands to the password region are disabled and these commands are ignored. There is no means to verify what the password is after the Password Mode Lock Bit is selected. Password verification is only allowed before selecting the Password Protection mode.
- The Protection Mode Lock Bits are not erasable.
- The exact password must be entered in order for the unlocking function to occur. If the password unlock command provided password does not match the hidden internal password, the unlock operation fails in the same manner as a programming operation on a protected sector. The P_ERR bit is set to one and the WIP Bit remains set. In this case it is a failure to change the state of the PPB Lock bit because it is still protected by the lack of a valid password.
- The Password Unlock command cannot be accepted any faster than once every 100 µs ± 20 µs. This makes it take an unreasonably long time (58 million years) for a hacker to run through all the 64-bit combinations in an attempt to correctly match a password. The Read Status Register 1 command may be used to read the WIP bit to determine when the device has completed the password unlock command or is ready to accept a new password command. When a valid password is provided the password unlock command does not insert the 100 µs delay before returning the WIP bit to zero.
- If the password is lost after selecting the Password Mode, there is no way to set the PPB Lock bit.
- ECC status may only be read from sectors that are readable. In read protection mode the addresses are forced to the boot sector address. ECC status is shown in that sector while read protection mode is active.

9. Commands

All communication between the host system and the S25FL512S memory device is in the form of units called commands.

All commands begin with an instruction that selects the type of information transfer or device operation to be performed. Commands may also have an address, instruction modifier, latency period, data transfer to the memory, or data transfer from the memory. All instruction, address, and data information is transferred serially between the host system and memory device.

All instructions are transferred from host to memory as a single bit serial sequence on the SI signal.

Single bit wide commands may provide an address or data sent only on the SI signal. Data may be sent back to the host serially on SO signal.

Dual or Quad Output commands provide an address sent to the memory only on the SI signal. Data will be returned to the host as a sequence of bit pairs on I/O0 and I/O1 or four bit (nibble) groups on I/O0, I/O1, I/O2, and I/O3.

Dual or Quad Input/Output (I/O) commands provide an address sent from the host as bit pairs on I/O0 and I/O1 or, four bit (nibble) groups on I/O0, I/O1, I/O2, and I/O3. Data is returned to the host similarly as bit pairs on I/O0 and I/O1 or, four bit (nibble) groups on I/O0, I/O1, I/O2, and I/O3.

Commands are structured as follows:

- Each command begins with an eight bit (byte) instruction.
- The instruction may be stand alone or may be followed by address bits to select a location within one of several address spaces in the device. The address may be either a 24-bit or 32-bit byte boundary address.
- The Serial Peripheral Interface with Multiple I/O provides the option for each transfer of address and data information to be done one, two, or four bits in parallel. This enables a trade off between the number of signal connections (I/O bus width) and the speed of information transfer. If the host system can support a two or four bit wide I/O bus the memory performance can be increased by using the instructions that provide parallel two bit (dual) or parallel four bit (quad) transfers.
- The width of all transfers following the instruction are determined by the instruction sent.
- All sIngle bits or parallel bit groups are transferred in most to least significant bit order.
- Some instructions send instruction modifier (mode) bits following the address to indicate that the next command will be of the same type with an implied, rather than an explicit, instruction. The next command thus does not provide an instruction byte, only a new address and mode bits. This reduces the time needed to send each command when the same command type is repeated in a sequence of commands.
- The address or mode bits may be followed by write data to be stored in the memory device or by a read latency period before read data is returned to the host.
- Read latency may be zero to several SCK cycles (also referred to as dummy cycles).
- All instruction, address, mode, and data information is transferred in byte granularity. Addresses are shifted into the device with the most significant byte first. All data is transferred with the lowest address byte sent first. Following bytes of data are sent in lowest to highest byte address order i.e. the byte address increments.
- All attempts to read the flash memory array during a program, erase, or a write cycle (embedded operations) are ignored. The embedded operation will continue to execute without any affect. A very limited set of commands are accepted during an embedded operation. These are discussed in the individual command descriptions. While a program, erase, or write operation is in progress, it is recommended to check that the Write-In Progress (WIP) bit is 0 before issuing most commands to the device, to ensure the new command can be accepted.
- Depending on the command, the time for execution varies. A command to read status information from an executing command is available to determine when the command completes execution and whether the command was successful.
- Although host software in some cases is used to directly control the SPI interface signals, the hardware interfaces of the host system and the memory device generally handle the details of signal relationships and timing. For this reason, signal relationships and timing are not covered in detail within this software interface focused section of the document. Instead, the focus is on the logical sequence of bits transferred in each command rather than the signal timing and relationships. Following are some general signal relationship descriptions to keep in mind. For additional information on the bit level format and signal timing relationships of commands, see Command Protocol on page 14.

– The host always controls the Chip Select (CS#), Serial Clock (SCK), and Serial Input (SI) - SI for single bit wide transfers. The memory drives Serial Output (SO) for single bit read transfers. The host and memory alternately drive the I/O0-I/O3 signals during Dual and Quad transfers.

–All commands begin with the host selecting the memory by driving CS# low before the first rising edge of SCK. CS# is kept low throughout a command and when CS# is returned high the command ends. Generally, CS# remains low for eight bit transfer multiples to transfer byte granularity information. Some commands will not be accepted if CS# is returned high not at an 8 bit boundary.

9.1 Command Set Summary

9.1.1 Extended Addressing

To accommodate addressing above 128 Mb, there are three options:

1. New instructions are provided with 4-byte address, used to access up to 32 Gb of memory.

Instruction Name	Description	Code (Hex)
4FAST_READ	Read Fast (4-byte Address)	0C
4READ	Read (4-byte Address)	13
4DOR	Read Dual Out (4-byte Address)	3C
4QOR	Read Quad Out (4-byte Address)	6C
4DIOR	Dual I/O Read (4-byte Address)	BC
4QIOR	Quad I/O Read (4-byte Address)	EC
4DDRFR	Read DDR Fast (4-byte Address)	0E
4DDRDIOR	DDR Dual I/O Read (4-byte Address)	BE
4DDRQIOR	DDR Quad I/O Read (4-byte Address)	EE
4PP	Page Program (4-byte Address)	12
4QPP	Quad Page Program (4-byte Address)	34
4SE	Erase 256 kB (4-byte Address)	DC

2. For backward compatibility to the 3-byte address instructions, the standard instructions can be used in conjunction with the EXTADD Bit in the Bank Address Register (BAR[7]). By default BAR[7] is cleared to 0 (following power up and hardware reset), to enable 3-byte (24-bit) addressing. When set to 1, the legacy commands are changed to require 4 bytes (32 bits) for the address field. The following instructions can be used in conjunction with EXTADD bit to switch from 3 bytes to 4 bytes of address field.

Instruction Name	Description	Code (Hex)
READ	Read (3-byte Address)	03
FAST_READ	Read Fast (3-byte Address)	0B
DOR	Read Dual Out (3-byte Address)	3B
QOR	Read Quad Out (3-byte Address)	6B
DIOR	Dual I/O Read (3-byte Address)	BB
QIOR	Quad I/O Read (3-byte Address)	EB
DDRFR	Read DDR Fast (3-byte Address)	0D
DDRDIOR	DDR Dual I/O Read (3-byte Address)	BD
DDRQIOR	DDR Quad I/O Read (3-byte Address)	ED
PP	Page Program (3-byte Address)	02
QPP	Quad Page Program (3-byte Address)	32
SE	Erase 256 kB (3-byte Address)	D8

3. For backward compatibility to the 3-byte addressing, the standard instructions can be used in conjunction with the Bank Address Register:
   a. The Bank Address Register is used to switch between 128-Mbit (16-Mbyte) banks of memory, The standard 3-byte address selects an address within the bank selected by the Bank Address Register.
      i. The host system writes the Bank Address Register to access beyond the first 128 Mbits of memory.
      ii. This applies to read, erase, and program commands.
   b. The Bank Register provides the high order (4th) byte of address, which is used to address the available memory at addresses greater than 16 Mbytes.
   c. Bank Register bits are volatile.
      i. On power up, the default is Bank0 (the lowest address 16 Mbytes).
   d. For Read, the device will continuously transfer out data until the end of the array.
      i. There is no bank to bank delay.
      ii. The Bank Address Register is not updated.
      iii. The Bank Address Register value is used only for the initial address of an access.

Table 38. Bank Address Map

Bank Address Register Bits		Bank	Memory Array Address Range (Hex)	
Bit 1	Bit 0			
0	0	0	00000000	00FFFFFF
0	1	1	01000000	01FFFFFF
1	0	2	02000000	02FFFFFF
1	1	3	03000000	03FFFFFF

Table 39. S25FL512S Command Set (sorted by function)

Function	Command Name	Command Description	Instruction Value (Hex)	Maximum Frequency (MHz)
Read Device Identification	READ_ID (REMS)	Read Electronic Manufacturer Signature	90	133
	RDID	Read ID (JEDEC Manufacturer ID and JEDEC CFI)	9F	133
	RES	Read Electronic Signature	AB	50
	RSFDP	Read Serial Flash Discoverable Parameters	5A	133
Register Access	RDSR1	Read Status Register-1	05	133
	RDSR2	Read Status Register-2	07	133
	RDCR	Read Configuration Register-1	35	133
	WRR	Write Register (Status-1, Configuration-1)	01	133
	WRDI	Write Disable	04	133
	WREN	Write Enable	06	133
	CLSR	Clear Status Register-1 - Erase/Prog. Fail Reset	30	133
	ECCRD	ECC Read (4-byte address	18	133
	ABRD	AutoBoot Register Read	14	133 (QUAD=0) 104 (QUAD=1)
	ABWR	AutoBoot Register Write	15	133
	BRRD	Bank Register Read	16	133
	BRWR	Bank Register Write	17	133
	BRAC	Bank Register Access (Legacy Command formerly used for Deep Power Down)	B9	133
	DLPRD	Data Learning Pattern Read	41	133
	PNVDLR	Program NV Data Learning Register	43	133
	WVDLR	Write Volatile Data Learning Register	4A	133

Table 39. S25FL512S Command Set (sorted by function) (Continued)

Function	Command Name	Command Description	Instruction Value (Hex)	Maximum Frequency (MHz)
Read Flash Array	READ	Read (3- or 4-byte address)	03	50
	4READ	Read (4-byte address)	13	50
	FAST_READ	Fast Read (3- or 4-byte address)	0B	133
	4FAST_READ	Fast Read (4-byte address)	0C	133
	DDRFR	DDR Fast Read (3- or 4-byte address)	0D	80
	4DDRFR	DDR Fast Read (4-byte address)	0E	80
	DOR	Read Dual Out (3- or 4-byte address)	3B	104
	4DOR	Read Dual Out (4-byte address)	3C	104
	QOR	Read Quad Out (3- or 4-byte address)	6B	104
	4QOR	Read Quad Out (4-byte address)	6C	104
	DIOR	Dual I/O Read (3- or 4-byte address)	BB	104
	4DIOR	Dual I/O Read (4-byte address)	BC	104
	DDRDIOR	DDR Dual I/O Read (3- or 4-byte address)	BD	80
	4DDRDIOR	DDR Dual I/O Read (4-byte address)	BE	80
	QIOR	Quad I/O Read (3- or 4-byte address)	EB	104
	4QIOR	Quad I/O Read (4-byte address)	EC	104
	DDRQIOR	DDR Quad I/O Read (3- or 4-byte address)	ED	80
	4DDRQIOR	DDR Quad I/O Read (4-byte address)	EE	80
Program Flash Array	PP	Page Program (3- or 4-byte address)	02	133
	4PP	Page Program (4-byte address)	12	133
	QPP	Quad Page Program (3- or 4-byte address)	32	80
	QPP	Quad Page Program - Alternate instruction (3- or 4-byte address)	38	80
	4QPP	Quad Page Program (4-byte address)	34	80
	PGSP	Program Suspend	85	133
	PGRS	Program Resume	8A	133
Erase Flash Array	BE	Bulk Erase	60	133
	BE	Bulk Erase (alternate command)	C7	133
	SE	Erase 256 kB (3- or 4-byte address)	D8	133
	4SE	Erase 256 kB (4-byte address)	DC	133
	ERSP	Erase Suspend	75	133
	ERRS	Erase Resume	7A	133
One Time Program Array	OTPP	OTP Program	42	133
	OTPR	OTP Read	4B	133

Table 39. S25FL512S Command Set (sorted by function) (Continued)

Function	Command Name	Command Description	Instruction Value (Hex)	Maximum Frequency (MHz)
Advanced Sector Protection	DYBRD	DYB Read	E0	133
	DYBWR	DYB Write	E1	133
	PPBRD	PPB Read	E2	133
	PPBP	PPB Program	E3	133
	PPBE	PPB Erase	E4	133
	ASPRD	ASP Read	2B	133
	ASPP	ASP Program	2F	133
	PLBRD	PPB Lock Bit Read	A7	133
	PLBWR	PPB Lock Bit Write	A6	133
	PASSRD	Password Read	E7	133
	PASSP	Password Program	E8	133
	PASSU	Password Unlock	E9	133
Reset	RESET	Software Reset	F0	133
	MBR	Mode Bit Reset	FF	133
Reserved for Future Use	MPM	Reserved for Multi-I/O-High Perf Mode (MPM)	A3	133
RFU	Reserved-18	Reserved	18	
RFU	Reserved-E5	Reserved	E5	
RFU	Reserved-E6	Reserved	E6	

9.1.2 Read Device Identification

There are multiple commands to read information about the device manufacturer, device type, and device features. SPI memories from different vendors have used different commands and formats for reading information about the memories. The S25FL512S device supports the three most common device information commands.

9.1.3 Register Read or Write

There are multiple registers for reporting embedded operation status or controlling device configuration options. There are commands for reading or writing these registers. Registers contain both volatile and nonvolatile bits. Nonvolatile bits in registers are automatically erased and programmed as a single (write) operation.

9.1.3.1 Monitoring Operation Status

The host system can determine when a write, program, erase, suspend or other embedded operation is complete by monitoring the Write in Progress (WIP) bit in the Status Register. The Read from Status Register-1 command provides the state of the WIP bit. The program error (P_ERR) and erase error (E_ERR) bits in the status register indicate whether the most recent program or erase command has not completed successfully. When P_ERR or E_ERR bits are set to one, the WIP bit will remain set to one indicating the device remains busy. Under this condition, only the CLSR, WRDI, RDSR1, RDSR2, and software RESET commands are valid commands. A Clear Status Register (CLSR) followed by a Write Disable (WRDI) command must be sent to return the device to standby state. CLSR clears the WIP, P_ERR, and E_ERR bits. WRDI clears the WEL bit. Alternatively, Hardware Reset, or Software Reset (RESET) may be used to return the device to standby state.

9.1.3.2 Configuration

There are commands to read, write, and protect registers that control interface path width, interface timing, interface address length, and some aspects of data protection.

9.1.4 Read Flash Array

Data may be read from the memory starting at any byte boundary. Data bytes are sequentially read from incrementally higher byte addresses until the host ends the data transfer by driving CS# input High. If the byte address reaches the maximum address of the memory array, the read will continue at address zero of the array.

There are several different read commands to specify different access latency and data path widths. Double Data Rate (DDR) commands also define the address and data bit relationship to both SCK edges:

- The Read command provides a single address bit per SCK rising edge on the SI signal with read data returning a single bit per SCK falling edge on the SO signal. This command has zero latency between the address and the returning data but is limited to a maximum SCK rate of 50 MHz.
- Other read commands have a latency period between the address and returning data but can operate at higher SCK frequencies. The latency depends on the configuration register latency code.
- The Fast Read command provides a single address bit per SCK rising edge on the SI signal with read data returning a single bit per SCK falling edge on the SO signal and may operate up to 133 MHz.
- Dual or Quad Output read commands provide address a single bit per SCK rising edge on the SI / I/O0 signal with read data returning two bits, or four bits of data per SCK falling edge on the I/O0-I/O3 signals.
- Dual or Quad I/O Read commands provide address two bits or four bits per SCK rising edge with read data returning two bits, or four bits of data per SCK falling edge on the I/O0-I/O3 signals.
- Fast (Single), Dual, or Quad Double Data Rate read commands provide address one bit, two bits or four bits per every SCK edge with read data returning one bit, two bits, or four bits of data per every SCK edge on the I/O0-I/O3 signals. Double Data Rate (DDR) operation is only supported for core and I/O voltages of 3 to 3.6V.

9.1.5 Program Flash Array

Programming data requires two commands: Write Enable (WREN), and Page Program (PP or QPP). The Page Program command accepts from 1 byte up to 512 consecutive bytes of data (page) to be programmed in one operation. Programming means that bits can either be left at 1, or programmed from 1 to 0. Changing bits from 0 to 1 requires an erase operation.

9.1.6 Erase Flash Array

The Sector Erase (SE) and Bulk Erase (BE) commands set all the bits in a sector or the entire memory array to 1. A bit needs to be first erased to 1 before programming can change it to a 0. While bits can be individually programmed from a 1 to 0, erasing bits from 0 to 1 must be done on a sector-wide (SE) or array-wide (BE) level.

9.1.7 OTP, Block Protection, and Advanced Sector Protection

There are commands to read and program a separate One TIme Programmable (OTP) array for permanent data such as a serial number. There are commands to control a contiguous group (block) of flash memory array sectors that are protected from program and erase operations. There are commands to control which individual flash memory array sectors are protected from program and erase operations.

9.1.8 Reset

There is a command to reset to the default conditions present after power on to the device. There is a command to reset (exit from) the Enhanced Performance Read Modes.

9.1.9 Reserved

Some instructions are reserved for future use. In this generation of the S25FL512S some of these command instructions may be unused and not affect device operation, some may have undefined results.

Some commands are reserved to ensure that a legacy or alternate source device command is allowed without affect. This allows legacy software to issue some commands that are not relevant for the current generation S25FL512S device with the assurance these commands do not cause some unexpected action.

Some commands are reserved for use in special versions of the FL-S not addressed by this document or for a future generation. This allows new host memory controller designs to plan the flexibility to issue these command instructions. The command format is defined if known at the time this document revision is published.

9.2 Identification Commands

9.2.1 Read Identification - REMS (Read_ID or REMS 90h)

The READ_ID command identifies the Device Manufacturer ID and the Device ID. The command is also referred to as Read Electronic Manufacturer and device Signature (REMS). READ-ID (REMS) is only supported for backward compatibility and should not be used for new software designs. New software designs should instead make use of the RDID command.

The command is initiated by shifting on SI the instruction code “90h” followed by a 24-bit address of 00000h. Following this, the Manufacturer ID and the Device ID are shifted out on SO starting at the falling edge of SCK after address. The Manufacturer ID and the Device ID are always shifted out with the MSB first. If the 24-bit address is set to 000001h, then the Device ID is read out first followed by the Manufacturer ID. The Manufacturer ID and Device ID output data toggles between address 000000H and 000001H until terminated by a low to high transition on CS# input. The maximum clock frequency for the READ_ID command is 133 MHz.

Figure 47. READ_ID (90h) Command Sequence

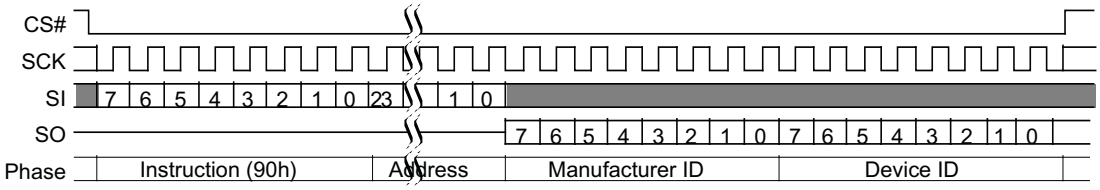


Table 40. Read_ID Values

Device	Manufacturer ID (hex)	Device ID (hex)
S25FL512S	01	19

9.2.2 Read Identification (RDID 9Fh)

The Read Identification (RDID) command provides read access to manufacturer identification, device identification, and Common Flash Interface (CFI) information. The manufacturer identification is assigned by JEDEC. The CFI structure is defined by JEDEC standard. The device identification and CFI values are assigned by Cypress.

The JEDEC Common Flash Interface (CFI) specification defines a device information structure, which allows a vendor-specified software flash management program (driver) to be used for entire families of flash devices. Software support can then be device-independent, JEDEC manufacturer ID independent, forward and backward-compatible for the specified flash device families. System vendors can standardize their flash drivers for long-term software compatibility by using the CFI values to configure a family driver from the CFI information of the device in use.

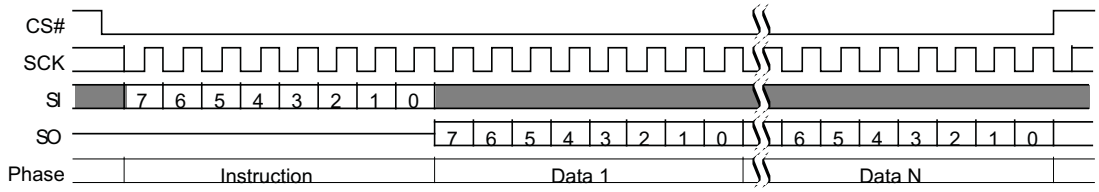
Any RDID command issued while a program, erase, or write cycle is in progress is ignored and has no effect on execution of the program, erase, or write cycle that is in progress.

The RDID instruction is shifted on SI. After the last bit of the RDID instruction is shifted into the device, a byte of manufacturer identification, two bytes of device identification, extended device identification, and CFI information will be shifted sequentially out on SO. As a whole this information is referred to as ID-CFI. See ID-CFI Address Space on page 45 for the detail description of the ID-CFI contents.

Continued shifting of output beyond the end of the defined ID-CFI address space will provide undefined data. The RDID command sequence is terminated by driving CS# to the logic high state anytime during data output.

The maximum clock frequency for the RDID command is 133 MHz.

Figure 48. Read Identification (RDID 9Fh) Command Sequence



9.2.3 Read Electronic Signature (RES) (ABh)

The RES command is used to read a single byte Electronic Signature from SO. RES is only supported for backward compatibility and should not be used for new software designs. New software designs should instead make use of the RDID command.

The RES instruction is shifted in followed by three dummy bytes onto SI. After the last bit of the three dummy bytes are shifted into the device, a byte of Electronic Signature will be shifted out of SO. Each bit is shifted out by the falling edge of SCK. The maximum clock frequency for the RES command is 50 MHz.

The Electronic Signature can be read repeatedly by applying multiples of eight clock cycles.

The RES command sequence is terminated by driving CS# to the logic high state anytime during data output.

Figure 49. Read Electronic Signature (RES ABh) Command Sequence

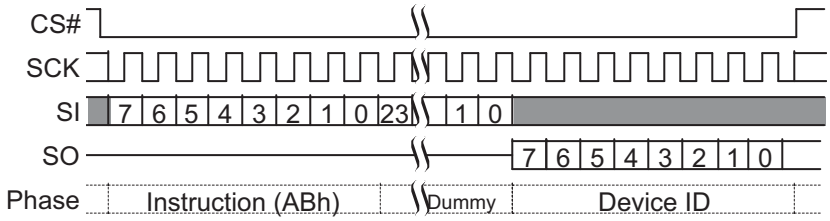


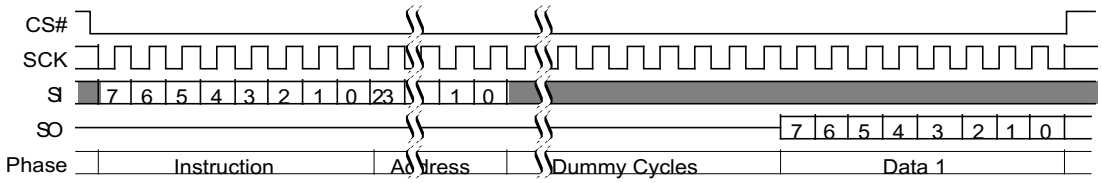
Table 41. RES Values

Device	Device ID (hex)
S25FL512S	19

9.2.4 Read Serial Flash Discoverable Parameters (RSFDP 5Ah)

The command is initiated by shifting on SI the instruction code ‘5Ah’, followed by a 24-bit address of 000000h, followed by eight dummy cycles. The SFDP bytes are then shifted out on SO starting at the falling edge of SCK after the eight dummy cycles. The SFDP bytes are always shifted out with the MSB first. If the 24-bit address is set to any other value, the selected location in the SFDP space is the starting point of the data read. This enables random access to any parameter in the SFDP space. The maximum clock frequency for the RSFDP command is 133 MHz.

Figure 50. RSFDP Command Sequence

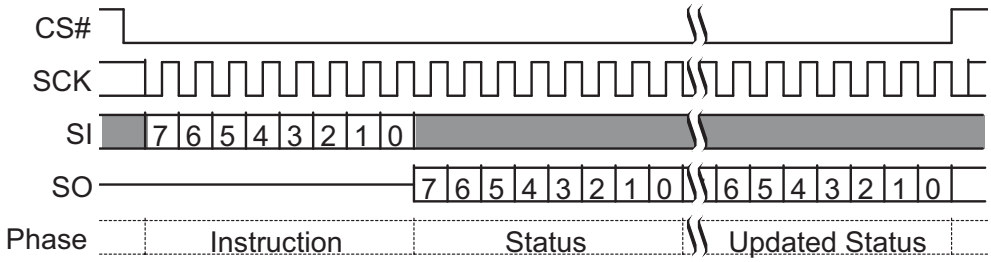


9.3 Register Access Commands

9.3.1 Read Status Register-1 (RDSR1 05h)

The Read Status Register-1 (RDSR1) command allows the Status Register-1 contents to be read from SO. The Status Register-1 contents may be read at any time, even while a program, erase, or write operation is in progress. It is possible to read the Status Register-1 continuously by providing multiples of eight clock cycles. The status is updated for each eight cycle read. The maximum clock frequency for the RDSR1 (05h) command is 133 MHz.

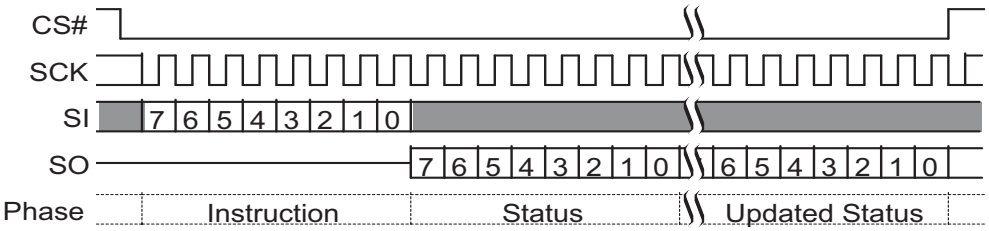
Figure 51. Read Status Register-1 (RDSR1 05h) Command Sequence



9.3.2 Read Status Register-2 (RDSR2 07h)

The Read Status Register (RDSR2) command allows the Status Register-2 contents to be read from SO. The Status Register-2 contents may be read at any time, even while a program, erase, or write operation is in progress. It is possible to read the Status Register-2 continuously by providing multiples of eight clock cycles. The status is updated for each eight cycle read. The maximum clock frequency for the RDSR2 command is 133 MHz.

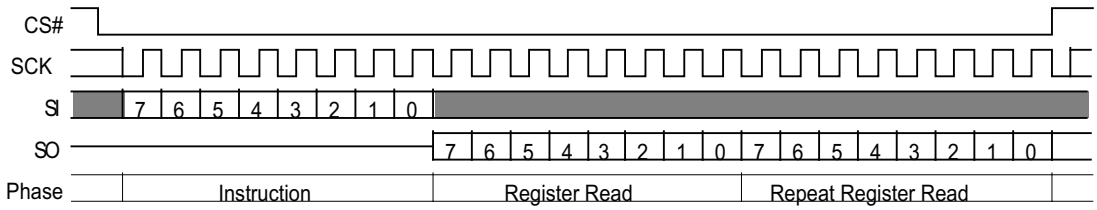
Figure 52. Read Status Register-2 (RDSR2 07h) Command Sequence



9.3.3 Read Configuration Register (RDCR 35h)

The Read Configuration Register (RDCR) command allows the Configuration Register contents to be read from SO. It is possible to read the Configuration Register continuously by providing multiples of eight clock cycles. The Configuration Register contents may be read at any time, even while a program, erase, or write operation is in progress.

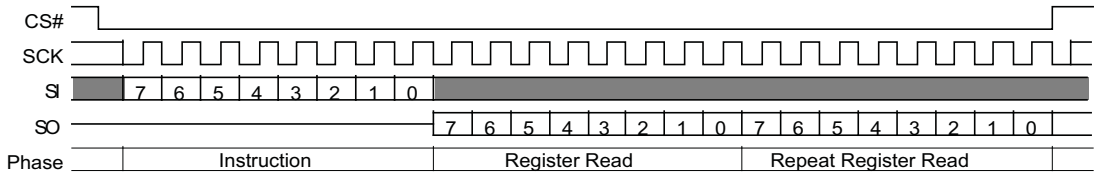
Figure 53. Read Configuration Register (RDCR 35h) Command Sequence



9.3.4 Bank Register Read (BRRD 16h)

The Read the Bank Register (BRRD) command allows the Bank address Register contents to be read from SO. The instruction is first shifted in from SI. Then the 8-bit Bank Register is shifted out on SO. It is possible to read the Bank Register continuously by providing multiples of eight clock cycles. The maximum operating clock frequency for the BRRD command is 133 MHz.

Figure 54. Read Bank Register (BRRD 16h) Command



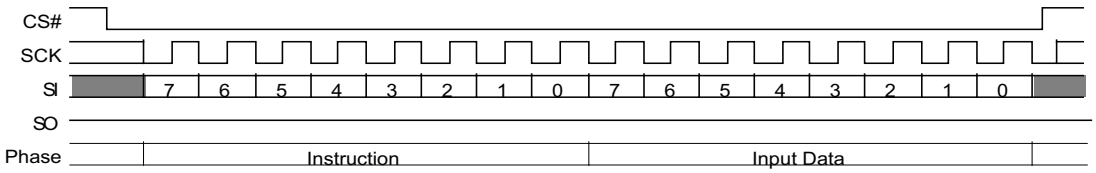
9.3.5 Bank Register Write (BRWR 17h)

The Bank Register Write (BRWR) command is used to write address bits above A23, into the Bank Address Register (BAR). The command is also used to write the Extended address control bit (EXTADD) that is also in BAR[7]. BAR provides the high order addresses needed by devices having more than 128 Mbits (16 Mbytes), when using 3-byte address commands without extended addressing enabled (BAR[7] EXTADD = 0). Because this command is part of the addressing method and is not changing data in the flash memory, this command does not require the WREN command to precede it.

The BRWR instruction is entered, followed by the data byte on SI. The Bank Register is one data byte in length.

The BRWR command has no effect on the P_ERR, E_ERR or WIP bits of the Status and Configuration Registers. Any bank address bit reserved for the future should always be written as a 0.

Figure 55. Bank Register Write (BRWR 17h) Command



9.3.6 Bank Register Access (BRAC B9h)

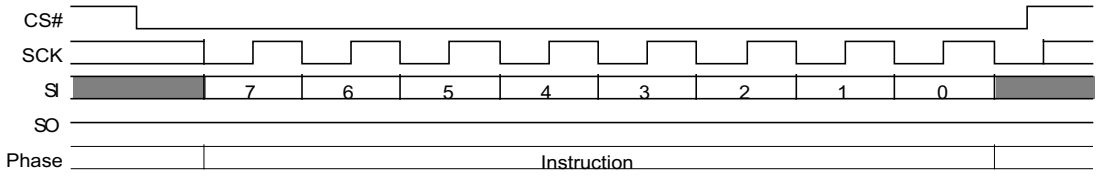
The Bank Register Read and Write commands provide full access to the Bank Address Register (BAR) but they are both commands that are not present in legacy SPI memory devices. Host system SPI memory controller interfaces may not be able to easily support such new commands. The Bank Register Access (BRAC) command uses the same command code and format as the Deep Power Down (DPD) command that is available in legacy SPI memories. The FL-S family does not support a DPD feature but assigns this legacy command code to the BRAC command to enable write access to the Bank Address Register for legacy systems that are able to send the legacy DPD (B9h) command.

When the BRAC command is sent, the FL-S family device will then interpret an immediately following Write Register (WRR) command as a write to the lower address bits of the BAR. A WREN command is not used between the BRAC and WRR commands. Only the lower two bits of the first data byte following the WRR command code are used to load BAR[1:0]. The upper bits of that byte and the content of the optional WRR command second data byte are ignored. Following the WRR command the access to BAR is closed and the device interface returns to the standby state. The combined BRAC followed by WRR command sequence has no affect on the value of the ExtAdd bit (BAR[7]).

Commands other than WRR may immediately follow BRAC and execute normally. However, any command other than WRR, or any other sequence in which CS# goes low and returns high, following a BRAC command, will close the access to BAR and return to the normal interpretation of a WRR command as a write to Status Register-1 and the Configuration Register.

The BRAC + WRR sequence is allowed only when the device is in standby, program suspend, or erase suspend states. This command sequence is illegal when the device is performing an embedded algorithm or when the program (P_ERR) or erase (E_ERR) status bits are set to 1.

Figure 56. BRAC (B9h) Command Sequence



9.3.7 Write Registers (WRR 01h)

The Write Registers (WRR) command allows new values to be written to both the Status Register-1 and Configuration Register. Before the Write Registers (WRR) command can be accepted by the device, a Write Enable (WREN) command must be received. After the Write Enable (WREN) command has been decoded successfully, the device will set the Write Enable Latch (WEL) in the Status Register to enable any write operations.

The Write Registers (WRR) command is entered by shifting the instruction and the data bytes on SI. The Status Register is one data byte in length.

The Write Registers (WRR) command will set the P_ERR or E_ERR bits if there is a failure in the WRR operation. Any Status or Configuration Register bit reserved for the future must be written as a 0.

CS# must be driven to the logic high state after the eighth or sixteenth bit of data has been latched. If not, the Write Registers (WRR) command is not executed. If CS# is driven high after the eighth cycle then only the Status Register-1 is written; otherwise, after the sixteenth cycle both the Status and Configuration Registers are written. When the configuration register QUAD bit CR[1] is 1, only the WRR command format with 16 data bits may be used.

As soon as CS# is driven to the logic high state, the self-timed Write Registers (WRR) operation is initiated. While the Write Registers (WRR) operation is in progress, the Status Register may still be read to check the value of the Write-In Progress (WIP) bit. The Write-In Progress (WIP) bit is a 1 during the self-timed Write Registers (WRR) operation, and is a 0 when it is completed. When the Write Registers (WRR) operation is completed, the Write Enable Latch (WEL) is set to a 0. The WRR command must be executed under continuous power. The maximum clock frequency for the WRR command is 133 MHz.

Figure 57. Write Registers (WRR 01h) Command Sequence – 8 data bits

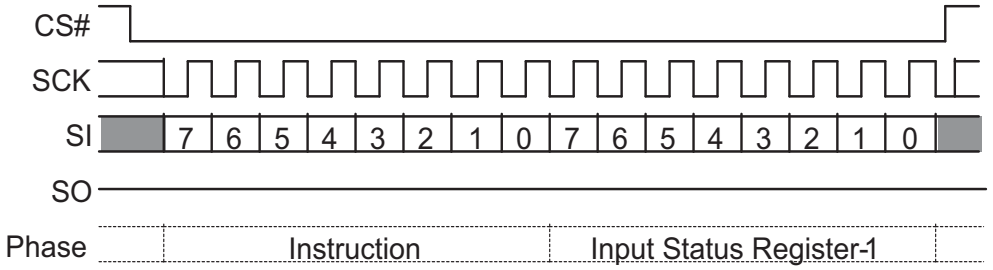
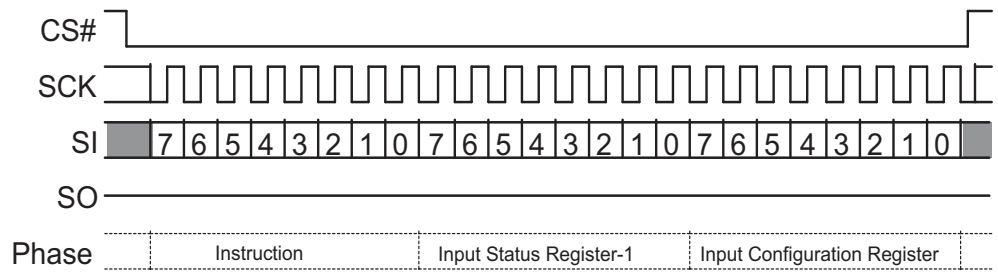


Figure 58. Write Registers (WRR 01h) Command Sequence – 16 data bits



The Write Registers (WRR) command allows the user to change the values of the Block Protect (BP2, BP1, and BP0) bits to define the size of the area that is to be treated as read-only. The Write Registers (WRR) command also allows the user to set the Status

Register Write Disable (SRWD) bit to a 1 or a 0. The Status Register Write Disable (SRWD) bit and Write Protect (WP#) signal allow the BP bits to be hardware protected.

When the Status Register Write Disable (SRWD) bit of the Status Register is a 0 (its initial delivery state), it is possible to write to the Status Register provided that the Write Enable Latch (WEL) bit has previously been set by a Write Enable (WREN) command, regardless of the whether Write Protect (WP#) signal is driven to the logic high or logic low state.

When the Status Register Write Disable (SRWD) bit of the Status Register is set to a 1, two cases need to be considered, depending on the state of Write Protect (WP#):

- If Write Protect (WP#) signal is driven to the logic high state, it is possible to write to the Status and Configuration Registers provided that the Write Enable Latch (WEL) bit has previously been set to a “1” by initiating a Write Enable (WREN) command.
- If Write Protect (WP#) signal is driven to the logic low state, it is not possible to write to the Status and Configuration Registers even if the Write Enable Latch (WEL) bit has previously been set to a 1 by a Write Enable (WREN) command. Attempts to write to the Status and Configuration Registers are rejected, and are not accepted for execution. As a consequence, all the data bytes in the memory area that are protected by the Block Protect (BP2, BP1, BP0) bits of the Status Register, are also hardware protected by WP#.

The WP# hardware protection can be provided:

- by setting the Status Register Write Disable (SRWD) bit after driving Write Protect (WP#) signal to the logic low state;
- or by driving Write Protect (WP#) signal to the logic low state after setting the Status Register Write Disable (SRWD) bit to a 1.

The only way to release the hardware protection is to pull the Write Protect (WP#) signal to the logic high state. If WP# is permanently tied high, hardware protection of the BP bits can never be activated.

Table 42. Block Protection Modes

WP#	SRWD Bit	Mode	Write Protection of Registers	Memory Content	
				Protected Area	Unprotected Area
1	1	Software Protected	Status and Configuration Registers are Writable (if WREN command has set the WEL bit). The values in the SRWD, BP2, BP1, and BP0 bits and those in the Configuration Register can be changed	Protected against Page Program, Quad Input Program, Sector Erase, and Bulk Erase	Ready to accept Page Program, Quad Input Program and Sector Erase commands
1	0				
0	0				
0	1	Hardware Protected	Status and Configuration Registers are Hardware Write Protected. The values in the SRWD, BP2, BP1, and BP0 bits and those in the Configuration Register cannot be changed	Protected against Page Program, Sector Erase, and Bulk Erase	Ready to accept Page Program or Erase commands

Notes

1. The Status Register originally shows 00h when the device is first shipped from Cypress to the customer.
2. Hardware protection is disabled when Quad Mode is enabled (QUAD bit = 1 in Configuration Register). WP# becomes I/O2; therefore, it cannot be utilized.

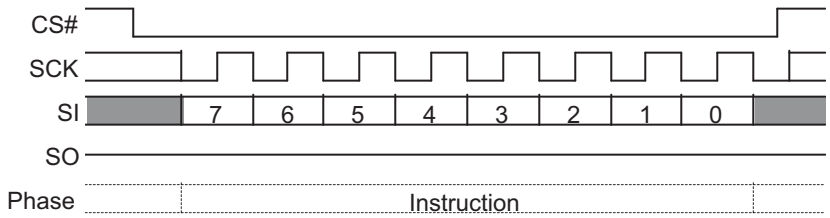
The WRR command has an alternate function of loading the Bank Address Register if the command immediately follows a BRAC command. See Bank Register Access (BRAC B9h) on page 74.

9.3.8 Write Enable (WREN 06h)

The Write Enable (WREN) command sets the Write Enable Latch (WEL) bit of the Status Register 1 (SR1[1]) to a 1. The Write Enable Latch (WEL) bit must be set to a 1 by issuing the Write Enable (WREN) command to enable write, program and erase commands.

CS# must be driven into the logic high state after the eighth bit of the instruction byte has been latched in on SI. Without CS# being driven to the logic high state after the eighth bit of the instruction byte has been latched in on SI, the write enable operation will not be executed.

Figure 59. Write Enable (WREN 06h) Command Sequence



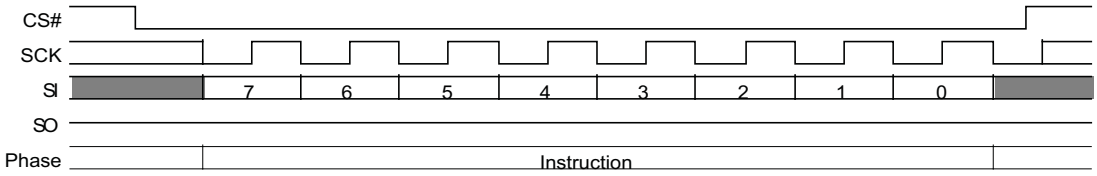
9.3.9 Write Disable (WRDI 04h)

The Write Disable (WRDI) command sets the Write Enable Latch (WEL) bit of the Status Register-1 (SR1[1]) to a 0.

The Write Enable Latch (WEL) bit may be set to a 0 by issuing the Write Disable (WRDI) command to disable Page Program (PP), Sector Erase (SE), Bulk Erase (BE), Write Registers (WRR), OTP Program (OTPP), and other commands, that require WEL be set to 1 for execution. The WRDI command can be used by the user to protect memory areas against inadvertent writes that can possibly corrupt the contents of the memory. The WRDI command is ignored during an embedded operation while WIP bit =1.

CS# must be driven into the logic high state after the eighth bit of the instruction byte has been latched in on SI. Without CS# being driven to the logic high state after the eighth bit of the instruction byte has been latched in on SI, the write disable operation will not be executed.

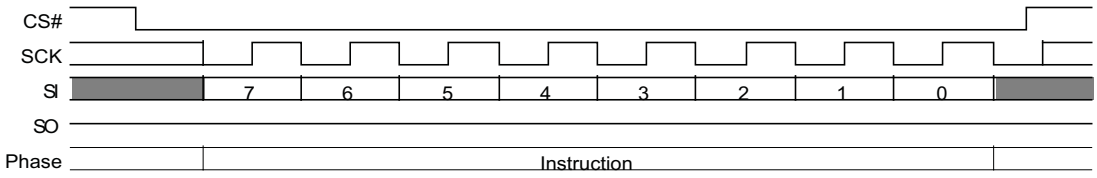
Figure 60. Write Disable (WRDI 04h) Command Sequence



9.3.10 Clear Status Register (CLSR 30h):

The Clear Status Register command resets bit SR1[5] (Erase Fail Flag) and bit SR1[6] (Program Fail Flag). It is not necessary to set the WEL bit before the Clear SR command is executed. The Clear SR command will be accepted even when the device remains busy with WIP set to 1, as the device does remain busy when either error bit is set. The WEL bit will be unchanged after this command is executed.

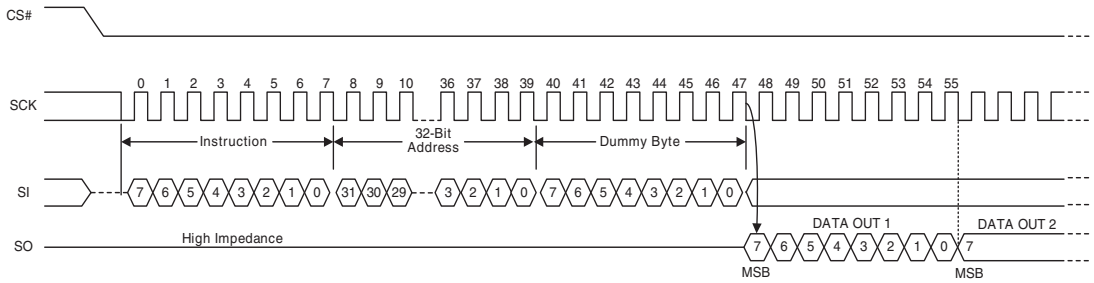
Figure 61. Clear Status Register (CLSR 30h) Command Sequence



9.3.11 ECC Status Register Read (ECCRD 18h)

To read the ECC Status Register, the command is followed by the ECC unit (16 Bytes) address, the four least significant bits (LSB) of address must be set to zero. This is followed by the number of dummy cycles selected by the read latency value in CR2V[3:0]. Then the 8-bit contents of the ECC Register, for the ECC unit selected, are shifted out on SO 16 times, once for each byte in the ECC Unit. If CS# remains low the next ECC unit status is sent through SO/I/O1 16 times, once for each byte in the ECC Unit, this continues until CS# goes high. The maximum operating clock frequency for the ECC READ command is 133 MHz. See Automatic ECC on page 96 for details on ECC unit.

Figure 62. ECC Status Register Read Command Sequence



9.3.12 AutoBoot

SPI devices normally require 32 or more cycles of command and address shifting to initiate a read command. And, in order to read boot code from an SPI device, the host memory controller or processor must supply the read command from a hardwired state machine or from some host processor internal ROM code.

Parallel NOR devices need only an initial address, supplied in parallel in a single cycle, and initial access time to start reading boot code.

The AutoBoot feature allows the host memory controller to take boot code from an S25FL512S device immediately after the end of reset, without having to send a read command. This saves 32 or more cycles and simplifies the logic needed to initiate the reading of boot code.

- As part of the power up reset, hardware reset, or command reset process the AutoBoot feature automatically starts a read access from a pre-specified address. At the time the reset process is completed, the device is ready to deliver code from the starting address. The host memory controller only needs to drive CS# signal from high to low and begin toggling the SCK signal. The S25FL512S device will delay code output for a pre-specified number of clock cycles before code streams out.
  - The Auto Boot Start Delay (ABSD) field of the AutoBoot register specifies the initial delay if any is needed by the host.
  - The host cannot send commands during this time.
  - If ABSD = 0, the maximum SCK frequency is 50 MHz.
  - If ABSD > 0, the maximum SCK frequency is 133 MHz if the QUAD bit CR1[1] is 0 or 104 MHz if the QUAD bit is set to 1.

- The starting address of the boot code is selected by the value programmed into the AutoBoot Start Address (ABSA) field of the AutoBoot Register which specifies a 512 byte boundary aligned location; the default address is 00000000h.
  - Data will continuously shift out until CS# returns high.
- At any point after the first data byte is transferred, when CS# returns high, the SPI device will reset to standard SPI mode; able to accept normal command operations.
  - A minimum of one byte must be transferred.
  - AutoBoot mode will not initiate again until another power cycle or a reset occurs.
- An AutoBoot Enable bit (ABE) is set to enable the AutoBoot feature.

The AutoBoot register bits are nonvolatile and provide:

- The starting address (512-byte boundary), set by the AutoBoot Start Address (ABSA). The size of the ABSA field is 23 bits for devices up to 32-Gbit.
- The number of initial delay cycles, set by the AutoBoot Start Delay (ABSD) 8-bit count value.
- The AutoBoot Enable.

If the configuration register QUAD bit CR1[1] is set to 1, the boot code will be provided 4 bits per cycle in the same manner as a Read Quad Out command. If the QUAD bit is 0 the code is delivered serially in the same manner as a Read command.

Figure 63. AutoBoot Sequence (CR1[1]=0)

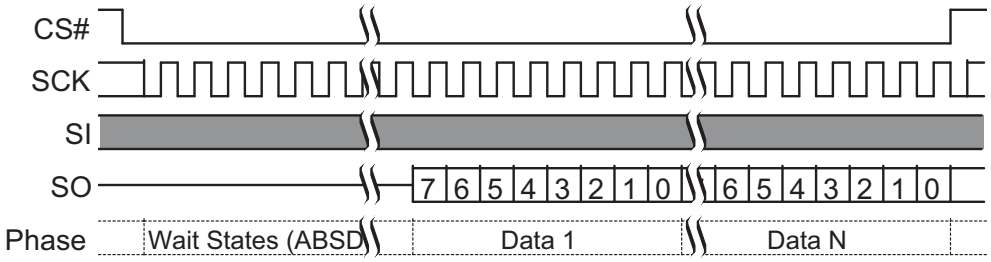
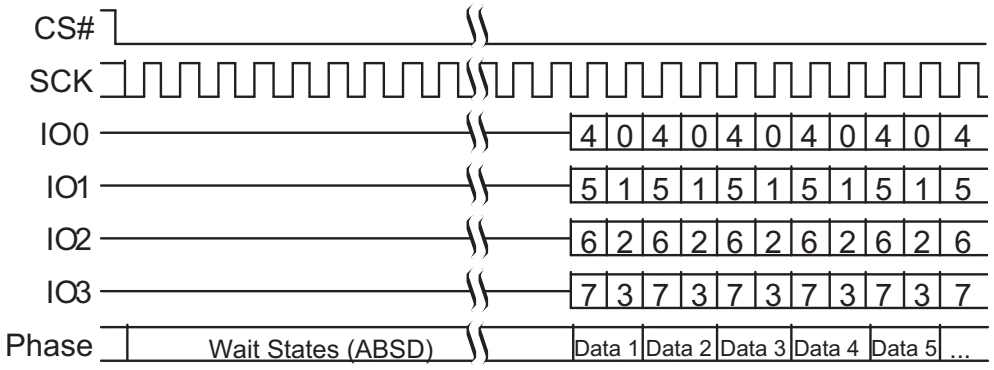


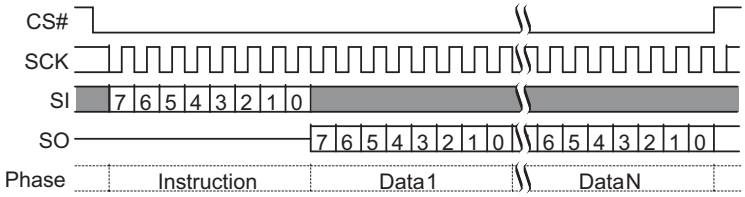
Figure 64. AutoBoot Sequence (CR1[1]=1)



9.3.13 AutoBoot Register Read (ABRD 14h)

The AutoBoot Register Read command is shifted into SI. Then the 32-bit AutoBoot Register is shifted out on SO, least significant byte first, most significant bit of each byte first. It is possible to read the AutoBoot Register continuously by providing multiples of 32 clock cycles. If the QUAD bit CR1[1] is cleared to 0, the maximum operating clock frequency for ABRD command is 133 MHz. If the QUAD bit CR1[1] is set to 1, the maximum operating clock frequency for ABRD command is 104 MHz.

Figure 65. AutoBoot Register Read (ABRD 14h) Command



9.3.14 AutoBoot Register Write (ABWR 15h)

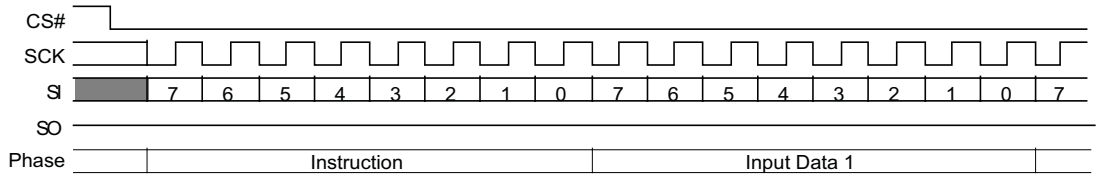
Before the ABWR command can be accepted, a Write Enable (WREN) command must be issued and decoded by the device, which sets the Write Enable Latch (WEL) in the Status Register to enable any write operations.

The ABWR command is entered by shifting the instruction and the data bytes on SI, least significant byte first, most significant bit of each byte first. The ABWR data is 32 bits in length.

The ABWR command has status reported in Status Register-1 as both an erase and a programming operation. An E_ERR or a P_ERR may be set depending on whether the erase or programming phase of updating the register fails.

CS# must be driven to the logic high state after the 32nd bit of data has been latched. If not, the ABWR command is not executed. As soon as CS# is driven to the logic high state, the self-timed ABWR operation is initiated. While the ABWR operation is in progress, Status Register-1 may be read to check the value of the Write-In Progress (WIP) bit. The Write-In Progress (WIP) bit is a 1 during the self-timed ABWR operation, and is a 0. when it is completed. When the ABWR cycle is completed, the Write Enable Latch (WEL) is set to a 0. The maximum clock frequency for the ABWR command is 133 MHz.

Figure 66. AutoBoot Register Write (ABWR) Command



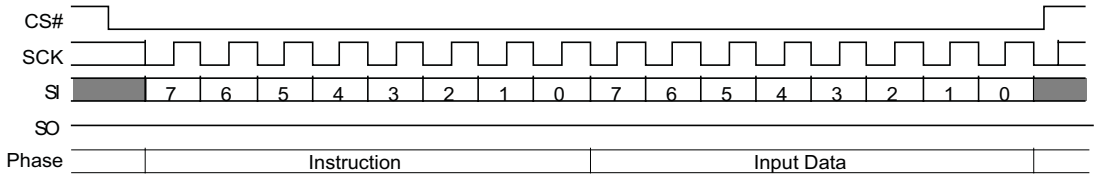
9.3.15 Program NVDLR (PNVDLR 43h)

Before the Program NVDLR (PNVDLR) command can be accepted by the device, a Write Enable (WREN) command must be issued and decoded by the device. After the Write Enable (WREN) command has been decoded successfully, the device will set the Write Enable Latch (WEL) to enable the PNVDLR operation.

The PNVDLR command is entered by shifting the instruction and the data byte on SI.

CS# must be driven to the logic high state after the eighth (8th) bit of data has been latched. If not, the PNVDLR command is not executed. As soon as CS# is driven to the logic high state, the self-timed PNVDLR operation is initiated. While the PNVDLR operation is in progress, the Status Register may be read to check the value of the Write-In Progress (WIP) bit. The Write-In Progress (WIP) bit is a 1 during the self-timed PNVDLR cycle, and is a 0. when it is completed. The PNVDLR operation can report a program error in the P_ERR bit of the status register. When the PNVDLR operation is completed, the Write Enable Latch (WEL) is set to a 0 The maximum clock frequency for the PNVDLR command is 133 MHz.

Figure 67. Program NVDLR (PNVDLR 43h) Command Sequence



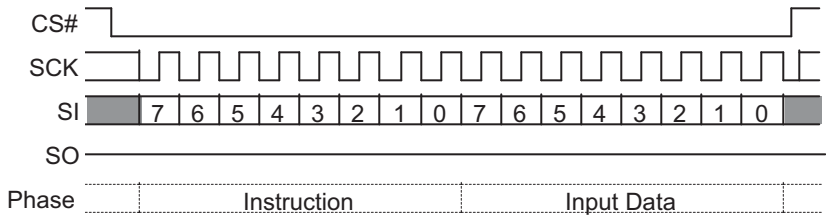
9.3.16 Write VDLR (WVDLR 4Ah)

Before the Write VDLR (WVDLR) command can be accepted by the device, a Write Enable (WREN) command must be issued and decoded by the device. After the Write Enable (WREN) command has been decoded successfully, the device will set the Write Enable Latch (WEL) to enable WVDLR operation.

The WVDLR command is entered by shifting the instruction and the data byte on SI.

CS# must be driven to the logic high state after the eighth (8th) bit of data has been latched. If not, the WVDLR command is not executed. As soon as CS# is driven to the logic high state, the WVDLR operation is initiated with no delays. The maximum clock frequency for the PNVDLR command is 133 MHz.

Figure 68. Write VDLR (WVDLR 4Ah) Command Sequence



9.3.17 Data Learning Pattern Read (DLPRD 41h)

The instruction is shifted on SI, then the 8-bit DLP is shifted out on SO. It is possible to read the DLP continuously by providing multiples of eight clock cycles. The maximum operating clock frequency for the DLPRD command is 133 MHz.

Figure 69. DLP Read (DLPRD 41h) Command Sequence

9.4 Read Memory Array Commands

Read commands for the main flash array provide many options for prior generation SPI compatibility or enhanced performance SPI:

- Some commands transfer address or data on each rising edge of SCK. These are called Single Data Rate commands (SDR).
- Some SDR commands transfer address one bit per rising edge of SCK and return data 1, 2, or 4 bits of data per rising edge of SCK. These are called Read or Fast Read for 1-bit data; Dual Output Read for 2-bit data, and Quad Output for 4-bit data.
- Some SDR commands transfer both address and data 2 or 4 bits per rising edge of SCK. These are called Dual I/O for 2 bit and Quad I/O for 4 bit.
- Some commands transfer address and data on both the rising edge and falling edge of SCK. These are called Double Data Rate (DDR) commands.
- There are DDR commands for 1, 2, or 4 bits of address or data per SCK edge. These are called Fast DDR for 1-bit, Dual I/O DDR for 2-bit, and Quad I/O DDR for 4-bit per edge transfer.

All of these commands begin with an instruction code that is transferred one bit per SCK rising edge. The instruction is followed by either a 3- or 4-byte address transferred at SDR or DDR. Commands transferring address or data 2 or 4 bits per clock edge are called Multiple I/O (MIO) commands. For FL-S devices at
256 Mbits or higher density, the traditional SPI 3-byte addresses are unable to directly address all locations in the memory array. These device have a bank address register that is used with 3-byte address commands to supply the high order address bits beyond the address from the host system. The default bank address is zero. Commands are provided to load and read the bank address register. These devices may also be configured to take a 4-byte address from the host system with the traditional 3-byte address commands. The 4-byte address mode for traditional commands is activated by setting the External Address (EXTADD) bit in the bank address register to 1.

The Quad I/O commands provide a performance improvement option controlled by mode bits that are sent following the address bits. The mode bits indicate whether the command following the end of the current read will be another read of the same type, without an instruction at the beginning of the read. These mode bits give the option to eliminate the instruction cycles when doing a series of Quad I/O read accesses.

A device ordering option provides an enhanced high performance option by adding a similar mode bit scheme to the DDR Fast Read, Dual I/O, and Dual I/O DDR commands, in addition to the Quad I/O command.

Some commands require delay cycles following the address or mode bits to allow time to access the memory array. The delay cycles are traditionally called dummy cycles. The dummy cycles are ignored by the memory thus any data provided by the host during these cycles is “don’t care” and the host may also leave the SI signal at high impedance during the dummy cycles. When MIO commands are used the host must stop driving the I/O signals (outputs are high impedance) before the end of last dummy cycle. When DDR commands are used the host must not drive the I/O signals during any dummy cycle. The number of dummy cycles varies with the SCK frequency or performance option selected via the Configuration Register 1 (CR1) Latency Code (LC). Dummy cycles are measured from SCK falling edge to next SCK falling edge. SPI outputs are traditionally driven to a new value on the falling edge of each SCK. Zero dummy cycles means the returning data is driven by the memory on the same falling edge of SCK that the host stops driving address or mode bits.

The DDR commands may optionally have an 8-edge Data Learning Pattern (DLP) driven by the memory, on all data outputs, in the dummy cycles immediately before the start of data. The DLP can help the host memory controller determine the phase shift from SCK to data edges so that the memory controller can capture data at the center of the data eye.

When using SDR I/O commands at higher SCK frequencies (>50 MHz), an LC that provides 1 or more dummy cycles should be selected to allow additional time for the host to stop driving before the memory starts driving data, to minimize I/O driver conflict. When using DDR I/O commands with the DLP enabled, an LC that provides 5 or more dummy cycles should be selected to allow 1 cycle of additional time for the host to stop driving before the memory starts driving the 4 cycle DLP.

Each read command ends when CS# is returned High at any point during data return. CS# must not be returned High during the mode or dummy cycles before data returns as this may cause mode bits to be captured incorrectly; making it indeterminate as to whether the device remains in enhanced high performance read mode.

9.4.1 Read (Read 03h or 4READ 13h)

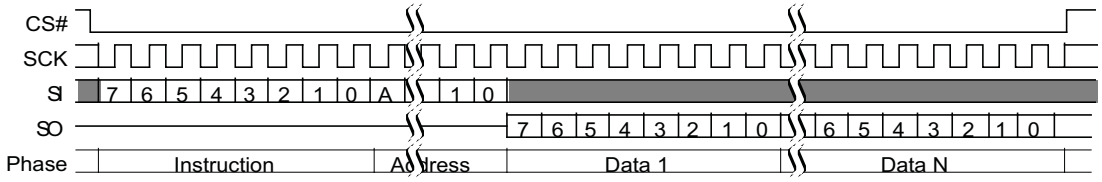
The instruction

- 03h (ExtAdd=0) is followed by a 3-byte address (A23-A0) or
- 03h (ExtAdd=1) is followed by a 4-byte address (A31-A0) or
- 13h is followed by a 4-byte address (A31-A0)

Then the memory contents, at the address given, are shifted out on SO. The maximum operating clock frequency for the READ command is 50 MHz.

The address can start at any byte location of the memory array. The address is automatically incremented to the next higher address in sequential order after each byte of data is shifted out. The entire memory can therefore be read out with one single read instruction and address 000000h provided. When the highest address is reached, the address counter will wrap around and roll back to 000000h, allowing the read sequence to be continued indefinitely.

Figure 70. Read Command Sequence (READ 03h or 13h)



9.4.2 Fast Read (FAST_READ 0Bh or 4FAST_READ 0Ch)

The instruction

- 0Bh (ExtAdd=0) is followed by a 3-byte address (A23-A0) or
- 0Bh (ExtAdd=1) is followed by a 4-byte address (A31-A0) or
- 0Ch is followed by a 4-byte address (A31-A0)

The address is followed by zero or eight dummy cycles depending on the latency code set in the Configuration Register. The dummy cycles allow the device internal circuits additional time for accessing the initial address location. During the dummy cycles the data value on SO is “don’t care” and may be high impedance. Then the memory contents, at the address given, are shifted out on SO.

The maximum operating clock frequency for FAST READ command is 133 MHz.

The address can start at any byte location of the memory array. The address is automatically incremented to the next higher address in sequential order after each byte of data is shifted out. The entire memory can therefore be read out with one single read instruction and address 000000h provided. When the highest address is reached, the address counter will wrap around and roll back to 000000h, allowing the read sequence to be continued indefinitely.

Figure 71. Fast Read (FAST_READ 0Bh or 0Ch) Command Sequence with Read Latency

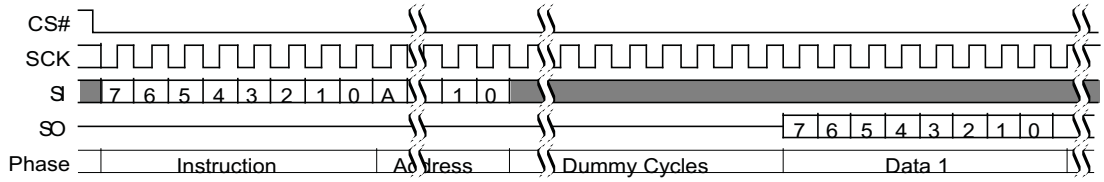
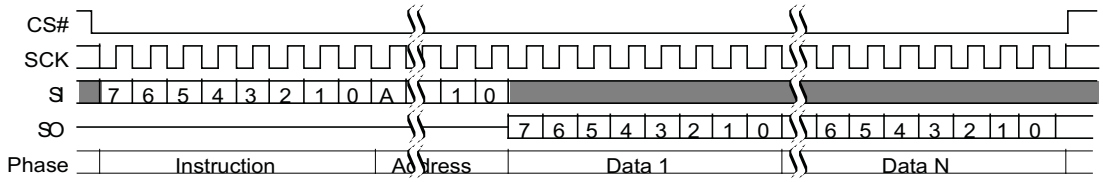


Figure 72. Fast Read Command (FAST_READ 0Bh or 0Ch) Sequence without Read Latency



9.4.3 Dual Output Read (DOR 3Bh or 4DOR 3Ch)

The instruction

- 3Bh (ExtAdd=0) is followed by a 3-byte address (A23-A0) or
- 3Bh (ExtAdd=1) is followed by a 4-byte address (A31-A0) or
- 3Ch is followed by a 4-byte address (A31-A0)

Then the memory contents, at the address given, is shifted out two bits at a time through I/O0 (SI) and I/O1 (SO). Two bits are shifted out at the SCK frequency by the falling edge of the SCK signal.

The maximum operating clock frequency for the Dual Output Read command is 104 MHz. For Dual Output Read commands, there are zero or eight dummy cycles required after the last address bit is shifted into SI before data begins shifting out of I/O0 and I/O1. This latency period (i.e., dummy cycles) allows the device's internal circuitry enough time to read from the initial address. During the dummy cycles, the data value on SI is a "don't care" and may be high impedance. The number of dummy cycles is determined by the frequency of SCK (refer to Table 22 on page 52).

The address can start at any byte location of the memory array. The address is automatically incremented to the next higher address in sequential order after each byte of data is shifted out. The entire memory can therefore be read out with one single read instruction and address 000000h provided. When the highest address is reached, the address counter will wrap around and roll back to 000000h, allowing the read sequence to be continued indefinitely.

Figure 73. Dual Output Read Command Sequence (3-Byte Address, 3Bh [ExtAdd=0], LC=10b)

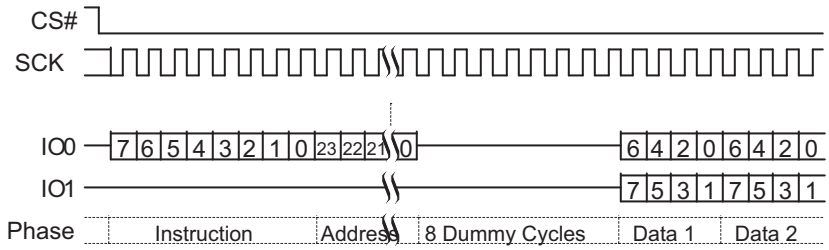


Figure 74. Dual Output Read Command Sequence (4-Byte Address, 3Ch or 3Bh [ExtAdd=1, LC=10b])

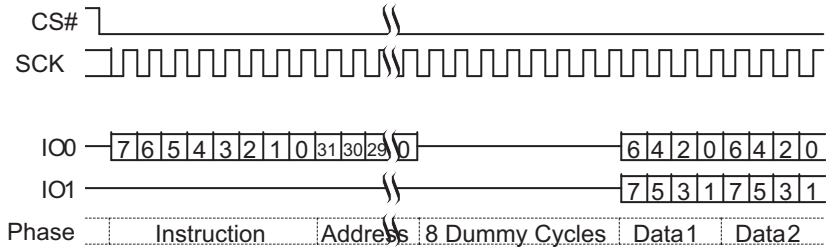
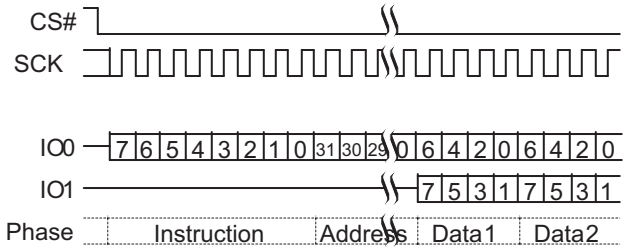


Figure 75. Dual Output Read Command Sequence (4-Byte Address, 3Ch or 3Bh [ExtAdd=1, LC=11b])



9.4.4 Quad Output Read (QOR 6Bh or 4QOR 6Ch)

The instruction

- 6Bh (ExtAdd=0) is followed by a 3-byte address (A23-A0) or
- 6Bh (ExtAdd=1) is followed by a 4-byte address (A31-A0) or
- 6Ch is followed by a 4-byte address (A31-A0)

Then the memory contents, at the address given, is shifted out four bits at a time through I/O0-I/O3. Each nibble (4 bits) is shifted out at the SCK frequency by the falling edge of the SCK signal.

The maximum operating clock frequency for Quad Output Read command is 104 MHz. For Quad Output Read Mode, there may be dummy cycles required after the last address bit is shifted into SI before data begins shifting out of I/O0-I/O3. This latency period (i.e., dummy cycles) allows the device's internal circuitry enough time to set up for the initial address. During the dummy cycles, the data value on I/O0-I/O3 is a "don't care" and may be high impedance. The number of dummy cycles is determined by the frequency of SCK (refer to Table 22 on page 52).

The address can start at any byte location of the memory array. The address is automatically incremented to the next higher address in sequential order after each byte of data is shifted out. The entire memory can therefore be read out with one single read instruction and address 000000h provided. When the highest address is reached, the address counter will wrap around and roll back to 000000h, allowing the read sequence to be continued indefinitely.

The QUAD bit of Configuration Register must be set (CR Bit1=1) to enable the Quad mode capability.

Figure 76. Quad Output Read (QOR 6Bh or 4QOR 6Ch) Command Sequence with Read Latency

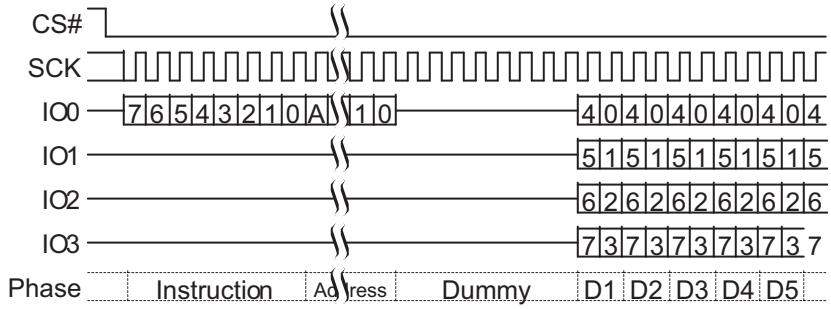
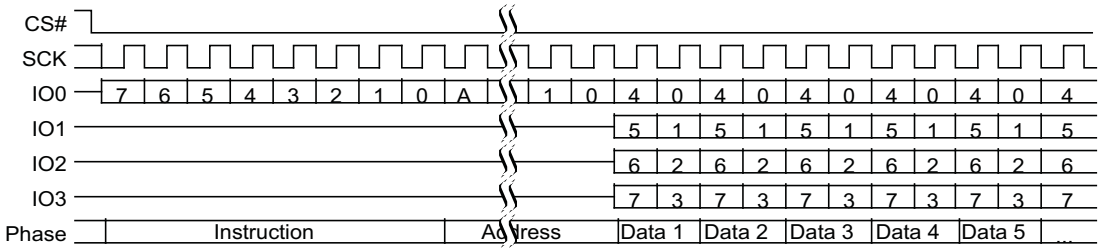


Figure 77. Quad Output Read (QOR 6Bh or 4QOR 6Ch) Command Sequence without Read Latency



9.4.5 Dual I/O Read (DIOR BBh or 4DIOR BCh)

The instruction

- BBh (ExtAdd=0) is followed by a 3-byte address (A23-A0) or
- BBh (ExtAdd=1) is followed by a 4-byte address (A31-A0) or
- BCh is followed by a 4-byte address (A31-A0)

The Dual I/O Read commands improve throughput with two I/O signals — I/O0 (SI) and I/O1 (SO). It is similar to the Dual Output Read command but takes input of the address two bits per SCK rising edge. In some applications, the reduced address input time might allow for code execution in place (XIP) i.e. directly from the memory device.

The maximum operating clock frequency for Dual I/O Read is 104 MHz.

For the Dual I/O Read command, there is a latency required after the last address bits are shifted into SI and SO before data begins shifting out of I/O0 and I/O1. There are different ordering part numbers that select the latency code table used for this command, either the High Performance LC (HPLC) table or the Enhanced High Performance LC (EHPLC) table. The HPLC table does not provide cycles for mode bits so each Dual I/O Read command starts with the 8 bit instruction, followed by address, followed by a latency period.

This latency period (dummy cycles) allows the device internal circuitry enough time to access data at the initial address. During the dummy cycles, the data value on SI and SO are “don’t care” and may be high impedance. The number of dummy cycles is determined by the frequency of SCK (Table 22 on page 52). The number of dummy cycles is set by the LC bits in the Configuration Register (CR1).

The EHPLC table does provide cycles for mode bits so a series of Dual I/O Read commands may eliminate the 8-bit instruction after the first Dual I/O Read command sends a mode bit pattern of Axh that indicates the following command will also be a Dual I/O Read command. The first Dual I/O Read command in a series starts with the 8-bit instruction, followed by address, followed by four cycles of mode bits, followed by a latency period. If the mode bit pattern is Axh the next command is assumed to be an additional Dual I/O Read command that does not provide instruction bits. That command starts with address, followed by mode bits, followed by latency.

The Enhanced High Performance feature removes the need for the instruction sequence and greatly improves code execution (XIP). The upper nibble (bits 7-4) of the Mode bits control the length of the next Dual I/O Read command through the inclusion or exclusion of the first byte instruction code. The lower nibble (bits 3-0) of the Mode bits are “don’t care” (“x”) and may be high impedance. If the Mode bits equal Axh, then the device remains in Dual I/O Enhanced High Performance Read Mode and the next address can be entered (after CS# is raised high and then asserted low) without the BBh or BCh instruction, as shown in Figure 81; thus, eliminating eight cycles for the command sequence. The following sequences will release the device from Dual I/O Enhanced High Performance Read mode; after which, the device can accept standard SPI commands:

1. During the Dual I/O Enhanced High Performance Command Sequence, if the Mode bits are any value other than Axh, then the next time CS# is raised high the device will be released from Dual I/O Read Enhanced High Performance Read mode.

During any operation, if CS# toggles high to low to high for eight cycles (or less) and data input (I/O0 and I/O1) are not set for a valid instruction sequence, then the device will be released from Dual I/O Enhanced High Performance Read mode. Note that the four mode bit cycles are part of the device’s internal circuitry latency time to access the initial address after the last address cycle that is clocked into I/O0 (SI) and I/O1 (SO).

It is important that the I/O signals be set to high-impedance at or before the falling edge of the first data out clock. At higher clock speeds the time available to turn off the host outputs before the memory device begins to drive (bus turn around) is diminished. It is allowed and may be helpful in preventing I/O signal contention, for the host system to turn off the I/O signal outputs (make them high impedance) during the last two “don’t care” mode cycles or during any dummy cycles.

Following the latency period the memory content, at the address given, is shifted out two bits at a time through I/O0 (SI) and I/O1 (SO). Two bits are shifted out at the SCK frequency at the falling edge of SCK signal.

The address can start at any byte location of the memory array. The address is automatically incremented to the next higher address in sequential order after each byte of data is shifted out. The entire memory can therefore be read out with one single read instruction and address 000000h provided. When the highest address is reached, the address counter will wrap around and roll back to 000000h, allowing the read sequence to be continued indefinitely.

CS# should not be driven high during mode or dummy bits as this may make the mode bits indeterminate.

Figure 78. Dual I/O Read Command Sequence (3-Byte Address, BBh [ExtAdd=0], HPLC=00b)

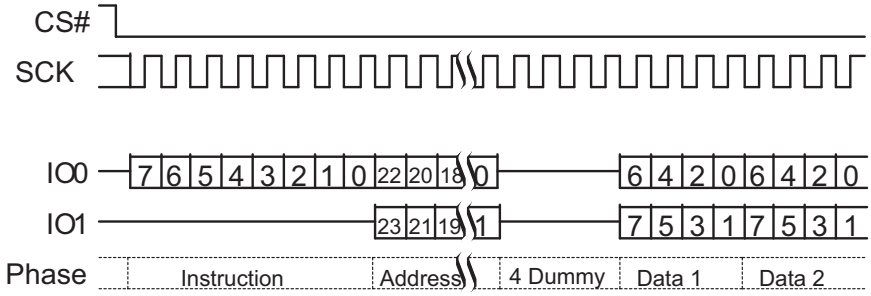


Figure 79. Dual I/O Read Command Sequence (4-Byte Address, BBh [ExtAdd=1], HPLC=10b)

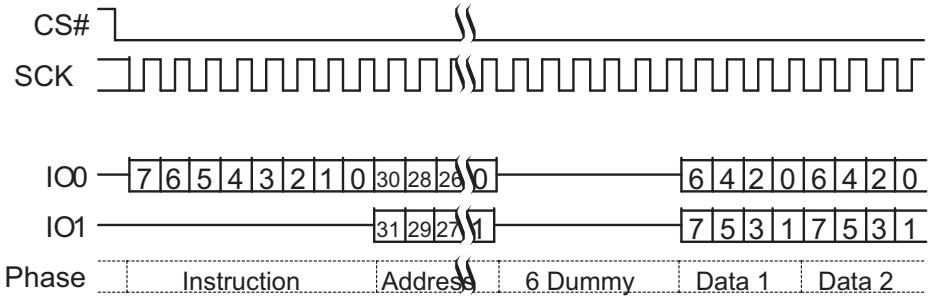


Figure 80. Dual I/O Read Command Sequence (4-Byte Address, BCh or BBh [ExtAdd=1], EHPLC=10b)

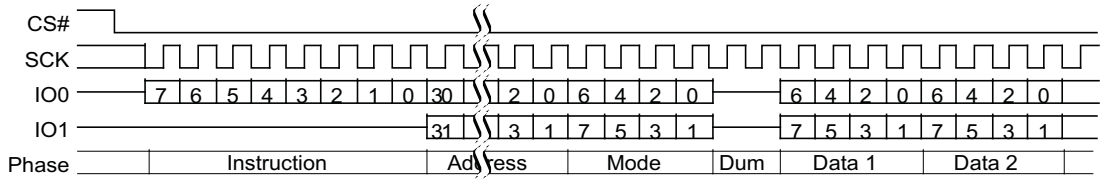
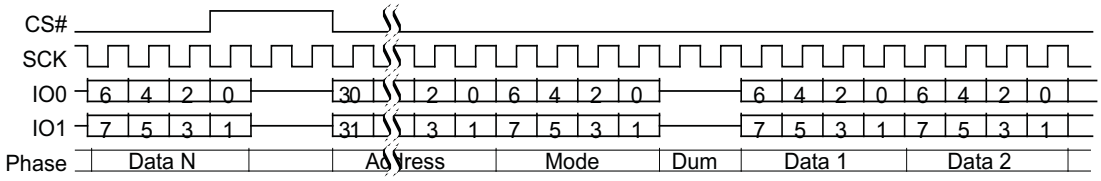


Figure 81. Continuous Dual I/O Read Command Sequence (4-Byte Address, BCh or BBh [ExtAdd=1], EHPLC=10b)



9.4.6 Quad I/O Read (QIOR EBh or 4QIOR ECh)

The instruction

- EBh (ExtAdd=0) is followed by a 3-byte address (A23-A0) or
- EBh (ExtAdd=1) is followed by a 4-byte address (A31-A0) or
- ECh is followed by a 4-byte address (A31-A0)

The Quad I/O Read command improves throughput with four I/O signals — I/O0-I/O3. It is similar to the Quad Output Read command but allows input of the address bits four bits per serial SCK clock. In some applications, the reduced instruction overhead might allow for code execution (XIP) directly from the S25FL512S device. The QUAD bit of the Configuration Register must be set (CR Bit1=1) to enable the Quad capability of the S25FL512S device.

The maximum operating clock frequency for Quad I/O Read is 104 MHz.

For the Quad I/O Read command, there is a latency required after the mode bits (described below) before data begins shifting out of I/O0-I/O3. This latency period (i.e., dummy cycles) allows the device's internal circuitry enough time to access data at the initial address. During latency cycles, the data value on I/O0-I/O3 are "don't care" and may be high impedance. The number of dummy cycles is determined by the frequency of SCK and the latency code table (refer to Table 22 on page 52). There are different ordering part numbers that select the latency code table used for this command, either the High Performance LC (HPLC) table or the Enhanced High Performance LC (EHPLC) table. The number of dummy cycles is set by the LC bits in the Configuration Register (CR1). However, both latency code tables use the same latency values for the Quad I/O Read command.

Following the latency period, the memory contents at the address given, is shifted out four bits at a time through I/O0-I/O3. Each nibble (4 bits) is shifted out at the SCK frequency by the falling edge of the SCK signal.

The address can start at any byte location of the memory array. The address is automatically incremented to the next higher address in sequential order after each byte of data is shifted out. The entire memory can therefore be read out with one single read instruction and address 000000h provided. When the highest address is reached, the address counter will wrap around and roll back to 000000h, allowing the read sequence to be continued indefinitely.

Address jumps can be done without the need for additional Quad I/O Read instructions. This is controlled through the setting of the Mode bits (after the address sequence, as shown in Figure 82 on page 89 or Figure 84 on page 89). This added feature removes the need for the instruction sequence and greatly improves code execution (XIP). The upper nibble (bits 7-4) of the Mode bits control the length of the next Quad I/O instruction through the inclusion or exclusion of the first byte instruction code. The lower nibble (bits 3-0) of the Mode bits are "don't care" ("x"). If the Mode bits equal Axh, then the device remains in Quad I/O High Performance Read Mode and the next address can be entered (after CS# is raised high and then asserted low) without requiring the EBh or ECh instruction, as shown in Figure 83 on page 89 or Figure 85 on page 89; thus, eliminating eight cycles for the command sequence. The following sequences will release the device from Quad I/O High Performance Read mode; after which, the device can accept standard SPI commands:

1. During the Quad I/O Read Command Sequence, if the Mode bits are any value other than Axh, then the next time CS# is raised high the device will be released from Quad I/O High Performance Read mode.

During any operation, if CS# toggles high to low to high for eight cycles (or less) and data input (I/O0-I/O3) are not set for a valid instruction sequence, then the device will be released from Quad I/O High Performance Read mode. Note that the two mode bit clock cycles and additional wait states (i.e., dummy cycles) allow the device's internal circuitry latency time to access the initial address after the last address cycle that is clocked into I/O0-I/O3.

It is important that the I/O0-I/O3 signals be set to high-impedance at or before the falling edge of the first data out clock. At higher clock speeds the time available to turn off the host outputs before the memory device begins to drive (bus turn around) is diminished. It is allowed and may be helpful in preventing I/O0-I/O3 signal contention, for the host system to turn off the I/O0-I/O3 signal outputs (make them high impedance) during the last "don't care" mode cycle or during any dummy cycles.

CS# should not be driven high during mode or dummy bits as this may make the mode bits indeterminate.

Figure 82. Quad I/O Read Command Sequence (3-Byte Address, EBh [ExtAdd=0], LC=00b)

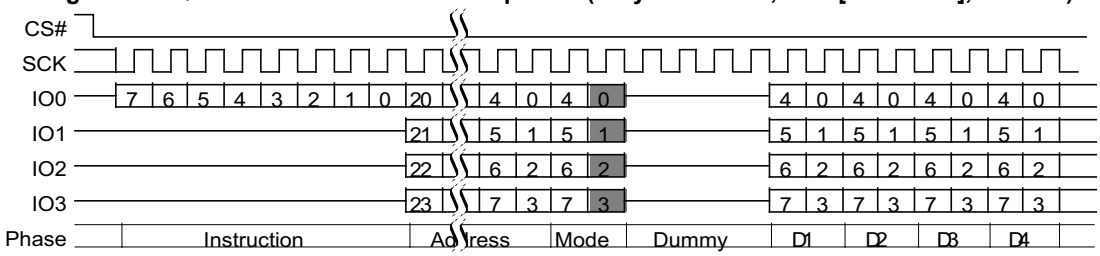


Figure 83. Continuous Quad I/O Read Command Sequence (3-Byte Address), LC=00b

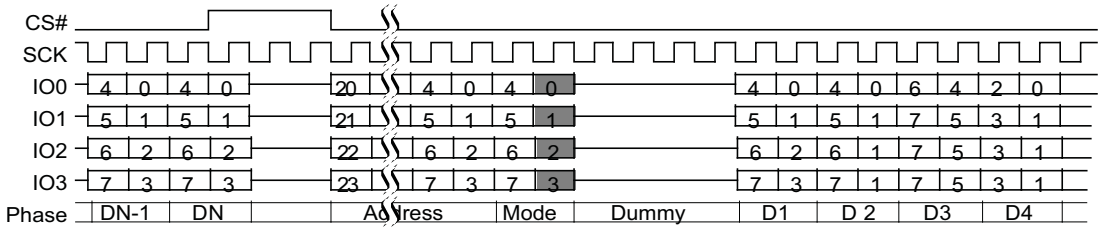


Figure 84. Quad I/O Read Command Sequence(4-Byte Address, ECh or EBh [ExtAdd=1], LC=00b)

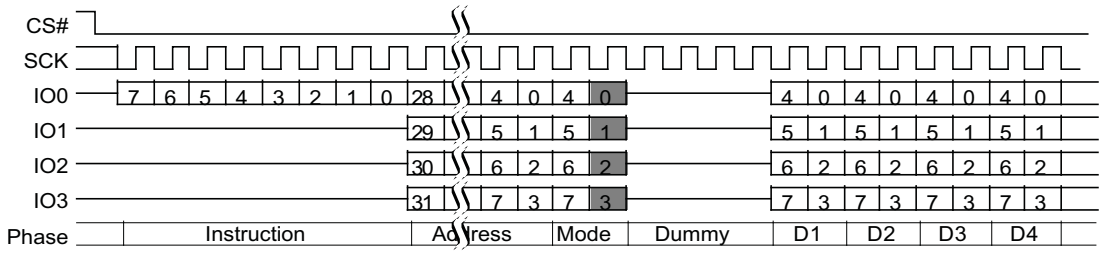
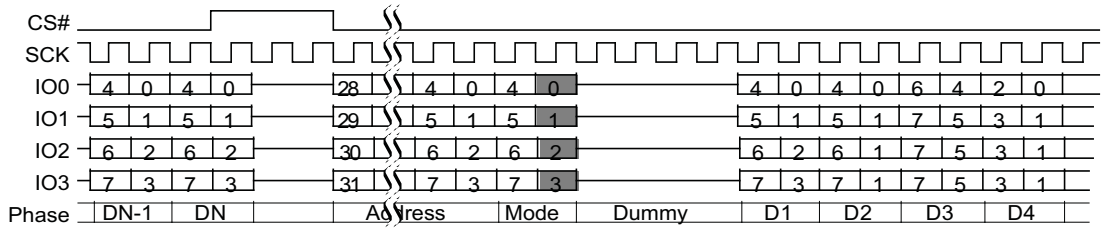


Figure 85. Continuous Quad I/O Read Command Sequence (4-Byte Address), LC=00b



9.4.7 DDR Fast Read (DDRFR 0Dh, 4DDRFR 0Eh)

The instruction

- 0Dh (ExtAdd=0) is followed by a 3-byte address (A23-A0) or
- 0Dh (ExtAdd=1) is followed by a 4-byte address (A31-A0) or
- 0Eh is followed by a 4-byte address (A31-A0)

The DDR Fast Read command improves throughput by transferring address and data on both the falling and rising edge of SCK. It is similar to the Fast Read command but allows transfer of address and data on every edge of the clock.

The maximum operating clock frequency for DDR Fast Read command is 80 MHz.

For the DDR Fast Read command, there is a latency required after the last address bits are shifted into SI before data begins shifting out of SO. There are different ordering part numbers that select the latency code table used for this command, either the High Performance LC (HPLC) table or the Enhanced High Performance LC (EHPLC) table. The HPLC table does not provide cycles for mode bits so each DDR Fast Read command starts with the 8-bit instruction, followed by address, followed by a latency period.

This latency period (dummy cycles) allows the device internal circuitry enough time to access data at the initial address. During the dummy cycles, the data value on SI is “don’t care” and may be high impedance. The number of dummy cycles is determined by the frequency of SCK (Table 22 on page 52). The number of dummy cycles is set by the LC bits in the Configuration Register (CR1).

Then the memory contents, at the address given, is shifted out, in DDR fashion, one bit at a time on each clock edge through SO. Each bit is shifted out at the SCK frequency by the rising and falling edge of the SCK signal.

The address can start at any byte location of the memory array. The address is automatically incremented to the next higher address in sequential order after each byte of data is shifted out. The entire memory can therefore be read out with one single read instruction and address 000000h provided. When the highest address is reached, the address counter will wrap around and roll back to 000000h, allowing the read sequence to be continued indefinitely.

The EHPLC table does provide cycles for mode bits so a series of DDR Fast Read commands may eliminate the 8-bit instruction after the first DDR Fast Read command sends a mode bit pattern of complementary first and second Nibbles, e.g. A5h, 5Ah, 0Fh, etc., that indicates the following command will also be a DDR Fast Read command. The first DDR Fast Read command in a series starts with the 8-bit instruction, followed by address, followed by four cycles of mode bits, followed by a latency period. If the mode bit pattern is complementary the next command is assumed to be an additional DDR Fast Read command that does not provide instruction bits. That command starts with address, followed by mode bits, followed by latency.

When the EHPLC table is used, address jumps can be done without the need for additional DDR Fast Read instructions. This is controlled through the setting of the Mode bits (after the address sequence, as shown in Figure 86 on page 91 and Figure 88 on page 91. This added feature removes the need for the eight bit SDR instruction sequence to reduce initial access time (improves XIP performance). The Mode bits control the length of the next DDR Fast Read operation through the inclusion or exclusion of the first byte instruction code. If the upper nibble (I/O[7:4]) and lower nibble (I/O[3:0]) of the Mode bits are complementary (i.e. 5h and Ah) then the next address can be entered (after CS# is raised high and then asserted low) without requiring the 0Dh or 0Eh instruction, as shown in Figure 87 and Figure 89, thus, eliminating eight cycles from the command sequence. The following sequences will release the device from this continuous DDR Fast Read mode; after which, the device can accept standard SPI commands:

1. During the DDR Fast Read Command Sequence, if the Mode bits are not complementary the next time CS# is raised high the device will be released from the continuous DDR Fast Read mode.
2. During any operation, if CS# toggles high to low to high for eight cycles (or less) and data input (SI) are not set for a valid instruction sequence, then the device will be released from DDR Fast Read mode.

CS# should not be driven high during mode or dummy bits as this may make the mode bits indeterminate.

The HOLD function is not valid during any part of a Fast DDR Command.

Although the data learning pattern (DLP) is programmable, the following example shows example of the DLP of 34h. The DLP 34h (or 00110100) will be driven on each of the active outputs (i.e. all four I/Os on a x4 device, both I/Os on a x2 device and the single SO output on a x1 device). This pattern was chosen to cover both DC and AC data transition scenarios. The two DC transition scenarios include data low for a long period of time (two half clocks) followed by a high going transition (001) and the complementary low going transition (110). The two AC transition scenarios include data low for a short period of time (one half clock) followed by a high going transition (101) and the complementary low going transition (010). The DC transitions will typically occur with a starting point closer to the supply rail than the AC transitions that may not have fully settled to their steady state (DC) levels. In many cases the DC transitions will bound the beginning of the data valid period and the AC transitions will bound the ending of the data valid period. These transitions will allow the host controller to identify the beginning and ending of the valid data eye. Once the data eye has been characterized the optimal data capture point can be chosen. See SPI DDR Data Learning Registers on page 57 for more details.

Figure 86. DDR Fast Read Initial Access (3-Byte Address, 0Dh [ExtAdd=0, EHPLC=11b])

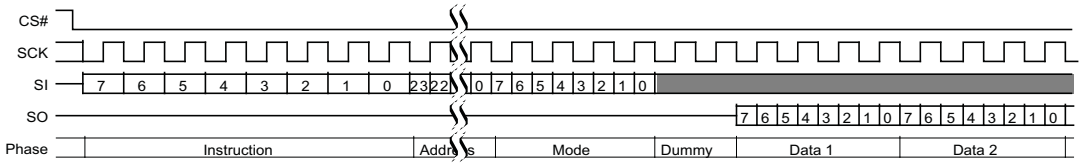


Figure 87. Continuous DDR Fast Read Subsequent Access (3-Byte Address [ExtAdd=0, EHPLC=11b])

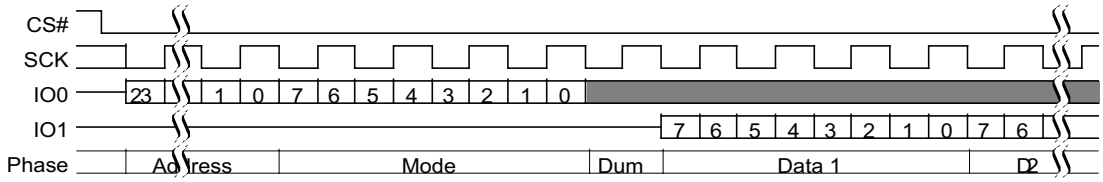
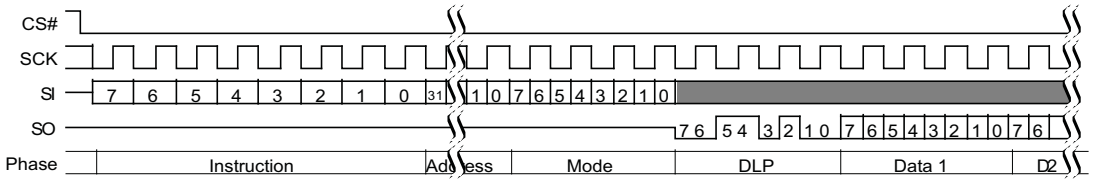
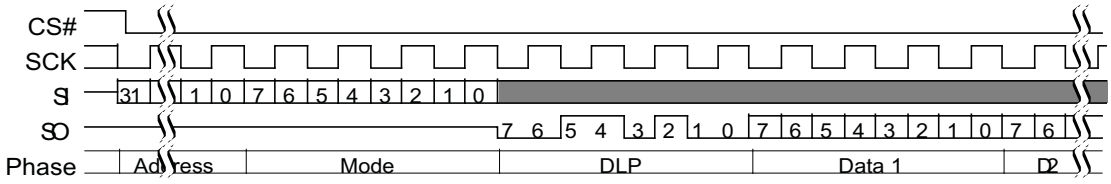


Figure 88. DDR Fast Read Initial Access (4-Byte Address, 0Eh or 0Dh [ExtAdd=1], EHPLC=01b)



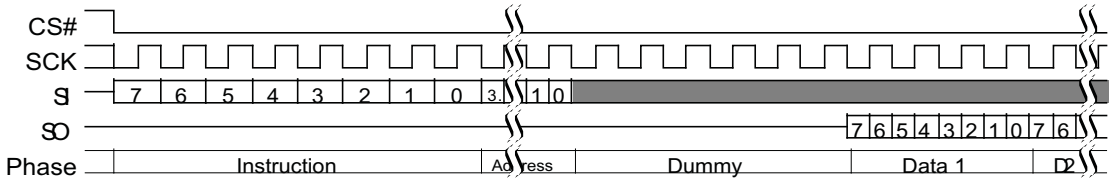
Note
1. Example DLP of 34h (or 00110100).

Figure 89. Continuous DDR Fast Read Subsequent Access (4-Byte Address [ExtAdd=1], EHPLC=01b)



Note
1. Example DLP of 34h (or 00110100).

Figure 90. DDR Fast Read Subsequent Access (4-Byte Address, HPLC=01b)



9.4.8 DDR Dual I/O Read (BDh, BEh)

The instruction

- BDh (ExtAdd=0) is followed by a 3-byte address (A23-A0) or
- BDh (ExtAdd=1) is followed by a 4-byte address (A31-A0) or
- BEh is followed by a 4-byte address (A31-A0)

Then the memory contents, at the address given, is shifted out, in a DDR fashion, two bits at a time on each clock edge through I/O0 (SI) and I/O1 (SO). Two bits are shifted out at the SCK frequency by the rising and falling edge of the SCK signal.

The DDR Dual I/O Read command improves throughput with two I/O signals — I/O0 (SI) and I/O1 (SO). It is similar to the Dual I/O Read command but transfers two address, mode, or data bits on every edge of the clock. In some applications, the reduced instruction overhead might allow for code execution (XIP) directly from the S25FL512S device.

The maximum operating clock frequency for DDR Dual I/O Read command is 80 MHz.

For DDR Dual I/O Read commands, there is a latency required after the last address bits are shifted into I/O0 and I/O1, before data begins shifting out of I/O0 and I/O1. There are different ordering part numbers that select the latency code table used for this command, either the High Performance LC (HPLC) table or the Enhanced High Performance LC (EHPLC) table. The number of latency (dummy) clocks is determined by the frequency of SCK (refer to Table 21 on page 51 or Table 23 on page 52). The number of dummy cycles is set by the LC bits in the Configuration Register (CR1).

The HPLC table does not provide cycles for mode bits so each Dual I/O command starts with the 8 bit instruction, followed by address, followed by a latency period. This latency period allows the device's internal circuitry enough time to access the initial address. During these latency cycles, the data value on SI (I/O0) and SO (I/O1) are "don't care" and may be high impedance. When the Data Learning Pattern (DLP) is enabled the host system must not drive the I/O signals during the dummy cycles. The I/O signals must be left high impedance by the host so that the memory device can drive the DLP during the dummy cycles.

The EHPLC table does provide cycles for mode bits so a series of Dual I/O DDR commands may eliminate the 8 bit instruction after the first command sends a complementary mode bit pattern, as shown in Figure 91 and Figure 93 on page 93. This added feature removes the need for the eight bit SDR instruction sequence and dramatically reduces initial access times (improves XIP performance). The Mode bits control the length of the next DDR Dual I/O Read operation through the inclusion or exclusion of the first byte instruction code. If the upper nibble (I/O[7:4]) and lower nibble (I/O[3:0]) of the Mode bits are complementary (i.e. 5h and Ah) the device transitions to Continuous DDR Dual I/O Read Mode and the next address can be entered (after CS# is raised high and then asserted low) without requiring the BDh or BEh instruction, as shown in Figure 92 on page 93, and thus, eliminating eight cycles from the command sequence. The following sequences will release the device from Continuous DDR Dual I/O Read mode; after which, the device can accept standard SPI commands:

1. During the DDR Dual I/O Read Command Sequence, if the Mode bits are not complementary the next time CS# is raised high and then asserted low the device will be released from DDR Dual I/O Read mode.
2. During any operation, if CS# toggles high to low to high for eight cycles (or less) and data input (I/O0 and I/O1) are not set for a valid instruction sequence, then the device will be released from DDR Dual I/O Read mode.

The address can start at any byte location of the memory array. The address is automatically incremented to the next higher address in sequential order after each byte of data is shifted out. The entire memory can therefore be read out with one single read instruction and address 000000h provided. When the highest address is reached, the address counter will wrap around and roll back to 000000h, allowing the read sequence to be continued indefinitely.

CS# should not be driven high during mode or dummy bits as this may make the mode bits indeterminate. The HOLD function is not valid during Dual I/O DDR commands.

Note that the memory devices may drive the I/Os with a preamble prior to the first data value. The preamble is a data learning pattern (DLP) that is used by the host controller to optimize data capture at higher frequencies. The preamble DLP drives the I/O bus for the four clock cycles immediately before data is output. The host must be sure to stop driving the I/O bus prior to the time that the memory starts outputting the preamble.

The preamble is intended to give the host controller an indication about the round trip time from when the host drives a clock edge to when the corresponding data value returns from the memory device. The host controller will skew the data capture point during the preamble period to optimize timing margins and then use the same skew time to capture the data during the rest of the read operation. The optimized capture point will be determined during the preamble period of every read operation. This optimization strategy is intended to compensate for both the PVT (process, voltage, temperature) of both the memory device and the host controller as well as any system level delays caused by flight time on the PCB.

Although the data learning pattern (DLP) is programmable, the following example shows example of the DLP of 34h. The DLP 34h (or 00110100) will be driven on each of the active outputs (i.e. all four SIOs on a x4 device, both SIOs on a x2 device and the single SO output on a x1 device). This pattern was chosen to cover both DC and AC data transition scenarios. The two DC transition scenarios include data low for a long period of time (two half clocks) followed by a high going transition (001) and the complementary low going transition (110). The two AC transition scenarios include data low for a short period of time (one half clock) followed by a high going transition (101) and the complementary low going transition (010). The DC transitions will typically occur with a starting point closer to the supply rail than the AC transitions that may not have fully settled to their steady state (DC) levels. In many cases the DC transitions will bound the beginning of the data valid period and the AC transitions will bound the ending of the data valid period. These transitions will allow the host controller to identify the beginning and ending of the valid data eye. Once the data eye has been characterized the optimal data capture point can be chosen. See SPI DDR Data Learning Registers on page 57 for more details.

Figure 91. DDR Dual I/O Read Initial Access (4-Byte Address, BEh or BDh [ExtAdd=1], EHPLC= 01b)

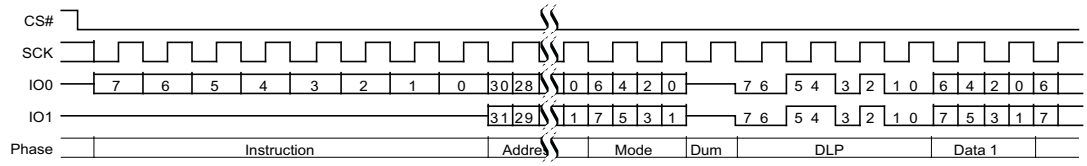


Figure 92. Continuous DDR Dual I/O Read Subsequent Access (4-Byte Address, EHPLC= 01b)

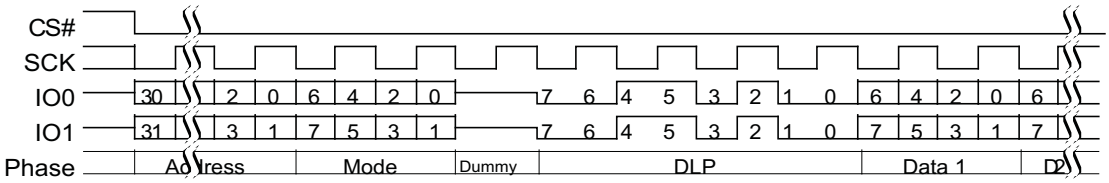
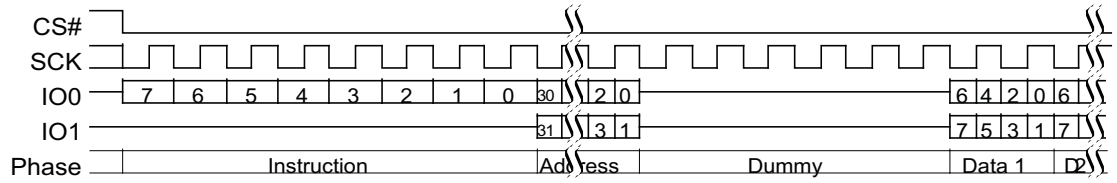


Figure 93. DDR Dual I/O Read (4-Byte Address, BEh or BDh [ExtAdd=1], HPLC=00b)



9.4.9 DDR Quad I/O Read (EDh, EEh)

The Read DDR Quad I/O command improves throughput with four I/O signals - I/O0-I/O3. It is similar to the Quad I/O Read command but allows input of the address four bits on every edge of the clock. In some applications, the reduced instruction overhead might allow for code execution (XIP) directly from the S25FL512S device. The QUAD bit of the Configuration Register must be set (CR Bit1=1) to enable the Quad capability.

The instruction

- EDh (ExtAdd=0) is followed by a 3-byte address (A23-A0) or
- EDh (ExtAdd=1) is followed by a 4-byte address (A31-A0) or
- EEh is followed by a 4-byte address (A31-A0)

The address is followed by mode bits. Then the memory contents, at the address given, is shifted out, in a DDR fashion, with four bits at a time on each clock edge through I/O0-I/O3.

The maximum operating clock frequency for Read DDR Quad I/O command is 80 MHz.

For Read DDR Quad I/O, there is a latency required after the last address and mode bits are shifted into the I/O0-I/O3 signals before data begins shifting out of I/O0-I/O3. This latency period (dummy cycles) allows the device's internal circuitry enough time to access the initial address. During these latency cycles, the data value on I/O0-I/O3 are "don't care" and may be high impedance. When the Data Learning Pattern (DLP) is enabled the host system must not drive the I/O signals during the dummy cycles. The I/O signals must be left high impedance by the host so that the memory device can drive the DLP during the dummy cycles.

There are different ordering part numbers that select the latency code table used for this command, either the High Performance LC (HPLC) table or the Enhanced High Performance LC (EHPLC) table. The number of dummy cycles is determined by the frequency of SCK (refer to Table 21 on page 51). The number of dummy cycles is set by the LC bits in the Configuration Register (CR1).

Both latency tables provide cycles for mode bits so a series of Quad I/O DDR commands may eliminate the 8 bit instruction after the first command sends a complementary mode bit pattern, as shown in Figure 94 and Figure 96. This feature removes the need for the eight bit SDR instruction sequence and dramatically reduces initial access times (improves XIP performance). The Mode bits control the length of the next Read DDR Quad I/O operation through the inclusion or exclusion of the first byte instruction code. If the upper nibble (I/O[7:4]) and lower nibble (I/O[3:0]) of the Mode bits are complementary (i.e. 5h and Ah) the device transitions to Continuous Read DDR Quad I/O Mode and the next address can be entered (after CS# is raised high and then asserted low) without requiring the EDh or EEh instruction, as shown in Figure 95 on page 95 and Figure 97 on page 95 thus, eliminating eight cycles from the command sequence. The following sequences will release the device from Continuous Read DDR Quad I/O mode; after which, the device can accept standard SPI commands:

1. During the Read DDR Quad I/O Command Sequence, if the Mode bits are not complementary the next time CS# is raised high and then asserted low the device will be released from Read DDR Quad I/O mode.
2. During any operation, if CS# toggles high to low to high for eight cycles (or less) and data input (I/O0, I/O1, I/O2, and I/O3) are not set for a valid instruction sequence, then the device will be released from Read DDR Quad I/O mode.

The address can start at any byte location of the memory array. The address is automatically incremented to the next higher address in sequential order after each byte of data is shifted out. The entire memory can therefore be read out with one single read instruction and address 000000h provided. When the highest address is reached, the address counter will wrap around and roll back to 000000h, allowing the read sequence to be continued indefinitely.

CS# should not be driven high during mode or dummy bits as this may make the mode bits indeterminate. The HOLD function is not valid during Quad I/O DDR commands.

Note that the memory devices drive the I/Os with a preamble prior to the first data value. The preamble is a pattern that is used by the host controller to optimize data capture at higher frequencies. The preamble drives the I/O bus for the four clock cycles immediately before data is output. The host must be sure to stop driving the I/O bus prior to the time that the memory starts outputting the preamble.

The preamble is intended to give the host controller an indication about the round trip time from when the host drives a clock edge to when the corresponding data value returns from the memory device. The host controller will skew the data capture point during the preamble period to optimize timing margins and then use the same skew time to capture the data during the rest of the read operation. The optimized capture point will be determined during the preamble period of every read operation. This optimization strategy is intended to compensate for both the PVT (process, voltage, temperature) of both the memory device and the host controller as well as any system level delays caused by flight time on the PCB.

Although the data learning pattern (DLP) is programmable, the following example shows example of the DLP of 34h. The DLP 34h (or 00110100) will be driven on each of the active outputs (i.e. all four SIOs on a x4 device, both SIOs on a x2 device and the single SO output on a x1 device). This pattern was chosen to cover both DC and AC data transition scenarios. The two DC transition scenarios include data low for a long period of time (two half clocks) followed by a high going transition (001) and the complementary low going transition (110). The two AC transition scenarios include data low for a short period of time (one half clock) followed by a high going transition (101) and the complementary low going transition (010). The DC transitions will typically occur with a starting point closer to the supply rail than the AC transitions that may not have fully settled to their steady state (DC) levels. In many cases the DC transitions will bound the beginning of the data valid period and the AC transitions will bound the ending of the data valid period. These transitions will allow the host controller to identify the beginning and ending of the valid data eye. Once the data eye has been characterized the optimal data capture point can be chosen. See SPI DDR Data Learning Registers on page 57 for more details.

Figure 94. DDR Quad I/O Read Initial Access (3-Byte Address, EDh [ExtAdd=0], HPLC=11b)

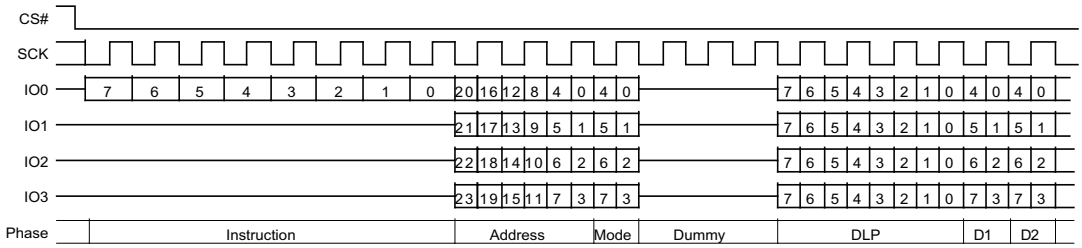


Figure 95. Continuous DDR Quad I/O Read Subsequent Access (3-Byte Address,HPLC=11b)

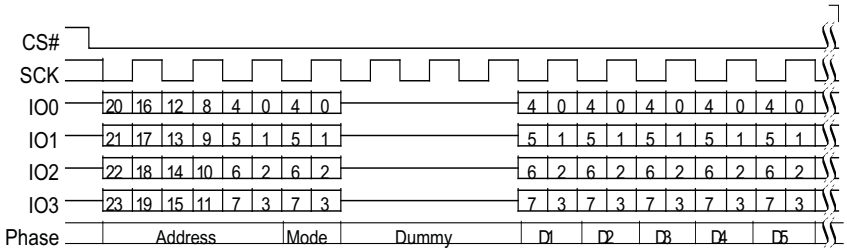
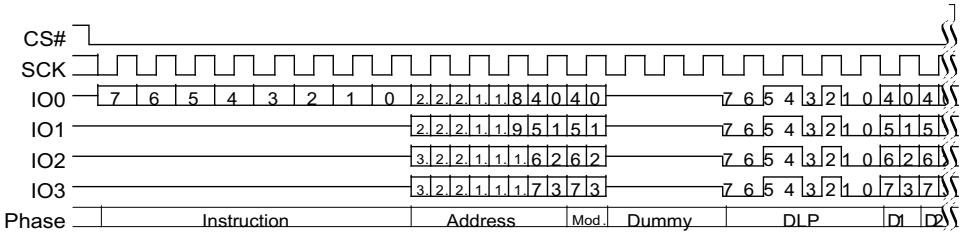
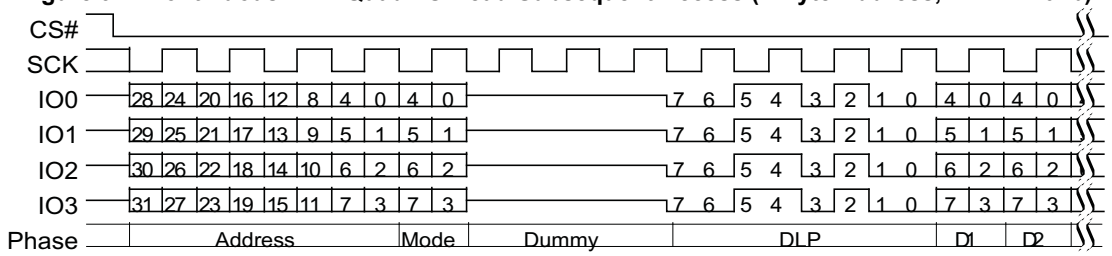


Figure 96. DDR Quad I/O Read Initial Access (4-Byte Address, EEh or EDh [ExtAdd=1], EHPLC=01b)



Note
1. Example DLP of 34h (or 00110100).

Figure 97. Continuous DDR Quad I/O Read Subsequent Access (4-Byte Address, EHPLC=01b)



Note
1. Example DLP of 34h (or 00110100).

9.5 Program Flash Array Commands

9.5.1 Program Granularity

9.5.1.1 Automatic ECC

Each 16 byte aligned and 16 byte length Programming Block has an automatic Error Correction Code (ECC) value. The data block plus ECC form an ECC unit. In combination with Error Detection and Correction (EDC) logic the ECC is used to detect and correct any single bit error found during a read access. When data is first programmed within an ECC unit the ECC value is set for the entire ECC unit. If the same ECC unit is programmed more than once the ECC value is changed to disable the EDC function. A sector erase is needed to again enable Automatic ECC on that Programming Block. The 16 byte Program Block is the smallest program granularity on which Automatic ECC is enabled.

These are automatic operations transparent to the user. The transparency of the Automatic ECC feature enhances data accuracy for typical programming operations which write data once to each ECC unit but, facilitates software compatibility to previous generations of FL family of products by allowing for single byte programming and bit walking in which the same ECC unit is programmed more than once. When an ECC unit has Automatic ECC disabled, EDC is not done on data read from the ECC unit location.

An ECC status register is provided for determining if ECC is enabled on an ECC unit and whether any errors have been detected and corrected in the ECC unit data or the ECC (See ECC Status Register (ECCSR) on page 54.) The ECC Status Register Read (ECCRD) command is used to read the ECC status on any ECC unit.

Error Detection and Correction (EDC) is applied to all parts of the Flash address spaces other than registers. An Error Correction Code (ECC) is calculated for each group of bytes protected and the ECC is stored in a hidden area related to the group of bytes. The group of protected bytes and the related ECC are together called an ECC unit.

ECC is calculated for each 16 byte aligned and length ECC unit.

- Single Bit EDC is supported with 8 ECC bits per ECC unit, plus 1 bit for an ECC disable Flag.
- Sector erase resets all ECC bits and ECC disable flags in a sector to the default state (enabled).
- ECC is programmed as part of the standard Program commands operation.
- ECC is disabled automatically if multiple programming operations are done on the same ECC unit.
- Single byte programming or bit walking is allowed but disables ECC on the second program to the same 16-byte ECC unit.
- The ECC disable flag is programmed when ECC is disabled.
- To re-enable ECC for an ECC unit that has been disabled, the Sector that includes the ECC unit must be erased.
- To ensure the best data integrity provided by EDC, each ECC unit should be programmed only once so that ECC is stored for that unit and not disabled.
- The calculation, programming, and disabling of ECC is done automatically as part of a programming operation. The detection and correction, if needed, is done automatically as part of read operations. The host system sees only corrected data from a read operation.
- ECC protects the OTP region - however a second program operation on the same ECC unit will disable ECC permanently on that ECC unit (OTP is one time programmable, hence an erase operation to re-enable the ECC enable/indicator bit is prohibited).

9.5.1.2 Page Programming

Page Programming is done by loading a Page Buffer with data to be programmed and issuing a programming command to move data from the buffer to the memory array. This sets an upper limit on the amount of data that can be programmed with a single programming command. Page Programming allows up to a page size (512 bytes) to be programmed in one operation. The page is aligned on the page size address boundary. It is possible to program from one bit up to a page size in each Page programming operation. It is recommended that a multiple of 16 byte length and aligned Program Blocks be written. For the very best performance, programming should be done in full pages of 512 bytes aligned on 512-byte boundaries with each Page being programmed only once.

9.5.1.3 Single Byte Programming

Single Byte Programming allows full backward compatibility to the standard SPI Page Programming (PP) command by allowing a single byte to be programmed anywhere in the memory array. While single byte programming is supported, this will disable Automatic ECC on the 16 byte ECC unit where the byte is located.

9.5.2 Page Program (PP 02h or 4PP 12h)

The Page Program (PP) commands allows bytes to be programmed in the memory (changing bits from 1 to 0). Before the Page Program (PP) commands can be accepted by the device, a Write Enable (WREN) command must be issued and decoded by the device. After the Write Enable (WREN) command has been decoded successfully, the device sets the Write Enable Latch (WEL) in the Status Register to enable any write operations.

The instruction

- 02h (ExtAdd=0) is followed by a 3-byte address (A23-A0) or
- 02h (ExtAdd=1) is followed by a 4-byte address (A31-A0) or
- 12h is followed by a 4-byte address (A31-A0)

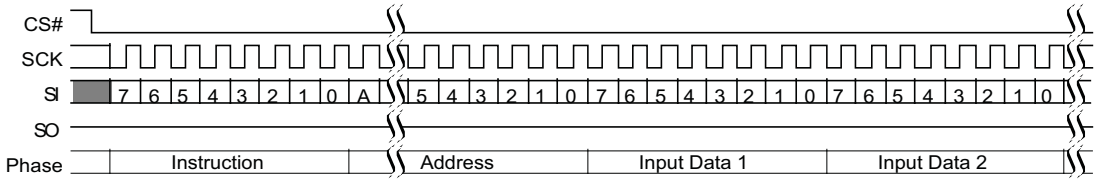
and at least one data byte on SI. Up to a page can be provided on SI after the 3-byte address with instruction 02h or 4-byte address with instruction 12h has been provided. If the 9 least significant address bits (A8-A0) are not all zero, all transmitted data that goes beyond the end of the current page are programmed from the start address of the same page (from the address whose 9 least significant bits (A8-A0) are all zero) i.e. the address wraps within the page aligned address boundaries. This is a result of only requiring the user to enter one single page address to cover the entire page boundary.

If less than a page of data is sent to the device, these data bytes will be programmed in sequence, starting at the provided address within the page, without having any affect on the other bytes of the same page.

For optimized timings, using the Page Program (PP) command to load the entire page size program buffer within the page boundary will save overall programming time versus loading less than a page size into the program buffer.

The programming process is managed by the flash memory device internal control logic. After a programming command is issued, the programming operation status can be checked using the Read Status Register-1 command. The WIP bit (SR1[0]) will indicate when the programming operation is completed. The P_ERR bit (SR1[6]) will indicate if an error occurs in the programming operation that prevents successful completion of programming.

Figure 98. Page Program (PP 02h or 4PP 12h) Command Sequence



9.5.3 Quad Page Program (QPP 32h or 38h, or 4QPP 34h)

The Quad-input Page Program (QPP) command allows bytes to be programmed in the memory (changing bits from 1 to 0). The Quad-input Page Program (QPP) command allows up to a page size (512 bytes) of data to be loaded into the Page Buffer using four signals: I/O0-I/O3. QPP can improve performance for PROM Programmer and applications that have slower clock speeds (< 12 MHz) by loading 4 bits of data per clock cycle. Systems with faster clock speeds do not realize as much benefit for the QPP command since the inherent page program time becomes greater than the time it takes to clock-in the data. The maximum frequency for the QPP command is 80 MHz.

To use Quad Page Program the Quad Enable Bit in the Configuration Register must be set (QUAD=1). A Write Enable command must be executed before the device will accept the QPP command (Status Register-1, WEL=1).

The instruction

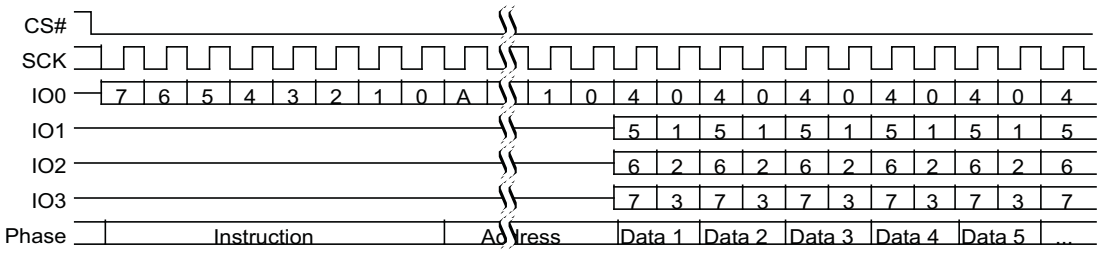
- 32h (ExtAdd=0) is followed by a 3-byte address (A23-A0) or
- 32h (ExtAdd=1) is followed by a 4-byte address (A31-A0) or
- 38h (ExtAdd=0) is followed by a 3-byte address (A23-A0) or
- 38h (ExtAdd=1) is followed by a 4-byte address (A31-A0) or
- 34h is followed by a 4-byte address (A31-A0)

and at least one data byte, into the I/O signals. Data must be programmed at the previously erased (FFh) memory locations.

Recommend the programming page is aligned on the page size address boundary. It is possible to program from one bit up to a page size in each Page programming operation. It is recommended that a multiple of 16 byte length and aligned Program Blocks be written. This insures that Automatic ECC is not disabled".

All other functions of QPP are identical to Page Program. The QPP command sequence is shown in the figure below.

Figure 99. Quad 512-byte Page Program Command Sequence



9.5.4 Program Suspend (PGSP 85h) and Resume (PGRS 8Ah)

The Program Suspend command allows the system to interrupt a programming operation and then read from any other non-erase-suspended sector or non-program-suspended-page. Program Suspend is valid only during a programming operation.

Commands allowed after the Program Suspend command is issued:

- Read Status Register 1 (RDSR1 05h)
- Read Status Register 2 (RDSR2 07h)

The Write in Progress (WIP) bit in Status Register 1 (SR1[0]) must be checked to know when the programming operation has stopped. The Program Suspend Status bit in the Status Register-2 (SR2[0]) can be used to determine if a programming operation has been suspended or was completed at the time WIP changes to 0. The time required for the suspend operation to complete is t_{PSL}, see Table 45 on page 110.

See Table 43 on page 102 for the commands allowed while programming is suspend.

The Program Resume command 8Ah must be written to resume the programming operation after a Program Suspend. If the programming operation was completed during the suspend operation, a resume command is not needed and has no effect if issued. Program Resume commands will be ignored unless a Program operation is suspended.

After a Program Resume command is issued, the WIP bit in the Status Register-1 will be set to a 1 and the programming operation will resume. Program operations may be interrupted as often as necessary e.g. a program suspend command could immediately follow a program resume command but, in order for a program operation to progress to completion there must be some periods of time between resume and the next suspend command greater than or equal to t_{PRS}. See Table 45 on page 110.

Figure 100. Program Suspend (PGSP 85h) Command Sequence

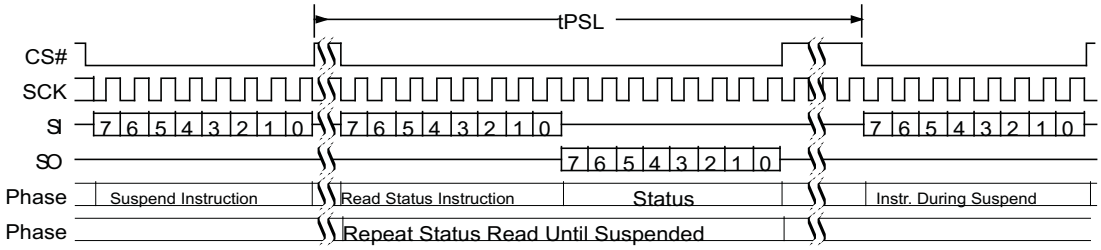
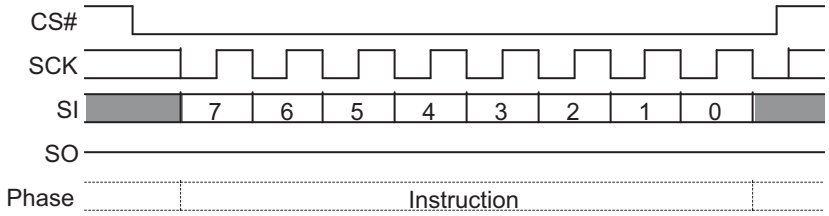


Figure 101. 10.55 Program Resume (PGRS 8Ah) Command Sequence



9.6 Erase Flash Array Commands

9.6.1 Sector Erase (SE D8h or 4SE DCh)

The Sector Erase (SE) command sets all bits in the addressed sector to 1 (all bytes are FFh). Before the Sector Erase (SE) command can be accepted by the device, a Write Enable (WREN) command must be issued and decoded by the device, which sets the Write Enable Latch (WEL) in the Status Register to enable any write operations.

The instruction

- D8h [ExtAdd=0] is followed by a 3-byte address (A23-A0), or
- D8h [ExtAdd=1] is followed by a 4-byte address (A31-A0), or
- DCh is followed by a 4-byte address (A31-A0)

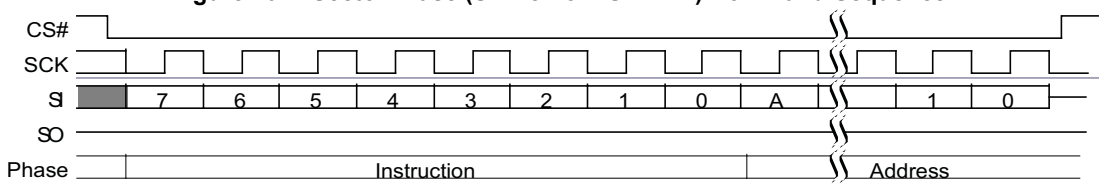
CS# must be driven into the logic high state after the twenty-fourth or thirty-second bit of address has been latched in on SI. This will initiate the erase cycle, which involves the pre-programming and erase of the chosen sector. If CS# is not driven high after the last bit of address, the sector erase operation will not be executed.

As soon as CS# is driven into the logic high state, the internal erase cycle will be initiated. With the internal erase cycle in progress, the user can read the value of the Write-In Progress (WIP) bit to check if the operation has been completed. The WIP bit will indicate a 1 when the erase cycle is in progress and a0 when the erase cycle has been completed.

A Sector Erase (SE) command applied to a sector that has been Write Protected through the Block Protection bits or ASP, will not be executed and will set the E_ERR status.

ASP has a PPB and a DYB protection bit for each sector.

Figure 102. Sector Erase (SE D8h or 4SE DCh) Command Sequence



9.6.2 Bulk Erase (BE 60h or C7h)

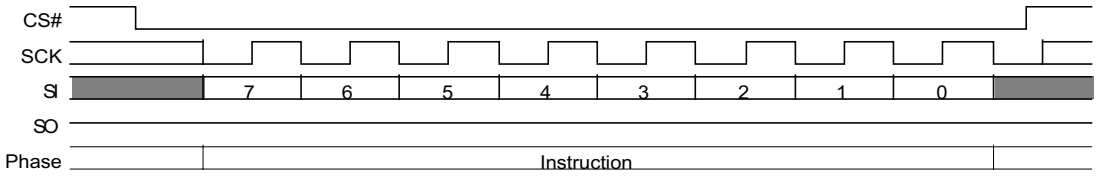
The Bulk Erase (BE) command sets all bits to 1 (all bytes are FFh) inside the entire flash memory array. Before the BE command can be accepted by the device, a Write Enable (WREN) command must be issued and decoded by the device, which sets the Write Enable Latch (WEL) in the Status Register to enable any write operations.

CS# must be driven into the logic high state after the eighth bit of the instruction byte has been latched in on SI. This will initiate the erase cycle, which involves the pre-programming and erase of the entire flash memory array. If CS# is not driven high after the last bit of instruction, the BE operation will not be executed.

As soon as CS# is driven into the logic high state, the erase cycle will be initiated. With the erase cycle in progress, the user can read the value of the Write-In Progress (WIP) bit to determine when the operation has been completed. The WIP bit will indicate a 1 when the erase cycle is in progress and a 0 when the erase cycle has been completed.

A BE command can be executed only when the Block Protection (BP2, BP1, BP0) bits are set to 0's. If the BP bits are not zero, the BE command is not executed and E_ERR is not set. The BE command will skip any sectors protected by the DYB or PPB and the E_ERR status will not be set.

Figure 103. Bulk Erase Command Sequence



9.6.3 Erase Suspend and Resume Commands (ERSP 75h or ERRS 7Ah)

The Erase Suspend command, allows the system to interrupt a sector erase operation and then read from or program data to, any other sector. Erase Suspend is valid only during a sector erase operation. The Erase Suspend command is ignored if written during the Bulk Erase operation.

When the Erase Suspend command is written during the sector erase operation, the device requires a maximum of t_{ESL} (erase suspend latency) to suspend the erase operation and update the status bits. See Table 46 on page 110.

Commands allowed after the Erase Suspend command is issued:

- Read Status Register 1 (RDSR1 05h)
- Read Status Register 2 (RDSR2 07h)

The Write in Progress (WIP) bit in Status Register 1 (SR1[0]) must be checked to know when the erase operation has stopped. The Erase Suspend bit in Status Register-2 (SR2[1]) can be used to determine if an erase operation has been suspended or was completed at the time WIP changes to 0.

If the erase operation was completed during the suspend operation, a resume command is not needed and has no effect if issued. Erase Resume commands will be ignored unless an Erase operation is suspended.

See Table 43 on page 102 for the commands allowed while erase is suspend.

After the erase operation has been suspended, the sector enters the erase-suspend mode. The system can read data from or program data to the device. Reading at any address within an erase-suspended sector produces undetermined data.

A WREN command is required before any command that will change nonvolatile data, even during erase suspend.

The WRR and PPB Erase commands are not allowed during Erase Suspend, it is therefore not possible to alter the Block Protection or PPB bits during Erase Suspend. If there are sectors that may need programming during Erase suspend, these sectors should be protected only by DYB bits that can be turned off during Erase Suspend. However, WRR is allowed immediately following the BRAC command; in this special case the WRR is interpreted as a write to the Bank Address Register, not a write to SR1 or CR1.

If a program command is sent for a location within an erase suspended sector the program operation will fail with the P_ERR bit set.

After an erase-suspended program operation is complete, the device returns to the erase-suspend mode. The system can determine the status of the program operation by reading the WIP bit in the Status Register, just as in the standard program operation.

The Erase Resume command 7Ah must be written to resume the erase operation if an Erase is suspend. Erase Resume commands will be ignored unless an Erase is Suspend.

After an Erase Resume command is sent, the WIP bit in the status register will be set to a 1 and the erase operation will continue. Further Resume commands are ignored.

Erase operations may be interrupted as often as necessary e.g. an erase suspend command could immediately follow an erase resume command but, in order for an erase operation to progress to completion there must be some periods of time between resume and the next suspend command greater than or equal to t_{ERS}. See Table 46 on page 110.

Figure 104. Erase Suspend (ERSP 75h) Command Sequence

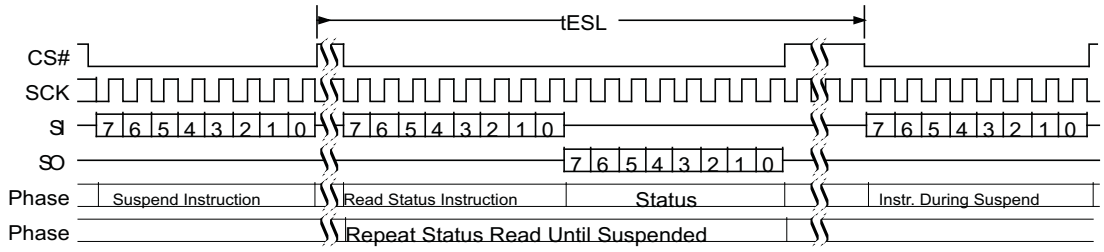


Figure 105. Erase Resume (ERRS 7Ah) Command Sequence

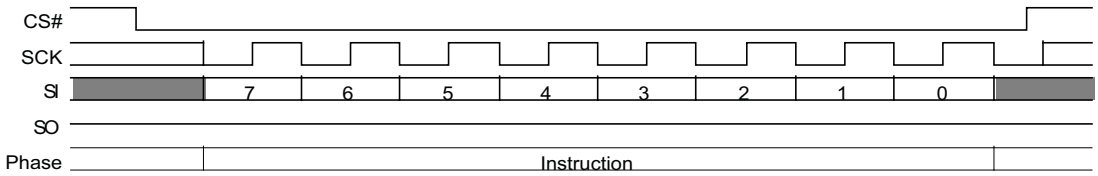


Table 43. Commands Allowed During Program or Erase Suspend

Instruction Name	Instruction Code (Hex)	Allowed During Erase Suspend	Allowed During Program Suspend	Comment
BRAC	B9	X	X	Bank address register may need to be changed during a suspend to reach a sector for read or program.
BRRD	16	X	X	Bank address register may need to be changed during a suspend to reach a sector for read or program.
BRWR	17	X	X	Bank address register may need to be changed during a suspend to reach a sector for read or program.
CLSR	30	X	–	Clear status may be used if a program operation fails during erase suspend.
DYBRD	E0	X	–	It may be necessary to remove and restore dynamic protection during erase suspend to allow programming during erase suspend.
DYBWR	E1	X	–	It may be necessary to remove and restore dynamic protection during erase suspend to allow programming during erase suspend.
ERRS	7A	X	–	Required to resume from erase suspend.
DDRFR	0D	X	X	All array reads allowed in suspend.
4DDRFR	0E	X	X	All array reads allowed in suspend.
FAST_READ	0B	X	X	All array reads allowed in suspend.
4FAST_READ	0C	X	X	All array reads allowed in suspend.
MBR	FF	X	X	May need to reset a read operation during suspend.
PGRS	8A	X	X	Needed to resume a program operation. A program resume may also be used during nested program suspend within an erase suspend.
PGSP	85	X	–	Program suspend allowed during erase suspend.
PP	02	X	–	Required for array program during erase suspend.
4PP	12	X	–	Required for array program during erase suspend.
PPBRD	E2	X	–	Allowed for checking persistent protection before attempting a program command during erase suspend.
QPP	32, 38	X	–	Required for array program during erase suspend.
4QPP	34	X	–	Required for array program during erase suspend.
4READ	13	X	X	All array reads allowed in suspend.
RDCR	35	X	X	–
DIOR	BB	X	X	All array reads allowed in suspend.
4DIOR	BC	X	X	All array reads allowed in suspend.
DOR	3B	X	X	All array reads allowed in suspend.
4DOR	3C	X	X	All array reads allowed in suspend.
DDRDIOR	BD	X	X	All array reads allowed in suspend.
4DDRDIOR	BE	X	X	All array reads allowed in suspend.
DDRQIOR	ED	X	X	All array reads allowed in suspend.
DDRQIOR4	EE	X	X	All array reads allowed in suspend.
QIOR	EB	X	X	All array reads allowed in suspend.
4QIOR	EC	X	X	All array reads allowed in suspend.
QOR	6B	X	X	All array reads allowed in suspend.

Table 43. Commands Allowed During Program or Erase Suspend (Continued)

Instruction Name	Instruction Code (Hex)	Allowed During Erase Suspend	Allowed During Program Suspend	Comment
4QOR	6C	X	X	All array reads allowed in suspend.
RDSR1	05	X	X	Needed to read WIP to determine end of suspend process.
RDSR2	07	X	X	Needed to read suspend status to determine whether the operation is suspended or complete.
READ	03	X	X	All array reads allowed in suspend.
RESET	F0	X	X	Reset allowed anytime.
WREN	06	X	–	Required for program command within erase suspend.
WRR	01	X	X	Bank register may need to be changed during a suspend to reach a sector needed for read or program. WRR is allowed when following BRAC.

9.7 One Time Program Array Commands

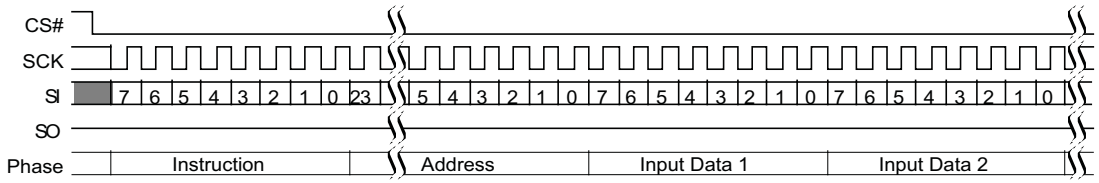
9.7.1 OTP Program (OTPP 42h)

The OTP Program command programs data in the One Time Program region, which is in a different address space from the main array data. The OTP region is 1024 bytes so, the address bits from A23 to A10 must be zero for this command. Refer to OTP Address Space on page 46 for details on the OTP region. The protocol of the OTP Program command is the same as the Page Program command. Before the OTP Program command can be accepted by the device, a Write Enable (WREN) command must be issued and decoded by the device, which sets the Write Enable Latch (WEL) in the Status Register to enable any write operations.

To program the OTP array in bit granularity, the rest of the bits within a data byte can be set to 1.

Each region in the OTP memory space can be programmed one or more times, provided that the region is not locked. Attempting to program zeros in a region that is locked will fail with the P_ERR bit in SR1 set to 1 Programming ones, even in a protected area does not cause an error and does not set P_ERR. Subsequent OTP programming can be performed only on the un-programmed bits (that is, 1 data).

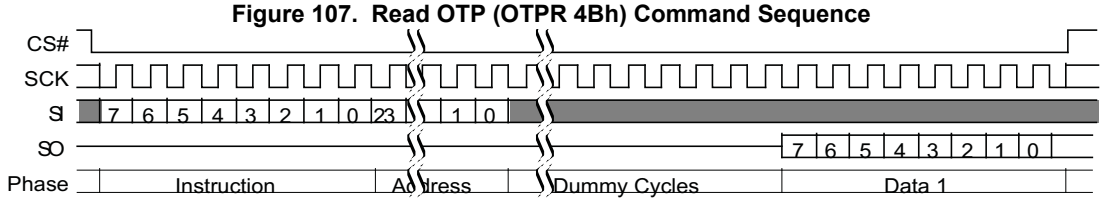
Figure 106. Page Program (OTPP 42h) Command Sequence



9.7.2 OTP Read (OTPR 4Bh)

The OTP Read command reads data from the OTP region. The OTP region is 1024 bytes so, the address bits from A23 to A10 must be zero for this command. Refer to OTP Address Space on page 46 for details on the OTP region. The protocol of the OTP Read command is similar to the Fast Read command except that it will not wrap to the starting address after the OTP address is at its maximum; instead, the data beyond the maximum OTP address will be undefined. Also, the OTP Read command is not affected by the latency code. The OTP read command always has one dummy byte of latency as shown below.

Figure 107. Read OTP (OTPR 4Bh) Command Sequence

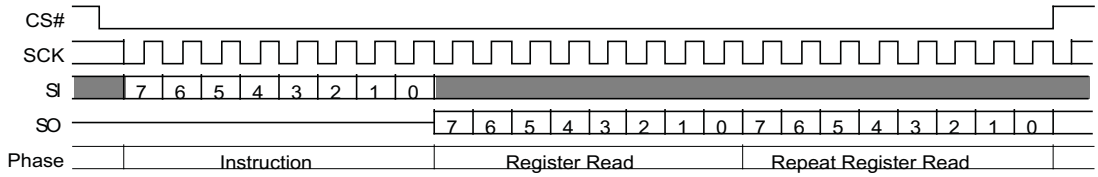


9.8 Advanced Sector Protection Commands

9.8.1 ASP Read (ASPRD 2Bh)

The ASP Read instruction 2Bh is shifted into SI by the rising edge of the SCK signal. Then the 16-bit ASP register contents is shifted out on the serial output SO, least significant byte first. Each bit is shifted out at the SCK frequency by the falling edge of the SCK signal. It is possible to read the ASP register continuously by providing multiples of 16 clock cycles. The maximum operating clock frequency for the ASP Read (ASPRD) command is 133 MHz.

Figure 108. ASPRD Command



9.8.2 ASP Program (ASPP 2Fh)

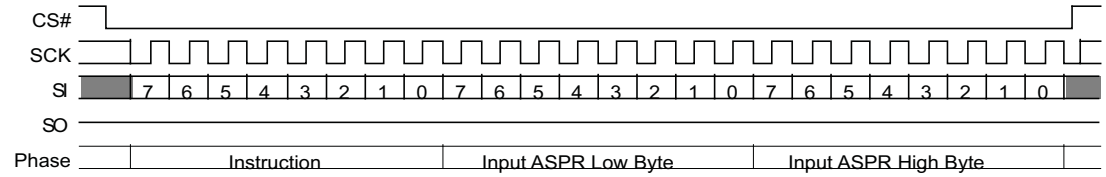
Before the ASP Program (ASPP) command can be accepted by the device, a Write Enable (WREN) command must be issued. After the Write Enable (WREN) command has been decoded, the device will set the Write Enable Latch (WEL) in the Status Register to enable any write operations.

The ASPP command is entered by driving CS# to the logic low state, followed by the instruction and two data bytes on SI, least significant byte first. The ASP Register is two data bytes in length.

The ASPP command affects the P_ERR and WIP bits of the Status and Configuration Registers in the same manner as any other programming operation.

CS# input must be driven to the logic high state after the sixteenth bit of data has been latched in. If not, the ASPP command is not executed. As soon as CS# is driven to the logic high state, the self-timed ASPP operation is initiated. While the ASPP operation is in progress, the Status Register may be read to check the value of the Write-In Progress (WIP) bit. The Write-In Progress (WIP) bit is a 1 during the self-timed ASPP operation, and is a 0 when it is completed. When the ASPP operation is completed, the Write Enable Latch (WEL) is set to a 0.

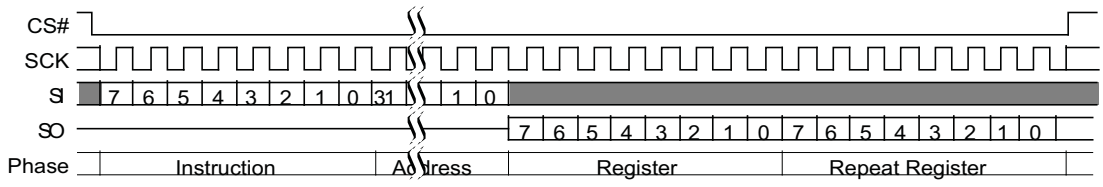
Figure 109. ASPP (2Fh) Command



9.8.3 DYB Read (DYBRD E0h)

The instruction E0h is latched into SI by the rising edge of the SCK signal. Followed by the 32-bit address selecting location zero within the desired sector (note, the high order address bits not used by a particular density device must be zero). Then the 8-bit DYB access register contents are shifted out on the serial output SO. Each bit is shifted out at the SCK frequency by the falling edge of the SCK signal. It is possible to read the same DYB access register continuously by providing multiples of eight clock cycles. The address of the DYB register does not increment so this is not a means to read the entire DYB array. Each location must be read with a separate DYB Read command. The maximum operating clock frequency for READ command is 133 MHz.

Figure 110. DYBRD Command Sequence



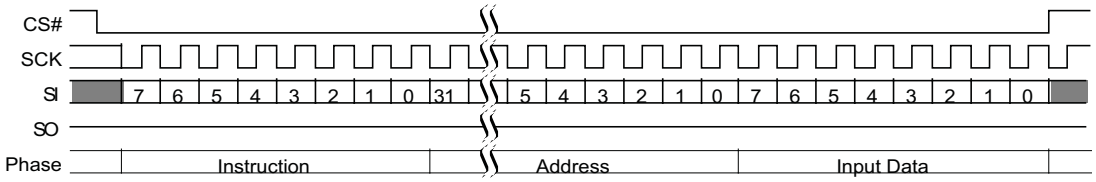
9.8.4 DYB Write (DYBWR E1h)

Before the DYB Write (DYBWR) command can be accepted by the device, a Write Enable (WREN) command must be issued. After the Write Enable (WREN) command has been decoded, the device will set the Write Enable Latch (WEL) in the Status Register to enable any write operations.

The DYBWR command is entered by driving CS# to the logic low state, followed by the instruction, the 32-bit address selecting location zero within the desired sector (note, the high order address bits not used by a particular density device must be zero), then the data byte on SI. The DYB Access Register is one data byte in length.

The DYBWR command affects the P_ERR and WIP bits of the Status and Configuration Registers in the same manner as any other programming operation. CS# must be driven to the logic high state after the eighth bit of data has been latched in. If not, the DYBWR command is not executed. As soon as CS# is driven to the logic high state, the self-timed DYBWR operation is initiated. While the DYBWR operation is in progress, the Status Register may be read to check the value of the Write-In Progress (WIP) bit. The Write-In Progress (WIP) bit is a 1 during the self-timed DYBWR operation, and is a 0 when it is completed. When the DYBWR operation is completed, the Write Enable Latch (WEL) is set to a 0.

Figure 111. DYBWR (E1h) Command Sequence

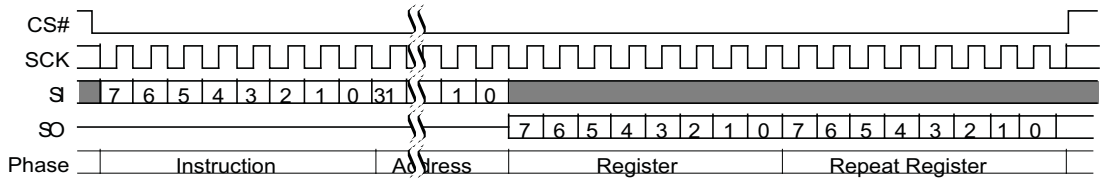


9.8.5 PPB Read (PPBRD E2h)

The instruction E2h is shifted into SI by the rising edges of the SCK signal, followed by the 32-bit address selecting location zero within the desired sector (note, the high order address bits not used by a particular density device must be zero) Then the 8-bit PPB access register contents are shifted out on SO.

It is possible to read the same PPB access register continuously by providing multiples of eight clock cycles. The address of the PPB register does not increment so this is not a means to read the entire PPB array. Each location must be read with a separate PPB Read command. The maximum operating clock frequency for the PPB Read command is 133 MHz.

Figure 112. PPBRD (E2h) Command Sequence



9.8.6 PPB Program (PPBP E3h)

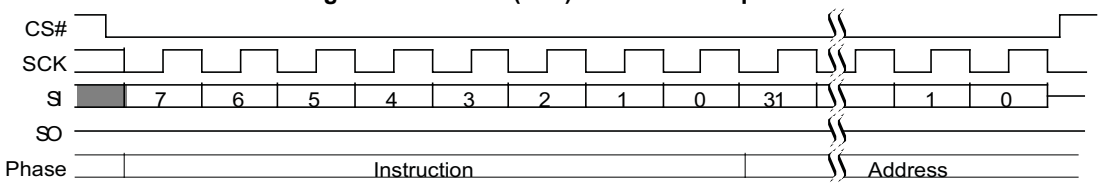
Before the PPB Program (PPBP) command can be accepted by the device, a Write Enable (WREN) command must be issued. After the Write Enable (WREN) command has been decoded, the device will set the Write Enable Latch (WEL) in the Status Register to enable any write operations.

The PPBP command is entered by driving CS# to the logic low state, followed by the instruction, followed by the 32-bit address selecting location zero within the desired sector (note, the high order address bits not used by a particular density device must be zero).

The PPBP command affects the P_ERR and WIP bits of the Status and Configuration Registers in the same manner as any other programming operation.

CS# must be driven to the logic high state after the last bit of address has been latched in. If not, the PPBP command is not executed. As soon as CS# is driven to the logic high state, the self-timed PPBP operation is initiated. While the PPBP operation is in progress, the Status Register may be read to check the value of the Write-In Progress (WIP) bit. The Write-In Progress (WIP) bit is a 1 during the self-timed PPBP operation, and is a 0 when it is completed. When the PPBP operation is completed, the Write Enable Latch (WEL) is set to a 0.

Figure 113. PPBP (E3h) Command Sequence



9.8.7 PPB Erase (PPBE E4h)

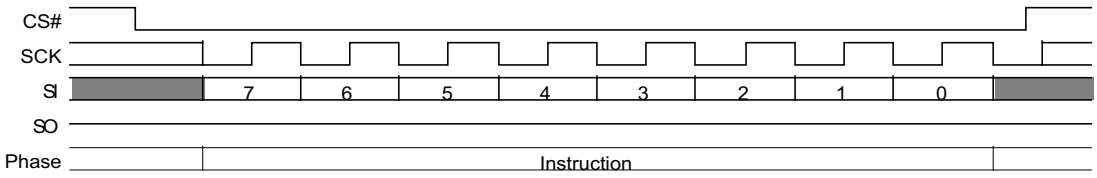
The PPB Erase (PPBE) command sets all PPB bits to 1. Before the PPB Erase command can be accepted by the device, a Write Enable (WREN) command must be issued and decoded by the device, which sets the Write Enable Latch (WEL) in the Status Register to enable any write operations.

The instruction E4h is shifted into SI by the rising edges of the SCK signal.

CS# must be driven into the logic high state after the eighth bit of the instruction byte has been latched in on SI. This will initiate the beginning of internal erase cycle, which involves the pre-programming and erase of the entire PPB memory array. Without CS# being driven to the logic high state after the eighth bit of the instruction, the PPB erase operation will not be executed.

With the internal erase cycle in progress, the user can read the value of the Write-In Progress (WIP) bit to check if the operation has been completed. The WIP bit will indicate a 1 when the erase cycle is in progress and a 0 when the erase cycle has been completed. Erase suspend is not allowed during PPB Erase.

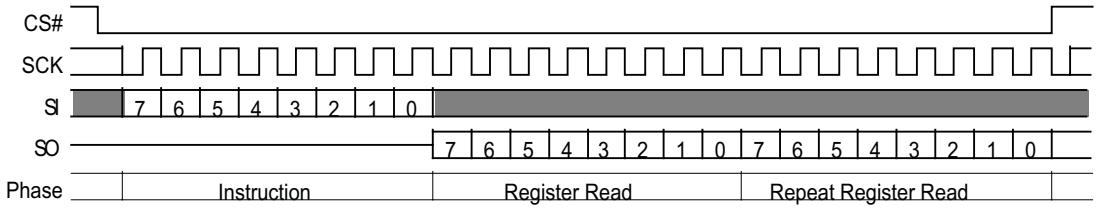
Figure 114. PPB Erase (PPBE E4h) Command Sequence



9.8.8 PPB Lock Bit Read (PLBRD A7h)

The PPB Lock Bit Read (PLBRD) command allows the PPB Lock Register contents to be read out of SO. It is possible to read the PPB lock register continuously by providing multiples of eight clock cycles. The PPB Lock Register contents may only be read when the device is in standby state with no other operation in progress. It is recommended to check the Write-In Progress (WIP) bit of the Status Register before issuing a new command to the device.

Figure 115. PPB Lock Register Read Command Sequence



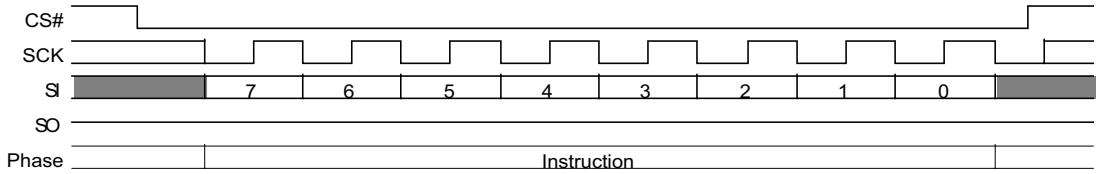
9.8.9 PPB Lock Bit Write (PLBWR A6h)

The PPB Lock Bit Write (PLBWR) command clears the PPB Lock Register to zero. Before the PLBWR command can be accepted by the device, a Write Enable (WREN) command must be issued and decoded by the device, which sets the Write Enable Latch (WEL) in the Status Register to enable any write operations.

The PLBWR command is entered by driving CS# to the logic low state, followed by the instruction.

CS# must be driven to the logic high state after the eighth bit of instruction has been latched in. If not, the PLBWR command is not executed. As soon as CS# is driven to the logic high state, the self-timed PLBWR operation is initiated. While the PLBWR operation is in progress, the Status Register may still be read to check the value of the Write-In Progress (WIP) bit. The Write-In Progress (WIP) bit is a 1 during the self-timed PLBWR operation, and is a 0 when it is completed. When the PLBWR operation is completed, the Write Enable Latch (WEL) is set to a 0. The maximum clock frequency for the PLBWR command is 133 MHz.

Figure 116. PPB Lock Bit Write (PLBWR A6h) Command Sequence

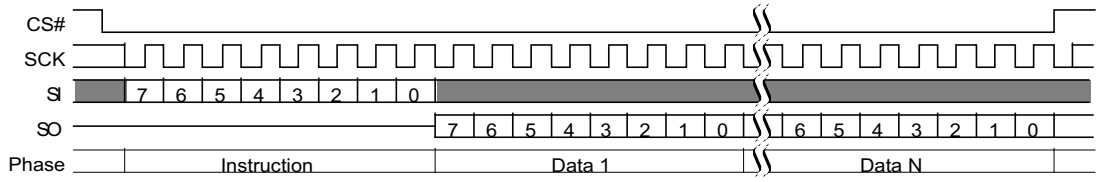


9.8.10 Password Read (PASSRD E7h)

The correct password value may be read only after it is programmed and before the Password Mode has been selected by programming the Password Protection Mode bit to 0 in the ASP Register (ASP[2]). After the Password Protection Mode is selected the PASSRD command is ignored.

The PASSRD command is shifted into SI. Then the 64-bit Password is shifted out on the serial output SO, least significant byte first, most significant bit of each byte first. Each bit is shifted out at the SCK frequency by the falling edge of the SCK signal. It is possible to read the Password continuously by providing multiples of 64 clock cycles. The maximum operating clock frequency for the PASSRD command is 133 MHz.

Figure 117. Password Read (PASSRD E7h) Command Sequence



9.8.11 Password Program (PASSP E8h)

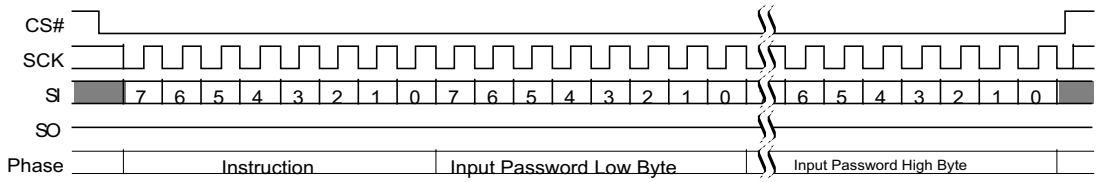
Before the Password Program (PASSP) command can be accepted by the device, a Write Enable (WREN) command must be issued and decoded by the device. After the Write Enable (WREN) command has been decoded, the device sets the Write Enable Latch (WEL) to enable the PASSP operation.

The password can only be programmed before the Password Mode is selected by programming the Password Protection Mode bit to 0 in the ASP Register (ASP[2]). After the Password Protection Mode is selected the PASSP command is ignored.

The PASSP command is entered by driving CS# to the logic low state, followed by the instruction and the password data bytes on SI, least significant byte first, most significant bit of each byte first. The password is sixty-four (64) bits in length.

CS# must be driven to the logic high state after the sixty-fourth (64th) bit of data has been latched. If not, the PASSP command is not executed. As soon as CS# is driven to the logic high state, the self-timed PASSP operation is initiated. While the PASSP operation is in progress, the Status Register may be read to check the value of the Write-In Progress (WIP) bit. The Write-In Progress (WIP) bit is a 1 during the self-timed PASSP cycle, and is a 0 when it is completed. The PASSP command can report a program error in the P_ERR bit of the status register. When the PASSP operation is completed, the Write Enable Latch (WEL) is set to a 0. The maximum clock frequency for the PASSP command is 133 MHz.

Figure 118. Password Program (PASSP E8h) Command Sequence



9.8.12 Password Unlock (PASSU E9h)

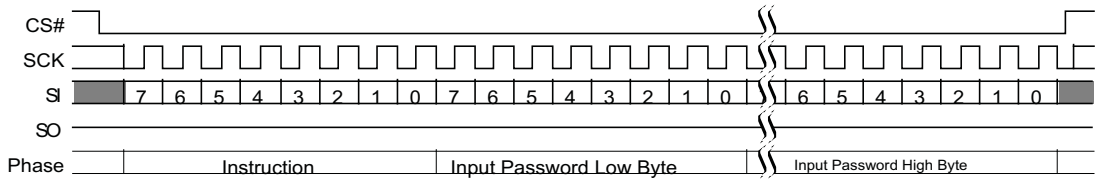
The PASSU command is entered by driving CS# to the logic low state, followed by the instruction and the password data bytes on SI, least significant byte first, most significant bit of each byte first. The password is sixty-four (64) bits in length.

CS# must be driven to the logic high state after the sixty-fourth (64th) bit of data has been latched. If not, the PASSU command is not executed. As soon as CS# is driven to the logic high state, the self-timed PASSU operation is initiated. While the PASSU operation is in progress, the Status Register may be read to check the value of the Write-In Progress (WIP) bit. The Write-In Progress (WIP) bit is a 1 during the self-timed PASSU cycle, and is a 0 when it is completed.

If the PASSU command supplied password does not match the hidden password in the Password Register, an error is reported by setting the P_ERR bit to 1. The WIP bit of the status register also remains set to 1. It is necessary to use the CLSR command to clear the status register, the RESET command to software reset the device, or drive the RESET# input low to initiate a hardware reset, in order to return the P_ERR and WIP bits to 0. This returns the device to standby state, ready for new commands such as a retry of the PASSU command.

If the password does match, the PPB Lock bit is set to 1. The maximum clock frequency for the PASSU command is 133 MHz.

Figure 119. Password Unlock (PASSU E9h) Command Sequence

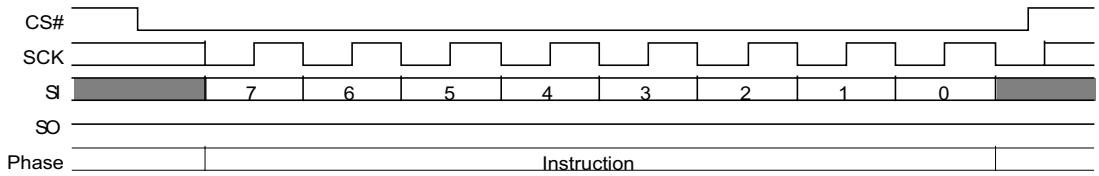


9.9 Reset Commands

9.9.1 Software Reset Command (RESET F0h)

The Software Reset command (RESET) restores the device to its initial power up state, except for the volatile FREEZE bit in the Configuration register CR1[1] and the volatile PPB Lock bit in the PPB Lock Register. The Freeze bit and the PPB Lock bit will remain set at their last value prior to the software reset. To clear the FREEZE bit and set the PPB Lock bit to its protection mode selected power on state, a full power-on-reset sequence or hardware reset must be done. Note that the nonvolatile bits in the configuration register, TBPROT, TBPARM, and BPNV, retain their previous state after a Software Reset. The Block Protection bits BP2, BP1, and BP0, in the status register will only be reset if they are configured as volatile via the BPNV bit in the Configuration Register (CR1[3]) and FREEZE is cleared to zero . The software reset cannot be used to circumvent the FREEZE or PPB Lock bit protection mechanisms for the other security configuration bits. The reset command is executed when CS# is brought to high state and requires t_{RPH} time to execute.

Figure 120. Software Reset (RESET F0h) Command Sequence

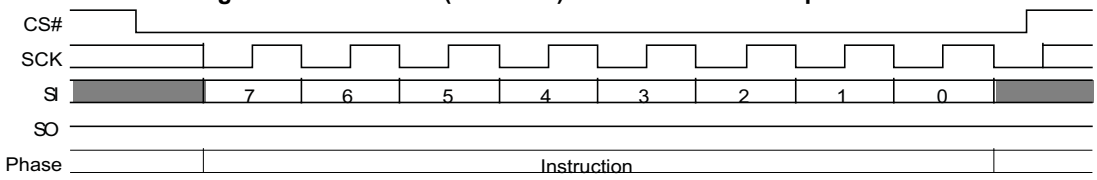


9.9.2 Mode Bit Reset (MBR FFh)

The Mode Bit Reset (MBR) command can be used to return the device from continuous high performance read mode back to normal standby awaiting any new command. Because some device packages lack a hardware RESET# input and a device that is in a continuous high performance read mode may not recognize any normal SPI command, a system hardware reset or software reset command may not be recognized by the device. It is recommended to use the MBR command after a system reset when the RESET# signal is not available or, before sending a software reset, to ensure the device is released from continuous high performance read mode.

The MBR command sends Ones on SI or I/O0 for 8 SCK cycles. I/O1 to I/O3 are “don’t care” during these cycles.

Figure 121. Mode Bit (MBR FFh) Reset Command Sequence



9.10 Embedded Algorithm Performance Tables

Table 44. Program and Erase Performance

Symbol	Parameter	Min	Typ [1]	Max [2]	Unit
t_W	WRR Write Time	–	560	2000	ms
t_{PP}	Page Programming (512 bytes)	–	340	750/1300 [3]	µs
t_{SE}	Sector Erase Time (256-kB logical sectors = 4 x 64 kB physical sectors)	–	520	2600	ms
t_{BE}	Bulk Erase Time (S25FL512S)	–	103	460	sec

Notes
1. Typical program and erase times assume the following conditions: 25°C, V_{CC} = 3.0V; 10,000 cycles; checkerboard data pattern.
2. Under worst case conditions of 90°C; 100,000 cycles max.
3. Industrial temperature range / Industrial Plus temperature range.

Table 45. Program Suspend AC Parameters

Parameter	Min	Typical	Max	Unit	Comments
Program Suspend Latency (t_{PSL})	–		40	µs	The time from Program Suspend command until the WIP bit is 0
Program Resume to next Program Suspend (t_{PRS})	0.06	100	–	µs	Minimum is the time needed to issue the next Program Suspend command but ≥ typical periods are needed for Program to progress to completion

Table 46. Erase Suspend AC Parameters

Parameter	Min	Typical	Max	Unit	Comments
Erase Suspend Latency (t_{ESL})	–	–	45	µs	The time from Erase Suspend command until the WIP bit is 0
Erase Resume to next Erase Suspend (t_{ERS})	0.06	100	–	µs	Minimum is the time needed to issue the next Erase Suspend command but ≥ typical periods are needed for the Erase to progress to completion

10. Data Integrity

10.1 Erase Endurance

Table 10.1 Erase Endurance

Parameter	Minimum	Unit
Program/Erase cycles per main Flash array sectors	100K	PE cycle
Program/Erase cycles per PPB array or nonvolatile register array [1]	100K	PE cycle

Note
1. Each write command to a nonvolatile register causes a PE cycle on the entire nonvolatile register array. OTP bits and registers internally reside in a separate array that is not PE cycled.

10.2 Data Retention

Table 10.2 Data Retention

Parameter	Test Conditions	Minimum Time	Unit
Data Retention Time	1K Program/Erase Cycles	20	Years
	10K Program/Erase Cycles	20	Years
	100K Program/Erase Cycles	2	Years

Contact Cypress Sales and FAE for further information on the data integrity. An application note is available at: www.cypress.com/appnotes.

11. Software Interface Reference

11.1 Command Summary

Table 47. S25FL512S Instruction Set (sorted by instruction)

Instruction (Hex)	Command Name	Command Description	Maximum Frequency (MHz)
01	WRR	Write Register (Status-1, Configuration-1)	133
02	PP	Page Program (3- or 4-byte address)	133
03	READ	Read (3- or 4-byte address)	50
04	WRDI	Write Disable	133
05	RDSR1	Read Status Register-1	133
06	WREN	Write Enable	133
07	RDSR2	Read Status Register-2	133
0B	FAST_READ	Fast Read (3- or 4-byte address)	133
0C	4FAST_READ	Fast Read (4-byte address)	133
0D	DDRFR	DDR Fast Read (3- or 4-byte address)	80
0E	4DDRFR	DDR Fast Read (4-byte address)	80
12	4PP	Page Program (4-byte address)	133
13	4READ	Read (4-byte address)	50
14	ABRD	AutoBoot Register Read	133
15	ABWR	AutoBoot Register Write	133
16	BRRD	Bank Register Read	133
17	BRWR	Bank Register Write	133
18	ECCRD	ECC Read	133
2B	ASPRD	ASP Read	133
2F	ASPP	ASP Program	133
30	CLSR	Clear Status Register - Erase/ Program Fail Reset	133
32	QPP	Quad Page Program (3- or 4-byte address)	80
34	4QPP	Quad Page Program (4-byte address)	80
35	RDCR	Read Configuration Register-1	133
38	QPP	Quad Page Program (3- or 4-byte address)	80
3B	DOR	Read Dual Out (3- or 4-byte address)	104
3C	4DOR	Read Dual Out (4-byte address)	104
41	DLPRD	Data Learning Pattern Read	133
42	OTPP	OTP Program	133

Table 47. S25FL512S Instruction Set (sorted by instruction) (Continued)

Instruction (Hex)	Command Name	Command Description	Maximum Frequency (MHz)
43	PNVDLR	Program NV Data Learning Register	133
4A	WVDLR	Write Volatile Data Learning Register	133
4B	OTPR	OTP Read	133
5A	RSFDP	Read Serial Flash Discoverable Parameters	133
60	BE	Bulk Erase	133
6B	QOR	Read Quad Out (3- or 4-byte address)	104
6C	4QOR	Read Quad Out (4-byte address)	104
75	ERSP	Erase Suspend	133
7A	ERRS	Erase Resume	133
85	PGSP	Program Suspend	133
8A	PGRS	Program Resume	133
90	READ_ID (REMS)	Read Electronic Manufacturer Signature	133
9F	RDID	Read ID (JEDEC Manufacturer ID and JEDEC CFI)	133
A3	MPM	Reserved for Multi-I/O-High Perf Mode (MPM)	133
A6	PLBWR	PPB Lock Bit Write	133
A7	PLBRD	PPB Lock Bit Read	133
AB	RES	Read Electronic Signature	50
B9	BRAC	Bank Register Access (Legacy Command formerly used for Deep Power Down)	133
BB	DIOR	Dual I/O Read (3- or 4-byte address)	104
BC	4DIOR	Dual I/O Read (4-byte address)	104
BD	DDRDIOR	DDR Dual I/O Read (3- or 4-byte address)	80
BE	4DDRDIOR	DDR Dual I/O Read (4-byte address)	80
C7	BE	Bulk Erase (alternate command)	133
D8	SE	Erase 256 kB (3- or 4-byte address)	133
DC	4SE	Erase 256 kB (4-byte address)	133
E0	DYBRD	DYB Read	133
E1	DYBWR	DYB Write	133
E2	PPBRD	PPB Read	133
E3	PPBP	PPB Program	133
E4	PPBE	PPB Erase	133

Table 47. S25FL512S Instruction Set (sorted by instruction) (Continued)

Instruction (Hex)	Command Name	Command Description	Maximum Frequency (MHz)
E5	Reserved-E5	Reserved	–
E6	Reserved-E6	Reserved	–
E7	PASSRD	Password Read	133
E8	PASSP	Password Program	133
E9	PASSU	Password Unlock	133
EB	QIOR	Quad I/O Read (3- or 4-byte address)	104
EC	4QIOR	Quad I/O Read (4-byte address)	104
ED	DDRQIOR	DDR Quad I/O Read (3- or 4-byte address)	80
EE	4DDRQIOR	DDR Quad I/O Read (4-byte address)	80
F0	RESET	Software Reset	133
FF	MBR	Mode Bit Reset	133

11.2 Serial Flash Discoverable Parameters (SFDP) Address Map

The SFDP address space has a header starting at address zero that identifies the SFDP data structure and provides a pointer to each parameter. One Basic Flash parameter is mandated by the JEDEC JESD216B standard. Two optional parameter tables for Sector Map and 4 Byte Address Instructions follow the Basic Flash table. Cypress provides an additional parameter by pointing to the ID-CFI address space i.e. the ID-CFI address space is a sub-set of the SFDP address space. The parameter tables portion of the SFDP data structure are located within the ID-CFI address space and is thus both a CFI parameter and an SFDP parameter. In this way both SFDP and ID-CFI information can be accessed by either the RSFDP or RDID commands.

Table 48. SFDP Overview Map

Byte Address	Description
0000h	Location zero within JEDEC JESD216B SFDP space – start of SFDP header
,,,	Remainder of SFDP header followed by undefined space
1000h	Location zero within ID-CFI space – start of ID-CFI parameter tables
...	ID-CFI parameters
1120h	Start of SFDP parameter which is also one of the CFI parameter tables
...	Remainder of SFDP parameter tables followed by either more CFI parameters or undefined space

11.2.1 Field Definitions

Table 49. SFDP Header

Relative Byte Address	SFDP Dword Address	Data	Description
00h	SFDP Header 1st DWORD	53h	This is the entry point for Read SFDP (5Ah) command i.e. location zero within SFDP space ASCII “S”
01h		46h	ASCII “F”
02h		44h	ASCII “D”
03h		50h	ASCII “P”
04h	SFDP Header 2nd DWORD	06h	SFDP Minor Revision (06h = JEDEC JESD216 Revision B) This revision is backward compatible with all prior minor revisions. Minor revisions are changes that define previously reserved fields, add fields to the end, or that clarify definitions of existing fields. Increments of the minor revision value indicate that previously reserved parameter fields may have been assigned a new definition or entire Dwords may have been added to the parameter table. However, the definition of previously existing fields is unchanged and therefore remain backward compatible with earlier SFDP parameter table revisions. Software can safely ignore increments of the minor revision number, as long as only those parameters the software was designed to support are used i.e. previously reserved fields and additional Dwords must be masked or ignored . Do not do a simple compare on the minor revision number, looking only for a match with the revision number that the software is designed to handle. There is no problem with using a higher number minor revision.
05h		01h	SFDP Major Revision This is the original major revision. This major revision is compatible with all SFDP reading and parsing software.
06h		05h	Number of Parameter Headers (zero based, 05h = 6 parameters)
07h		FFh	Unused
08h	Parameter Header 0 1st DWORD	00h	Parameter ID LSB (00h = JEDEC SFDP Basic SPI Flash Parameter)
09h		00h	Parameter Minor Revision (00h = JESD216) - This older revision parameter header is provided for any legacy SFDP reading and parsing software that requires seeing a minor revision 0 parameter header. SFDP software designed to handle later minor revisions should continue reading parameter headers looking for a higher numbered minor revision that contains additional parameters for that software revision.
0Ah		01h	Parameter Major Revision (01h = The original major revision - all SFDP software is compatible with this major revision.
0Bh		09h	Parameter Table Length (in double words = Dwords = 4 byte units) 09h = 9 Dwords
0Ch	Parameter Header 0 2nd DWORD	20h	Parameter Table Pointer Byte 0 (Dword = 4 byte aligned) JEDEC Basic SPI Flash parameter byte offset = 1120h
0Dh		11h	Parameter Table Pointer Byte 1
0Eh		00h	Parameter Table Pointer Byte 2
0Fh		FFh	Parameter ID MSB (FFh = JEDEC defined legacy Parameter ID)

Table 49. SFDP Header (Continued)

Relative Byte Address	SFDP Dword Address	Data	Description
10h	Parameter Header 1 1st DWORD	00h	Parameter ID LSB (00h = JEDEC SFDP Basic SPI Flash Parameter)
11h		05h	Parameter Minor Revision (05h = JESD216 Revision A) - This older revision parameter header is provided for any legacy SFDP reading and parsing software that requires seeing a minor revision 5 parameter header. SFDP software designed to handle later minor revisions should continue reading parameter headers looking for a later minor revision that contains additional parameters.
12h		01h	Parameter Major Revision (01h = The original major revision - all SFDP software is compatible with this major revision.
13h		10h	Parameter Table Length (in double words = Dwords = 4 byte units) 10h = 16 Dwords
14h	Parameter Header 1 2nd DWORD	20h	Parameter Table Pointer Byte 0 (Dword = 4 byte aligned) JEDEC Basic SPI Flash parameter byte offset = 1120h address
15h		11h	Parameter Table Pointer Byte 1
16h		00h	Parameter Table Pointer Byte 2
17h		FFh	Parameter ID MSB (FFh = JEDEC defined Parameter)
18h	Parameter Header 2 1st DWORD	00h	Parameter ID LSB (00h = JEDEC SFDP Basic SPI Flash Parameter)
19h		06h	Parameter Minor Revision (06h = JESD216 Revision B)
1Ah		01h	Parameter Major Revision (01h = The original major revision - all SFDP software is compatible with this major revision.
1Bh		10h	Parameter Table Length (in double words = Dwords = 4 byte units) 10h = 16 Dwords
1Ch	Parameter Header 2 2nd DWORD	20h	Parameter Table Pointer Byte 0 (Dword = 4 byte aligned) JEDEC Basic SPI Flash parameter byte offset = 1120h address
1Dh		11h	Parameter Table Pointer Byte 1
1Eh		00h	Parameter Table Pointer Byte 2
1Fh		FFh	Parameter ID MSB (FFh = JEDEC defined Parameter)
20h	Parameter Header 3 1st DWORD	81h	Parameter ID LSB (81h = SFDP Sector Map Parameter)
21h		00h	Parameter Minor Revision (00h = Initial version as defined in JESD216 Revision B)
22h		01h	Parameter Major Revision (01h = The original major revision - all SFDP software that recognizes this parameter's ID is compatible with this major revision.
23h		02h	Parameter Table Length (in double words = Dwords = 4 byte units) 02h = 2 Dwords
24h	Parameter Header 3 2nd DWORD	60h	Parameter Table Pointer Byte 0 (Dword = 4 byte aligned) JEDEC parameter byte offset = 1160h
25h		11h	Parameter Table Pointer Byte 1
26h		00h	Parameter Table Pointer Byte 2
27h		FFh	Parameter ID MSB (FFh = JEDEC defined Parameter)
28h	Parameter Header 4 1st DWORD	84h	Parameter ID LSB (00h = SFDP 4 Byte Address Instructions Parameter)
29h		00h	Parameter Minor Revision (00h = Initial version as defined in JESD216 Revision B)
2Ah		01h	Parameter Major Revision (01h = The original major revision - all SFDP software that recognizes this parameter's ID is compatible with this major revision.
2Bh		02h	Parameter Table Length (in double words = Dwords = 4 byte units) (2h = 2 Dwords)

Table 49. SFDP Header (Continued)

Relative Byte Address	SFDP Dword Address	Data	Description
2Ch	Parameter Header 4 2nd DWORD	68h	Parameter Table Pointer Byte 0 (Dword = 4 byte aligned) JEDEC parameter byte offset = 1168h
2Dh		11h	Parameter Table Pointer Byte 1
2Eh		00h	Parameter Table Pointer Byte 2
2Fh		FFh	Parameter ID MSB (FFh = JEDEC defined Parameter)
30h	Parameter Header 5 1st DWORD	01h	Parameter ID LSB (Spansion Vendor Specific ID-CFI parameter) Legacy Manufacturer ID 01h = AMD / Spansion
31h		01h	Parameter Minor Revision (01h = ID-CFI updated with SFDP Rev B table)
32h		01h	Parameter Major Revision (01h = The original major revision - all SFDP software that recognizes this parameter's ID is compatible with this major revision.
33h		5Ch	Parameter Table Length (in double words = Dwords = 4 byte units) CFI starts at 1000h, the final SFDP parameter (CFI ID = A5) starts at 111Eh (SFDP starting point of 1120h -2hB of CFI parameter header), for a length of 11EhB excluding the CFI A5 parameter. The final CFI A5 parameter adds an additional 52hB for a total of 11Eh + 82h = 170hB. 170hB/4 = 5Ch Dwords.
34h	Parameter Header 5 2nd DWORD	00h	Parameter Table Pointer Byte 0 (Dword = 4 byte aligned) Entry point for ID-CFI parameter is byte offset = 1000h relative to SFDP location zero.
35h		10h	Parameter Table Pointer Byte 1
36h		00h	Parameter Table Pointer Byte 2
37h		01h	Parameter ID MSB (01h = JEDEC JEP106 Bank Number 1)

11.3 Device ID and Common Flash Interface (ID-CFI) Address Map

11.3.1 Field Definitions

Table 50. Manufacturer and Device ID

Byte Address	Data	Description
00h	01h	Manufacturer ID for Spansion
01h	02h (512 Mb)	Device ID Most Significant Byte - Memory Interface Type
02h	20h (512 Mb)	Device ID Least Significant Byte - Density
03h	xxh	ID-CFI Length - number bytes following. Adding this value to the current location of 03h gives the address of the last valid location in the ID-CFI address map. A value of 00h indicates the entire 512-byte ID-CFI space must be read because the actual length of the ID-CFI information is longer than can be indicated by this legacy single byte field. The value is OPN dependent.
04h	00h (Uniform 256-kB sectors)	Sector Architecture
05h	80h (FL-S Family)	Family ID
06h	xxh	ASCII characters for Model Refer to Ordering Information on page 141 for the model number definitions.
07h	xxh	
08h	xxh	Reserved
09h	xxh	Reserved
0Ah	xxh	Reserved
0Bh	xxh	Reserved
0Ch	xxh	Reserved
0Dh	xxh	Reserved
0Eh	xxh	Reserved
0Fh	xxh	Reserved

Table 51. CFI Query Identification String

Byte Address	Data	Description
10h 11h 12h	51h 52h 59h	Query Unique ASCII string “QRY”
13h 14h	02h 00h	Primary OEM Command Set FL-P backward compatible command set ID
15h 16h	40h 00h	Address for Primary Extended Table
17h 18h	53h 46h	Alternate OEM Command Set ASCII characters “FS” for SPI (F) interface, S Technology
19h 1Ah	51h 00h	Address for Alternate OEM Extended Table

Table 52. CFI System Interface String

Byte Address	Data	Description
1Bh	27h	V_{CC} Min. (erase/program): 100 millivolts
1Ch	36h	V_{CC} Max. (erase/program): 100 millivolts
1Dh	00h	V_{PP} Min. voltage (00h = no V_{PP} present)
1Eh	00h	V_{PP} Max. voltage (00h = no V_{PP} present)
1Fh	06h	Typical timeout per single byte program 2^N µs
20h	09h (512B page)	Typical timeout for Min. size Page program 2^N µs (00h = not supported)
21h	09h (256 kB)	Typical timeout per individual sector erase 2^N ms
22h	11h (512 Mb)	Typical timeout for full chip erase 2^N ms (00h = not supported)
23h	02h	Max. timeout for byte program 2^N times typical
24h	02h	Max. timeout for page program 2^N times typical
25h	03h	Max. timeout per individual sector erase 2^N times typical
26h	03h	Max. timeout for full chip erase 2^N times typical (00h = not supported)

Table 53. Device Geometry Definition for 512-Mbit Device

Byte Address	Data	Description
27h	1Ah (512 Mb)	Device Size = 2^N bytes;
28h	02h	Flash Device Interface Description; 0000h = x8 only 0001h = x16 only 0002h = x8/x16 capable 0003h = x32 only 0004h = Single I/O SPI, 3-byte address 0005h = Multi I/O SPI, 3-byte address 0102h = Multi I/O SPI, 3- or 4-byte address
29h	01h	
2Ah	09h	Max. number of bytes in multi-byte write = 2^N (0000 = not supported 0009h = 512B page)
2Bh	00h	
2Ch	01h	Number of Erase Block Regions within device 1 = Uniform Device, 2 = Boot Device
2Dh	FFh	Erase Block Region 1 Information (refer to JEDEC JEP137) 32 sectors = 32-1 = 001Fh 4-kB sectors = 256 bytes x 0010h
2Eh	00h	
2Fh	00h	
30h	04h	
31h thru 3Fh	FFh	RFU

Table 54. CFI Primary Vendor-Specific Extended Query (Sheet 1 of 2)

Byte Address	Data	Description
40h	50h	Query-unique ASCII string “PRI”
41h	52h	
42h	49h	
43h	31h	Major version number = 1, ASCII
44h	33h	Minor version number = 3, ASCII
45h	21h	Address Sensitive Unlock (Bits 1-0) 00b = Required 01b = Not Required Process Technology (Bits 5-2) 0000b = 0.23 µm Floating Gate 0001b = 0.17 µm Floating Gate 0010b = 0.23 µm MirrorBit 0011b = 0.11 µm Floating Gate 0100b = 0.11 µm MirrorBit 0101b = 0.09 µm MirrorBit 1000b = 0.065 µm MirrorBit
46h	02h	Erase Suspend 0 = Not Supported 1 = Read Only 2 = Read and Program
47h	01h	Sector Protect 00 = Not Supported X = Number of sectors in group
48h	00h	Temporary Sector Unprotect 00 = Not Supported 01 = Supported
49h	08h	Sector Protect/Unprotect Scheme 04 = High Voltage Method 05 = Software Command Locking Method 08 = Advanced Sector Protection Method 09 = Secure
4Ah	00h	Simultaneous Operation 00 = Not Supported X = Number of Sectors
4Bh	01h	Burst Mode (Synchronous sequential read) support 00 = Not Supported 01 = Supported
4Ch	xxh	Page Mode Type, model dependent 00 = Not Supported 01 = 4 Word Read Page 02 = 8 Read Word Page 03 = 256-Byte Program Page 04 = 512-Byte Program Page
4Dh	00h	ACC (Acceleration) Supply Minimum 00 = Not Supported, 100 mV
4Eh	00h	ACC (Acceleration) Supply Maximum 00 = Not Supported, 100 mV

Table 54. CFI Primary Vendor-Specific Extended Query (Sheet 2 of 2)

Byte Address	Data	Description
4Fh	07h	WP# Protection 01 = Whole Chip 04 = Uniform Device with Bottom WP Protect 05 = Uniform Device with Top WP Protect 07 = Uniform Device with Top or Bottom Write Protect (user select)
50h	01h	Program Suspend 00 = Not Supported 01 = Supported

The Alternate Vendor-Specific Extended Query provides information related to the expanded command set provided by the FL-S family. The alternate query parameters use a format in which each parameter begins with an identifier byte and a parameter length byte. Driver software can check each parameter ID and can use the length value to skip to the next parameter if the parameter is not needed or not recognized by the software.

Table 55. CFI Alternate Vendor-Specific Extended Query Header

Byte Address	Data	Description
51h	41h	Query-unique ASCII string “ALT”
52h	4Ch	
53h	54h	
54h	32h	Major version number = 2, ASCII
55h	30h	Minor version number = 0, ASCII

Table 56. CFI Alternate Vendor-Specific Extended Query Parameter 0

Parameter Relative Byte Address Offset	Data	Description
00h	00h	Parameter ID (Ordering Part Number)
01h	10h	Parameter Length (The number of following bytes in this parameter. Adding this value to the current location value +1 = the first byte of the next parameter)
02h	53h	ASCII “S” for manufacturer (Spansion)
03h	32h	ASCII “25” for Product Characters (Single Die SPI)
04h	35h	
05h	46h	ASCII “FL” for Interface Characters (SPI 3 Volt)
06h	4Ch	
07h	35h (512 Mb)	ASCII characters for density
08h	31h (512 Mb)	
09h	32h (512 Mb)	
0Ah	53h	ASCII “S” for Technology (65nm MirrorBit)

Table 56. CFI Alternate Vendor-Specific Extended Query Parameter 0

Parameter Relative Byte Address Offset	Data	Description
0Bh	xxh	Reserved for Future Use (RFU)
0Ch	xxh	
0Dh	xxh	
0Eh	xxh	
0Fh	xxh	
10h	xxh	
11h	xxh	

Table 57. CFI Alternate Vendor-Specific Extended Query Parameter 80h Address Options

Parameter Relative Byte Address Offset	Data	Description
00h	80h	Parameter ID (Ordering Part Number)
01h	01h	Parameter Length (The number of following bytes in this parameter. Adding this value to the current location value +1 = the first byte of the next parameter)
02h	F0h	Bits 7:4 - Reserved = 1111b Bit 3 - AutoBoot support - Ye s= 0b, No = 1b Bit 2 - 4-byte address instructions supported - Yes = 0b, No = 1b Bit 1 - Bank address + 3-byte address instructions supported - Yes = 0b, No = 1b Bit 0 - 3-byte address instructions supported - Yes = 0b, No = 1b

Table 58. CFI Alternate Vendor-Specific Extended Query Parameter 84h Suspend Commands

Parameter Relative Byte Address Offset	Data	Description
00h	84h	Parameter ID (Suspend Commands
01h	08h	Parameter Length (The number of following bytes in this parameter. Adding this value to the current location value +1 = the first byte of the next parameter)
02h	85h	Program suspend instruction code
03h	28h	Program suspend latency maximum (µs)
04h	8Ah	Program resume instruction code
05h	64h	Program resume to next suspend typical (µs)
06h	75h	Erase suspend instruction code
07h	28h	Erase suspend latency maximum (µs)
08h	7Ah	Erase resume instruction code
09h	64h	Erase resume to next suspend typical (µs)

Table 59. CFI Alternate Vendor-Specific Extended Query Parameter 88h Data Protection

Parameter Relative Byte Address Offset	Data	Description
00h	88h	Parameter ID (Data Protection)
01h	04h	Parameter Length (The number of following bytes in this parameter. Adding this value to the current location value +1 = the first byte of the next parameter)
02h	0Ah	OTP size 2^N bytes, FFh = not supported
03h	01h	OTP address map format, 01h = FL-S format, FFh = not supported
04h	xxh	Block Protect Type, model dependent 00h = FL-P, FL-S, FFh = not supported
05h	xxh	Advanced Sector Protection type, model dependent 01h = FL-S ASP

Table 60. CFI Alternate Vendor-Specific Extended Query Parameter 8Ch Reset Timing

Parameter Relative Byte Address Offset	Data	Description
00h	8Ch	Parameter ID (Reset Timing)
01h	06h	Parameter Length (The number of following bytes in this parameter. Adding this value to the current location value +1 = the first byte of the next parameter)
02h	96h	POR maximum value
03h	01h	POR maximum exponent 2^N µs
04h	23h	Hardware Reset maximum value, FFh = not supported
05h	00h	Hardware Reset maximum exponent 2^N µs
06h	23h	Software Reset maximum value, FFh = not supported
07h	00h	Software Reset maximum exponent 2^N µs

Table 61. CFI Alternate Vendor-Specific Extended Query Parameter 90h - HPLC(SDR)

Parameter Relative Byte Address Offset	Data	Description
00h	90h	Parameter ID (Latency Code Table)
01h	56h	Parameter Length (The number of following bytes in this parameter. Adding this value to the current location value +1 = the first byte of the next parameter)
02h	06h	Number of rows
03h	0Eh	Row length in bytes
04h	46h	Start of header (row 1), ASCII “F” for frequency column header
05h	43h	ASCII “C” for Code column header
06h	03h	Read 3-byte address instruction
07h	13h	Read 4-byte address instruction
08h	0Bh	Read Fast 3-byte address instruction
09h	0Ch	Read Fast 4-byte address instruction
0Ah	3Bh	Read Dual Out 3-byte address instruction
0Bh	3Ch	Read Dual Out 4-byte address instruction

Table 61. CFI Alternate Vendor-Specific Extended Query Parameter 90h - HPLC(SDR) (Continued)

Parameter Relative Byte Address Offset	Data	Description
0Ch	6Bh	Read Quad Out 3-byte address instruction
0Dh	6Ch	Read Quad Out 4-byte address instruction
0Eh	BBh	Dual I/O Read 3-byte address instruction
0Fh	BCh	Dual I/O Read 4-byte address instruction
10h	EBh	Quad I/O Read 3-byte address instruction
11h	ECh	Quad I/O Read 4-byte address instruction
12h	32h	Start of row 2, SCK frequency limit for this row (50 MHz)
13h	03h	Latency Code for this row (11b)
14h	00h	Read mode cycles
15h	00h	Read latency cycles
16h	00h	Read Fast mode cycles
17h	00h	Read Fast latency cycles
18h	00h	Read Dual Out mode cycles
19h	00h	Read Dual Out latency cycles
1Ah	00h	Read Quad Out mode cycles
1Bh	00h	Read Quad Out latency cycles
1Ch	00h	Dual I/O Read mode cycles
1Dh	04h	Dual I/O Read latency cycles
1Eh	02h	Quad I/O Read mode cycles
1Fh	01h	Quad I/O Read latency cycles
20h	50h	Start of row 3, SCK frequency limit for this row (80 MHz)
21h	00h	Latency Code for this row (00b)
22h	FFh	Read mode cycles (FFh = command not supported at this frequency)
23h	FFh	Read latency cycles
24h	00h	Read Fast mode cycles
25h	08h	Read Fast latency cycles
26h	00h	Read Dual Out mode cycles
27h	08h	Read Dual Out latency cycles
28h	00h	Read Quad Out mode cycles
29h	08h	Read Quad Out latency cycles
2Ah	00h	Dual I/O Read mode cycles
2Bh	04h	Dual I/O Read latency cycles
2Ch	02h	Quad I/O Read mode cycles
2Dh	04h	Quad I/O Read latency cycles
2Eh	5Ah	Start of row 4, SCK frequency limit for this row (90 MHz)
2Fh	01h	Latency Code for this row (01b)
30h	FFh	Read mode cycles (FFh = command not supported at this frequency)
31h	FFh	Read latency cycles

Table 61. CFI Alternate Vendor-Specific Extended Query Parameter 90h - HPLC(SDR) (Continued)

Parameter Relative Byte Address Offset	Data	Description
32h	00h	Read Fast mode cycles
33h	08h	Read Fast latency cycles
34h	00h	Read Dual Out mode cycles
35h	08h	Read Dual Out latency cycles
36h	00h	Read Quad Out mode cycles
37h	08h	Read Quad Out latency cycles
38h	00h	Dual I/O Read mode cycles
39h	05h	Dual I/O Read latency cycles
3Ah	02h	Quad I/O Read mode cycles
3Bh	04h	Quad I/O Read latency cycles
3Ch	68h	Start of row 5, SCK frequency limit for this row (104 MHz)
3Dh	02h	Latency Code for this row (10b)
3Eh	FFh	Read mode cycles (FFh = command not supported at this frequency)
3Fh	FFh	Read latency cycles
40h	00h	Read Fast mode cycles
41h	08h	Read Fast latency cycles
42h	00h	Read Dual Out mode cycles
43h	08h	Read Dual Out latency cycles
44h	00h	Read Quad Out mode cycles
45h	08h	Read Quad Out latency cycles
46h	00h	Dual I/O Read mode cycles
47h	06h	Dual I/O Read latency cycles
48h	02h	Quad I/O Read mode cycles
49h	05h	Quad I/O Read latency cycles
4Ah	85h	Start of row 6, SCK frequency limit for this row (133 MHz)
4Bh	02h	Latency Code for this row (10b)
4Ch	FFh	Read mode cycles (FFh = command not supported at this frequency)
4Dh	FFh	Read latency cycles
4Eh	00h	Read Fast mode cycles
4Fh	08h	Read Fast latency cycles
50h	FFh	Read Dual Out mode cycles
51h	FFh	Read Dual Out latency cycles
52h	FFh	Read Quad Out mode cycles
53h	FFh	Read Quad Out latency cycles
54h	FFh	Dual I/O Read mode cycles
55h	FFh	Dual I/O Read latency cycles
56h	FFh	Quad I/O Read mode cycles
57h	FFh	Quad I/O Read latency cycles

Table 62. CFI Alternate Vendor-Specific Extended Query Parameter 9Ah - HPLC DDR (Sheet 1 of 2)

Parameter Relative Byte Address Offset	Data	Description
00h	9Ah	Parameter ID (Latency Code Table)
01h	2Ah	Parameter Length (The number of following bytes in this parameter. Adding this value to the current location value +1 = the first byte of the next parameter)
02h	05h	Number of rows
03h	08h	Row length in bytes
04h	46h	Start of header (row 1), ASCII “F” for frequency column header
05h	43h	ASCII “C” for Code column header
06h	0Dh	Read Fast DDR 3-byte address instruction
07h	0Eh	Read Fast DDR 4-byte address instruction
08h	BDh	DDR Dual I/O Read 3-byte address instruction
09h	BEh	DDR Dual I/O Read 4-byte address instruction
0Ah	EDh	Read DDR Quad I/O 3-byte address instruction
0Bh	EEh	Read DDR Quad I/O 4-byte address instruction
0Ch	32h	Start of row 2, SCK frequency limit for this row (50 MHz)
0Dh	03h	Latency Code for this row (11b)
0Eh	00h	Read Fast DDR mode cycles
0Fh	04h	Read Fast DDR latency cycles
10h	00h	DDR Dual I/O Read mode cycles
11h	04h	DDR Dual I/O Read latency cycles
12h	01h	Read DDR Quad I/O mode cycles
13h	03h	Read DDR Quad I/O latency cycles
14h	42h	Start of row 3, SCK frequency limit for this row (66 MHz)
15h	00h	Latency Code for this row (00b)
16h	00h	Read Fast DDR mode cycles
17h	05h	Read Fast DDR latency cycles
18h	00h	DDR Dual I/O Read mode cycles
19h	06h	DDR Dual I/O Read latency cycles
1Ah	01h	Read DDR Quad I/O mode cycles
1Bh	06h	Read DDR Quad I/O latency cycles
1Ch	42h	Start of row 4, SCK frequency limit for this row (66 MHz)
1Dh	01h	Latency Code for this row (01b)
1Eh	00h	Read Fast DDR mode cycles
1Fh	06h	Read Fast DDR latency cycles
20h	00h	DDR Dual I/O Read mode cycles
21h	07h	DDR Dual I/O Read latency cycles
22h	01h	Read DDR Quad I/O mode cycles
23h	07h	Read DDR Quad I/O latency cycles
24h	42h	Start of row 5, SCK frequency limit for this row (66 MHz)

Table 62. CFI Alternate Vendor-Specific Extended Query Parameter 9Ah - HPLC DDR (Sheet 2 of 2)

Parameter Relative Byte Address Offset	Data	Description
25h	02h	Latency Code for this row (10b)
26h	00h	Read Fast DDR mode cycles
27h	07h	Read Fast DDR latency cycles
28h	00h	DDR Dual I/O Read mode cycles
29h	08h	DDR Dual I/O Read latency cycles
2Ah	01h	Read DDR Quad I/O mode cycles
2Bh	08h	Read DDR Quad I/O latency cycles

Table 63. CFI Alternate Vendor-Specific Extended Query Parameter 90h - EHPLC (SDR)

Parameter Relative Byte Address Offset	Data	Description
00h	90h	Parameter ID (Latency Code Table)
01h	56h	Parameter Length (The number of following bytes in this parameter. Adding this value to the current location value +1 = the first byte of the next parameter)
02h	06h	Number of rows
03h	0Eh	Row length in bytes
04h	46h	Start of header (row 1), ASCII “F” for frequency column header
05h	43h	ASCII “C” for Code column header
06h	03h	Read 3-byte address instruction
07h	13h	Read 4-byte address instruction
08h	0Bh	Read Fast 3-byte address instruction
09h	0Ch	Read Fast 4-byte address instruction
0Ah	3Bh	Read Dual Out 3-byte address instruction
0Bh	3Ch	Read Dual Out 4-byte address instruction
0Ch	6Bh	Read Quad Out 3-byte address instruction
0Dh	6Ch	Read Quad Out 4-byte address instruction
0Eh	BBh	Dual I/O Read 3-byte address instruction
0Fh	BCh	Dual I/O Read 4-byte address instruction
10h	EBh	Quad I/O Read 3-byte address instruction
11h	ECh	Quad I/O Read 4-byte address instruction
12h	32h	Start of row 2, SCK frequency limit for this row (50 MHz)
13h	03h	Latency Code for this row (11b)
14h	00h	Read mode cycles
15h	00h	Read latency cycles
16h	00h	Read Fast mode cycles
17h	00h	Read Fast latency cycles
18h	00h	Read Dual Out mode cycles
19h	00h	Read Dual Out latency cycles

Table 63. CFI Alternate Vendor-Specific Extended Query Parameter 90h - EHPLC (SDR) (Continued)

Parameter Relative Byte Address Offset	Data	Description
1Ah	00h	Read Quad Out mode cycles
1Bh	00h	Read Quad Out latency cycles
1Ch	04h	Dual I/O Read mode cycles
1Dh	00h	Dual I/O Read latency cycles
1Eh	02h	Quad I/O Read mode cycles
1Fh	01h	Quad I/O Read latency cycles
20h	50h	Start of row 3, SCK frequency limit for this row (80 MHz)
21h	00h	Latency Code for this row (00b)
22h	FFh	Read mode cycles (FFh = command not supported at this frequency)
23h	FFh	Read latency cycles
24h	00h	Read Fast mode cycles
25h	08h	Read Fast latency cycles
26h	00h	Read Dual Out mode cycles
27h	08h	Read Dual Out latency cycles
28h	00h	Read Quad Out mode cycles
29h	08h	Read Quad Out latency cycles
2Ah	04h	Dual I/O Read mode cycles
2Bh	00h	Dual I/O Read latency cycles
2Ch	02h	Quad I/O Read mode cycles
2Dh	04h	Quad I/O Read latency cycles
2Eh	5Ah	Start of row 4, SCK frequency limit for this row (90 MHz)
2Fh	01h	Latency Code for this row (01b)
30h	FFh	Read mode cycles (FFh = command not supported at this frequency)
31h	FFh	Read latency cycles
32h	00h	Read Fast mode cycles
33h	08h	Read Fast latency cycles
34h	00h	Read Dual Out mode cycles
35h	08h	Read Dual Out latency cycles
36h	00h	Read Quad Out mode cycles
37h	08h	Read Quad Out latency cycles
38h	04h	Dual I/O Read mode cycles
39h	01h	Dual I/O Read latency cycles
3Ah	02h	Quad I/O Read mode cycles
3Bh	04h	Quad I/O Read latency cycles
3Ch	68h	Start of row 5, SCK frequency limit for this row (104 MHz)
3Dh	02h	Latency Code for this row (10b)
3Eh	FFh	Read mode cycles (FFh = command not supported at this frequency)
3Fh	FFh	Read latency cycles

Table 63. CFI Alternate Vendor-Specific Extended Query Parameter 90h - EHPLC (SDR) (Continued)

Parameter Relative Byte Address Offset	Data	Description
40h	00h	Read Fast mode cycles
41h	08h	Read Fast latency cycles
42h	00h	Read Dual Out mode cycles
43h	08h	Read Dual Out latency cycles
44h	00h	Read Quad Out mode cycles
45h	08h	Read Quad Out latency cycles
46h	04h	Dual I/O Read mode cycles
47h	02h	Dual I/O Read latency cycles
48h	02h	Quad I/O Read mode cycles
49h	05h	Quad I/O Read latency cycles
4Ah	85h	Start of row 6, SCK frequency limit for this row (133 MHz)
4Bh	02h	Latency Code for this row (10b)
4Ch	FFh	Read mode cycles (FFh = command not supported at this frequency)
4Dh	FFh	Read latency cycles
4Eh	00h	Read Fast mode cycles
4Fh	08h	Read Fast latency cycles
50h	FFh	Read Dual Out mode cycles
51h	FFh	Read Dual Out latency cycles
52h	FFh	Read Quad Out mode cycles
53h	FFh	Read Quad Out latency cycles
54h	FFh	Dual I/O Read mode cycles
55h	FFh	Dual I/O Read latency cycles
56h	FFh	Quad I/O Read mode cycles
57h	FFh	Quad I/O Read latency cycles

Table 64. CFI Alternate Vendor-Specific Extended Query Parameter 9Ah - EHPLC DDR (Sheet 1 of 2)

Parameter Relative Byte Address Offset	Data	Description
00h	9Ah	Parameter ID (Latency Code Table)
01h	2Ah	Parameter Length (The number of following bytes in this parameter. Adding this value to the current location value +1 = the first byte of the next parameter)
02h	05h	Number of rows
03h	08h	Row length in bytes
04h	46h	Start of header (row 1), ASCII “F” for frequency column header
05h	43h	ASCII “C” for Code column header
06h	0Dh	Read Fast DDR 3-byte address instruction
07h	0Eh	Read Fast DDR 4-byte address instruction
08h	BDh	DDR Dual I/O Read 3-byte address instruction

Table 64. CFI Alternate Vendor-Specific Extended Query Parameter 9Ah - EHPLC DDR (Sheet 2 of 2)

Parameter Relative Byte Address Offset	Data	Description
09h	BEh	DDR Dual I/O Read 4-byte address instruction
0Ah	EDh	Read DDR Quad I/O 3-byte address instruction
0Bh	EEh	Read DDR Quad I/O 4-byte address instruction
0Ch	32h	Start of row 2, SCK frequency limit for this row (50 MHz)
0Dh	03h	Latency Code for this row (11b)
0Eh	04h	Read Fast DDR mode cycles
0Fh	01h	Read Fast DDR latency cycles
10h	02h	DDR Dual I/O Read mode cycles
11h	02h	DDR Dual I/O Read latency cycles
12h	01h	Read DDR Quad I/O mode cycles
13h	03h	Read DDR Quad I/O latency cycles
14h	42h	Start of row 3, SCK frequency limit for this row (66 MHz)
15h	00h	Latency Code for this row (00b)
16h	04h	Read Fast DDR mode cycles
17h	02h	Read Fast DDR latency cycles
18h	02h	DDR Dual I/O Read mode cycles
19h	04h	DDR Dual I/O Read latency cycles
1Ah	01h	Read DDR Quad I/O mode cycles
1Bh	06h	Read DDR Quad I/O latency cycles
1Ch	42h	Start of row 4, SCK frequency limit for this row (66 MHz)
1Dh	01h	Latency Code for this row (01b)
1Eh	04h	Read Fast DDR mode cycles
1Fh	04h	Read Fast DDR latency cycles
20h	02h	DDR Dual I/O Read mode cycles
21h	05h	DDR Dual I/O Read latency cycles
22h	01h	Read DDR Quad I/O mode cycles
23h	07h	Read DDR Quad I/O latency cycles
24h	42h	Start of row 5, SCK frequency limit for this row (66 MHz)
25h	02h	Latency Code for this row (10b)
26h	04h	Read Fast DDR mode cycles
27h	05h	Read Fast DDR latency cycles
28h	02h	DDR Dual I/O Read mode cycles
29h	06h	DDR Dual I/O Read latency cycles
2Ah	01h	Read DDR Quad I/O mode cycles
2Bh	08h	Read DDR Quad I/O latency cycles

Table 65. CFI Alternate Vendor-Specific Extended Query Parameter F0h RFU

Parameter Relative Byte Address Offset	Data	Description
00h	F0h	Parameter ID (RFU)
01h	0Fh	Parameter Length (The number of following bytes in this parameter. Adding this value to the current location value +1 = the first byte of the next parameter)
02h	FFh	RFU
...	FFh	RFU
10h	FFh	RFU

Table 66. CFI Alternate Vendor-Specific Extended Query Parameter A5h, JEDEC SFDP Rev B

CFI Parameter Relative Byte Address Offset	SFDP Parameter Relative Byte Address Offset	SFDP Dword Name	Data	Description
00h	—	N/A	A5h	CFI Parameter ID (JEDEC SFDP)
01h	—	N/A	50h	CFI Parameter Length (The number of following bytes in this parameter. Adding this value to the current location value +1 = the first byte of the next parameter)
02h	00h	JEDEC Basic Flash Parameter Dword-1	E7h	Start of SFDP JEDEC parameter, located at 1120h in the overall SFDP address space. Bits 7:5 = unused = 111b Bit 4:3 = 06h is status register write instruction & status register is default nonvolatile= 00b Bit 2 = Program Buffer > 64Bytes = 1 Bits 1:0 = Uniform 4KB erase unavailable = 11b
03h	01h		FFh	Bits 15:8 = Uniform 4KB erase opcode = not supported = FFh
04h	02h		F3h (FLxxxSAG) F7h (FLxxxSDP)	Bit 23 = Unused = 1b Bit 22 = Supports Quad Out Read = Yes = 1b Bit 21 = Supports Quad I/O Read = Yes =1b Bit 20 = Supports Dual I/O Read = Yes = 1b Bit19 = Supports DDR 0= No, 1 = Yes Bit 18:17 = Number of Address Bytes, 3 or 4 = 01b Bit 16 = Supports Dual Out Read = Yes = 1b
05h	03h		FFh	Bits 31:24 = Unused = FFh
06h	04h	JEDEC Basic Flash Parameter Dword-2	FFh	Density in bits, zero based, 512Mb = 1FFFFFFFh
07h	05h		FFh	
08h	06h		FFh	
09h	07h		1Fh	
0Ah	08h	JEDEC Basic Flash Parameter Dword-3	44h	Bits 7:5 = number of Quad I/O Mode cycles = 010b Bits 4:0 = number of Quad I/O Dummy cycles = 00100b for default latency code 00b
0Bh	09h		EBh	Quad I/O instruction code
0Ch	0Ah		08h	Bits 23:21 = number of Quad Out Mode cycles = 000b Bits 20:16 = number of Quad Out Dummy cycles = 01000b
0Dh	0Bh		6Bh	Quad Out instruction code

Table 66. CFI Alternate Vendor-Specific Extended Query Parameter A5h, JEDEC SFDP Rev B (Continued)

CFI Parameter Relative Byte Address Offset	SFDP Parameter Relative Byte Address Offset	SFDP Dword Name	Data	Description
0Eh	0Ch	JEDEC Basic Flash Parameter Dword-4	08h	Bits 7:5 = number of Dual Out Mode cycles = 000b Bits 4:0 = number of Dual Out Dummy cycles = 01000b for default latency code
0Fh	0Dh		3Bh	Dual Out instruction code
10h	0Eh		04h (HPLC) 80h (EHPLC)	Bits 23:21 = number of Dual I/O Mode cycles = 100b for EHPLC or 000b for HPLC Bits 20:16 = number of Dual I/O Dummy cycles = 00000b for EHPLC or 00100b for HPLC Default Latency code = 00b
11h	0Fh		BBh	Dual I/O instruction code
12h	10h	JEDEC Basic Flash Parameter Dword-5	EEh	Bits 7:5 RFU = 111b Bit 4 = Quad All supported = No = 0b Bits 3:1 RFU = 111b Bit 0 = Dual All not supported = 0b
13h	11h		FFh	Bits 15:8 = RFU = FFh
14h	12h		FFh	Bits 23:16 = RFU = FFh
15h	13h		FFh	Bits 31:24 = RFU = FFh
16h	14h	JEDEC Basic Flash Parameter Dword-6	FFh	Bits 7:0 = RFU = FFh
17h	15h		FFh	Bits 15:8 = RFU = FFh
18h	16h		FFh	Bits 23:21 = number of Dual All Mode cycles = 111b Bits 20:16 = number of Dual All Dummy cycles = 11111b
19h	17h		FFh	Dual All instruction code
1Ah	18h	JEDEC Basic Flash Parameter Dword-7	FFh	Bits 7:0 = RFU = FFh
1Bh	19h		FFh	
1Ch	1Ah		FFh	Bits 15:8 = RFU = FFh
1Dh	1Bh		EBh	Bits 23:21 = number of Quad All Mode cycles = 111b Bits 20:16 = number of Quad All Dummy cycles = 11111b
1Eh	1Ch	JEDEC Basic Flash Parameter Dword-8	00h	Quad All mode Quad I/O (4-4-4) instruction code
1Fh	1Dh		FFh	Erase type 1 instruction = not supported = FFh
20h	1Eh		00h	Erase type 2 size 2^N Bytes = not supported = 00h
21h	1Fh		FFh	Erase type 2 instruction = not supported = FFh
22h	20h	JEDEC Basic Flash Parameter Dword-9	12h	Erase type 3 size 2^N Bytes = 256KB = 12h
23h	21h		D8h	Erase type 3 instruction
24h	22h		00h	Erase type 4 size 2^N Bytes = not supported = 00h
25h	23h		FFh	Erase type 4 instruction = not supported = FFh

Table 66. CFI Alternate Vendor-Specific Extended Query Parameter A5h, JEDEC SFDP Rev B (Continued)

CFI Parameter Relative Byte Address Offset	SFDP Parameter Relative Byte Address Offset	SFDP Dword Name	Data	Description
26h	24h	JEDEC Basic Flash Parameter Dword-10	F2h	Bits 31:30 = Erase type 4 Erase, Typical time units (00b: 1 ms, 01b: 16 ms, 10b: 128 ms, 11b: 1 s) = RFU = 11b Bits 29:25 = Erase type 4 Erase, Typical time count = RFU = 11111b (typ erase time = count +1 * units = RFU) Bits 24:23 = Erase type 3 Erase, Typical time units (00b: 1 ms, 01b: 16 ms, 10b: 128 ms, 11b: 1 s) = 128mS = 10b Bits 22:18 = Erase type 3 Erase, Typical time count = 00011b (typ erase time = count +1 * units = 4*128mS = 512mS) Bits 17:16 = Erase type 2 Erase, Typical time units (00b: 1 ms, 01b: 16 ms, 10b: 128 ms, 11b: 1 s) = RFU = 11b Bits 15:11 = Erase type 2 Erase, Typical time count = RFU = 11111b (typ erase time = count +1 * units = RFU) Bits 10:9 = Erase type 1 Erase, Typical time units (00b: 1 ms, 01b: 16 ms, 10b: 128 ms, 11b: 1 s) = RFU = 11b Bits 8:4 = Erase type 1 Erase, Typical time count = RFU = 11111b (typ erase time = count +1 * units = RFU) Bits 3:0 = Multiplier from typical erase time to maximum erase time = 2*(N+1), N=2h = 6x multiplier Binary Fields: 11-11111-10-00011-11-11111-11-11111-0010 Nibble Format: 1111_1111_0000_1111_1111_1111_1111_0010 Hex Format: FF_0F_FF_F2
27h	25h		FFh	
28h	26h		0Fh	
29h	27h		FFh	
2Ah	28h	JEDEC Basic Flash Parameter Dword-11	91h	Bit 31 Reserved = 1b Bits 30:29 = Chip Erase, Typical time units (00b: 16 ms, 01b: 256 ms, 10b: 4 s, 11b: 64 s) = 4s = 10b Bits 28:24 = Chip Erase, Typical time count, (count+1)*units, count = 11001b, (typ Program time = count +1 * units = 26*.4uS = 104S Bits 23 = Byte Program Typical time, additional byte units (0b:1uS, 1b:8uS) = 1uS = 0b Bits 22:19 = Byte Program Typical time, additional byte count, (count+1)*units, count = 0000b, (typ Program time = count +1 * units = 1*1uS = 1uS Bits 18 = Byte Program Typical time, first byte units (0b:1uS, 1b:8uS) = 8uS = 1b Bits 17:14 = Byte Program Typical time, first byte count, (count+1)*units, count = 1100b, (typ Program time = count +1 * units = 13*8uS = 104uS Bits 13 = Page Program Typical time units (0b:8uS, 1b:64uS) = 64uS = 1b Bits 12:8 = Page Program Typical time count, (count+1)*units, count = 00101b, (typ Program time = count +1 * units =6*64uS = 384uS) Bits 7:4 = Page size 2^N, N=9h, = 512B page Bits 3:0 = Multiplier from typical time to maximum for Page or Byte program = 2*(N+1), N=1h = 4x multiplier Binary Fields: 1-10-11001-0-0000-1-1100-1-00101-1001-0001 Nibble Format: 1101_1001_0000_0111_0010_0101_1001_0001 Hex Format: D9_07_25_91
2Bh	29h		25h	
2Ch	2Ah		07h	
2Dh	2Bh		D9h	

Table 66. CFI Alternate Vendor-Specific Extended Query Parameter A5h, JEDEC SFDP Rev B (Continued)

CFI Parameter Relative Byte Address Offset	SFDP Parameter Relative Byte Address Offset	SFDP Dword Name	Data	Description
2Eh	2Ch	JEDEC Basic Flash Parameter Dword-12	ECh	Bit 31 = Suspend and Resume supported = 0b Bits 30:29 = Suspend in-progress erase max latency units (00b: 128ns, 01b: 1us, 10b: 8us, 11b: 64us) = 8us= 10b Bits 28:24 = Suspend in-progress erase max latency count = 00101b, max erase suspend latency = count +1 * units = 6*8uS = 48uS Bits 23:20 = Erase resume to suspend interval count = 0001b, interval = count +1 * 64us = 2 * 64us = 128us Bits 19:18 = Suspend in-progress program max latency units (00b: 128ns, 01b: 1us, 10b: 8us, 11b: 64us) = 8us= 10b Bits 17:13 = Suspend in-progress program max latency count = 00100b, max erase suspend latency = count +1 * units = 5*8uS = 40uS Bits 12:9 = Program resume to suspend interval count = 0001b, interval = count +1 * 64us = 2 * 64us = 128us Bit 8 = RFU = 1b Bits 7:4 = Prohibited operations during erase suspend = xxx0b: May not initiate a new erase anywhere (erase nesting not permitted) + xx1xb: May not initiate a page program in the erase suspended sector size + x1xxb: May not initiate a read in the erase suspended sector size + 1xxxb: The erase and program restrictions in bits 5:4 are sufficient = 1110b Bits 3:0 = Prohibited Operations During Program Suspend = xxx0b: May not initiate a new erase anywhere (erase nesting not permitted) + xx0xb: May not initiate a new page program anywhere (program nesting not permitted) + x1xxb: May not initiate a read in the program suspended page size + 1xxxb: The erase and program restrictions in bits 1:0 are sufficient = 1100b Binary Fields: 0-10-00101-0001-10-00100-0001-1-1110-1100 Nibble Format: 0100_0101_0001_1000_1000_0011_1110_1100 Hex Format: 45_18_83_EC
2Fh	2Dh		83h	
30h	2Eh		18h	
31h	2Fh		45h	
32h	30h	JEDEC Basic Flash Parameter Dword-13	8Ah	Bits 31:24 = Erase Suspend Instruction = 75h Bits 23:16 = Erase Resume Instruction = 7Ah Bits 15:8 = Program Suspend Instruction = 85h Bits 7:0 = Program Resume Instruction = 8Ah
33h	31h		85h	
34h	32h		7Ah	
35h	33h		75h	
36h	34h	JEDEC Basic Flash Parameter Dword-14	F7h	Bit 31 = Deep Power Down Supported = not supported = 1 Bits 30:23 = Enter Deep Power Down Instruction = not supported = FFh Bits 22:15 = Exit Deep Power Down Instruction = not supported = FFh Bits 14:13 = Exit Deep Power Down to next operation delay units = (00b: 128ns, 01b: 1us, 10b: 8us, 11b: 64us) = 64us = 11b Bits 12:8 = Exit Deep Power Down to next operation delay count = 11111b, Exit Deep Power Down to next operation delay = (count+1)*units = not supported Bits 7:4 = RFU = Fh Bit 3:2 = Status Register Polling Device Busy = 01b: Legacy status polling supported = Use legacy polling by reading the Status Register with 05h instruction and checking WIP bit[0] (0=ready; 1=busy). Bits 1:0 = RFU = 11b Binary Fields: 1-11111111-11111111-11-11111-1111-01-11 Nibble Format: 1111_1111_1111_1111_1111_1111_1111_0111 Hex Format: FF_FF_FF_F7
37h	35h		FFh	
38h	36h		FFh	
39h	37h		FFh	

Table 66. CFI Alternate Vendor-Specific Extended Query Parameter A5h, JEDEC SFDP Rev B (Continued)

CFI Parameter Relative Byte Address Offset	SFDP Parameter Relative Byte Address Offset	SFDP Dword Name	Data	Description
3Ah	38h	JEDEC Basic Flash Parameter Dword-15	00h	Bits 31:24 = RFU = FFh Bit 23 = Hold and WP Disable = not supported = 0b Bits 22:20 = Quad Enable Requirements = 101b: QE is bit 1 of the status register 2. Status register 1 is read using Read Status instruction 05h. Status register 2 is read using instruction 35h. QE is set via Write Status instruction 01h with two data bytes where bit 1 of the second byte is one. It is cleared via Write Status with two data bytes where bit 1 of the second byte is zero. Bits 19:16 0-4-4 Mode Entry Method = xxx1b: Mode Bits[7:0] = A5h Note QE must be set prior to using this mode + x1xxb: Mode Bits[7:0] = Axh + 1xxxb: RFU = 1101b Bits 15:10 0-4-4 Mode Exit Method = xx_xxx1b: Mode Bits[7:0] = 00h will terminate this mode at the end of the current read operation + xx_1xxxb: Input Fh (mode bit reset) on DQ0-DQ3 for 8 clocks. This will terminate the mode prior to the next read operation. + x1_xxxxb: Mode Bit[7:0] != Axh + 1x_x1xx: RFU
3Bh	39h		F6h	
3Ch	3Ah		5Dh	
3Dh	3Bh		FFh	
3Eh	3Ch	JEDEC Basic Flash Parameter Dword-16	F0h	Bits 31:24 = Enter 4-Byte Addressing = xxxx_1xxxb: 8-bit volatile bank register used to define A[30:A24] bits. MSB (bit[7]) is used to enable/disable 4-byte address mode. When MSB is set to '1', 4-byte address mode is active and A[30:24] bits are don't care. Read with instruction 16h. Write instruction is 17h with 1 byte of data. When MSB is cleared to '0', select the active 128 Mbit segment by setting the appropriate A[30:24] bits and use 3-Byte addressing. + xx1x_xxxxb: Supports dedicated 4-Byte address instruction set. Consult vendor data sheet for the instruction set definition or look for 4 Byte Address Parameter Table. + 1xxx_xxxxb: Reserved = 10101000b Bits 23:14 = Exit 4-Byte Addressing = xx_xxxx_1xxxb: 8-bit volatile bank register used to define A[30:A24] bits. MSB (bit[7]) is used to enable/disable 4-byte address mode. When MSB is cleared to '0', 3-byte address mode is active and A30:A24 are used to select the active 128 Mbit memory segment. Read with instruction 16h. Write instruction is 17h, data length is 1 byte. + xx_xx1x_xxxxb: Hardware reset + xx_x1xx_xxxxb: Software reset (see bits 13:8 in this DWORD) + xx_1xxx_xxxxb: Power cycle + x1_xxxx_xxxxb: Reserved + 1x_xxxx_xxxxb: Reserved = 1111101000b Bits 13:8 = Soft Reset and Rescue Sequence Support = x0_1xxxb: issue instruction F0h + 1x_xxxxb: exit 0-4-4 mode is required prior to other reset sequences above if the device may be operating in this mode. = 101000b Bit 7 = RFU = 1 Bits 6:0 = Volatile or Nonvolatile Register and Write Enable Instruction for Status Register 1 = xx1_xxxxb: Status Register 1 contains a mix of volatile and nonvolatile bits. The 06h instruction is used to enable writing of the register. + x1x_xxxxb: Reserved + 1xx_xxxxb: Reserved = 1110000b Binary Fields: 10101000-1111101000-101000-1-1110000 Nibble Format: 1010_1000_1111_1010_0010_1000_1111_0000 Hex Format: A8_FA_28_F0
3Fh	3Dh		28h	
40h	3Eh		FAh	
41h	3Fh		A8h	
42h	40h	JEDEC Sector Map Parameter Dword-1 Config-0 Header	FFh	Bits 31:24 = RFU = FFh Bits 23:16 = Region count (Dwords -1) = 00h: One region Bits 15:8 = Configuration ID = 00h: Uniform 256KB sectors Bits 7:2 = RFU = 111111b Bit 1 = Map Descriptor = 1 Bit 0 = The end descriptor = 1
43h	41h		00h	
44h	42h		00h	
45h	43h		FFh	

Table 66. CFI Alternate Vendor-Specific Extended Query Parameter A5h, JEDEC SFDP Rev B (Continued)

CFI Parameter Relative Byte Address Offset	SFDP Parameter Relative Byte Address Offset	SFDP Dword Name	Data	Description
46h	44h	JEDEC Sector Map Parameter Dword-2 Config-0 Region-0	F4h	Bits 31:8 = Region size = 00FFFFh: Region size as count-1 of 256 Byte units = 64MB/256 = 256K Count = 262144, value = count -1 = 262144 - 1 = 262143 = 3FFFFh Bits 4:7 = RFU = Fh Erase Type not supported = 0/ supported = 1 Bits 3 = Erase Type 4 support = 0b ---Erase Type 4 is not defined Bits 2 = Erase Type 3 support = 1b ---Erase Type 3 is 256KB erase and is supported in the 256KB sector region Bits 1 = Erase Type 2 support = 0b ---Erase Type 2 is 64KB erase and is not supported in the 256KB sector region Bits 0 = Erase Type 1 support = 0b --- Erase Type 1 is 4KB erase and is not supported in the 256KB sector region Format: 0000_0011_1111_1111_1111_1111_1111_0100 Hex Format: 03_FF_FF_F4
47h	45h		FFh	
48h	46h		FFh	
49h	47h		03h	
4Ah	48h	JEDEC 4 Byte Address Instructions Parameter Dword-1	FFh	Supported = 1, Not Supported = 0 Bits 31:20 = RFU = FFFh Bit 19 = Support for nonvolatile individual sector lock write command, Instruction=E3h = 1 Bit 18 = Support for nonvolatile individual sector lock read command, Instruction=E2h = 1 Bit 17 = Support for volatile individual sector lock Write command, Instruction=E1h = 1 Bit 16 = Support for volatile individual sector lock Read command, Instruction=E0h = 1 Bit 15 = Support for (1-4-4) DTR_Read Command, Instruction=EEh = 1 Bit 14 = Support for (1-2-2) DTR_Read Command, Instruction=BEh = 1 Bit 13 = Support for (1-1-1) DTR_Read Command, Instruction=0Eh = 1 Bit 12 = Support for Erase Command – Type 4 = 0 Bit 11 = Support for Erase Command – Type 3 = 1 Bit 10 = Support for Erase Command – Type 2 = 0 Bit 9 = Support for Erase Command – Type 1 = 0 Bit 8 = Support for (1-4-4) Page Program Command, Instruction=3Eh =0 Bit 7 = Support for (1-1-4) Page Program Command, Instruction=34h = 1 Bit 6 = Support for (1-1-1) Page Program Command, Instruction=12h = 1 Bit 5 = Support for (1-4-4) FAST_READ Command, Instruction=ECh = 1 Bit 4 = Support for (1-1-4) FAST_READ Command, Instruction=6Ch = 1 Bit 3 = Support for (1-2-2) FAST_READ Command, Instruction=BCh = 1 Bit 2 = Support for (1-1-2) FAST_READ Command, Instruction=3Ch = 1 Bit 1 = Support for (1-1-1) FAST_READ Command, Instruction=0Ch = 1 Bit 0 = Support for (1-1-1) READ Command, Instruction=13h = 1
4Bh	49h		E8h	
4Ch	4Ah		FFh	
4Dh	4Bh		FFh	
4Eh	4Ch	JEDEC 4 Byte Address Instructions Parameter Dword-2	FFh	Bits 31:24 = FFh = Instruction for Erase Type 4: RFU Bits 23:16 = DCh = Instruction for Erase Type 3 Bits 15:8 = FFh = Instruction for Erase Type 2: RFU Bits 7:0 = FFh = Instruction for Erase Type 1: RFU
4Fh	4Dh		FFh	
50h	4Eh		DCh	
51h	4Fh		FFh	

This parameter type (Parameter ID F0h) may appear multiple times and have a different length each time. The parameter is used to reserve space in the ID-CFI map or to force space (pad) to align a following parameter to a required boundary.

11.4 Registers

The register maps are copied in this section as a quick reference. See Registers on page 48 for the full description of the register contents.

Table 67. Status Register-1 (SR1)

Bits	Field Name	Function	Type	Default State	Description
7	SRWD	Status Register Write Disable	Nonvolatile	0	1 = Locks state of SRWD, BP, and configuration register bits when WP# is low by ignoring WRR command 0 = No protection, even when WP# is low
6	P_ERR	Programming Error Occurred	Volatile, Read only	0	1 = Error occurred 0 = No Error
5	E_ERR	Erase Error Occurred	Volatile, Read only	0	1= Error occurred 0 = No Error
4	BP2	Block Protection	Volatile if CR1[3]=1, Nonvolatile if CR1[3]=0	1 if CR1[3]=1, 0 when shipped from Cypress	Protects selected range of sectors (Block) from Program or Erase
3	BP1				
2	BP0				
1	WEL	Write Enable Latch	Volatile	0	1 = Device accepts Write Registers (WRR), program or erase commands 0 = Device ignores Write Registers (WRR), program or erase commands This bit is not affected by WRR, only WREN and WRDI commands affect this bit.
0	WIP	Write in Progress	Volatile, Read only	0	1= Device Busy, a Write Registers (WRR), program, erase or other operation is in progress 0 = Ready Device is in standby mode and can accept commands

Table 68. Configuration Register (CR1)

Bits	Field Name	Function	Type	Default State	Description
7	LC1	Latency Code	Nonvolatile	0	Selects number of initial read latency cycles See Latency Code Tables
6	LC0			0	
5	TBPROT	Configures Start of Block Protection	OTP	0	1 = BP starts at bottom (Low address) 0 = BP starts at top (High address)
4	RFU	RFU	RFU	0	Reserved for Future Use
3	BPNV	Configures BP2-0 in Status Register	OTP	0	1 = Volatile 0 = Nonvolatile
2	RFU	RFU	RFU	0	Reserved for Future Use
1	QUAD	Puts the device into Quad I/O operation	Nonvolatile	0	1 = Quad 0 = Dual or Serial
0	FREEZE	Lock current state of BP2-0 bits in Status Register, TBPROT in Configuration Register, and OTP regions	Volatile	0	1 = Block Protection and OTP locked 0 = Block Protection and OTP un-locked

Table 69. Status Register-2 (SR2)

Bits	Field Name	Function	Type	Default State	Description
7	RFU	Reserved	–	0	Reserved for Future Use
6	RFU	Reserved	–	0	Reserved for Future Use
5	RFU	Reserved	–	0	Reserved for Future Use
4	RFU	Reserved	–	0	Reserved for Future Use
3	RFU	Reserved	–	0	Reserved for Future Use
2	RFU	Reserved	–	0	Reserved for Future Use
1	ES	Erase Suspend	Volatile, Read only	0	1 = In erase suspend mode. 0 = Not in erase suspend mode.
0	PS	Program Suspend	Volatile, Read only	0	1 = In program suspend mode. 0 = Not in program suspend mode.

Table 70. Bank Address Register (BAR)

Bits	Field Name	Function	Type	Default State	Description
7	EXTADD	Extended Address Enable	Volatile	0b	1 = 4-byte (32-bits) addressing required from command. 0 = 3-byte (24-bits) addressing from command + Bank Address
6 to 2	RFU	Reserved	Volatile	00000b	Reserved for Future Use
1	BA25	Bank Address	Volatile	0	A25 for 512 Mb device
0	RFU	Bank Address	Volatile	0	RFU for lower density device

Table 71. ASP Register (ASPR)

Bits	Field Name	Function	Type	Default State	Description
15 to 9	RFU	Reserved	OTP	1	Reserved for Future Use
8	RFU	Reserved	OTP	(Note 1)	Reserved for Future Use
7	RFU	Reserved	OTP	(Note 1)	Reserved for Future Use
6	RFU	Reserved	OTP	1	Reserved for Future Use
5	RFU	Reserved	OTP	(Note 1)	Reserved for Future Use
4	RFU	Reserved	OTP	(Note 1)	Reserved for Future Use
3	RFU	Reserved	OTP	(Note 1)	Reserved for Future Use
2	PWDMLB	Password Protection Mode Lock Bit	OTP	1	0 = Password Protection Mode permanently enabled. 1 = Password Protection Mode not permanently enabled.
1	PSTMLB	Persistent Protection Mode Lock Bit	OTP	1	0 = Persistent Protection Mode permanently enabled. 1 = Persistent Protection Mode not permanently enabled.
0	RFU	Reserved	OTP	1	Reserved for Future Use

Note
1. Default value depends on ordering part number, see Initial Delivery State on page 140.

Table 72. Password Register (PASS)

Bits	Field Name	Function	Type	Default State	Description
63 to 0	PWD	Hidden Password	OTP	FFFFFFFF-FFFFFFFFh	Nonvolatile OTP storage of 64-bit password. The password is no longer readable after the password protection mode is selected by programming ASP register bit 2 to zero.

Table 73. PPB Lock Register (PPBL)

Bits	Field Name	Function	Type	Default State	Description
7 to 1	RFU	Reserved	Volatile	00h	Reserved for Future Use
0	PPBLOCK	Protect PPB Array	Volatile	Persistent Protection Mode = 1 Password Protection Mode = 0	0 = PPB array protected until next power cycle or hardware reset 1 = PPB array may be programmed or erased

Table 74. PPB Access Register (PPBAR)

Bits	Field Name	Function	Type	Default State	Description
7 to 0	PPB	Read or Program per sector PPB	Nonvolatile	FFh	00h = PPB for the sector addressed by the PPBRD or PPBP command is programmed to ‘0’, protecting that sector from program or erase operations. FFh = PPB for the sector addressed by the PPBRD or PPBP command is erased to ‘1’, not protecting that sector from program or erase operations.

Table 75. DYB Access Register (DYBAR)

Bits	Field Name	Function	Type	Default State	Description
7 to 0	DYB	Read or Write per sector DYB	Volatile	FFh	00h = DYB for the sector addressed by the DYBRD or DYBP command is cleared to ‘0’, protecting that sector from program or erase operations. FFh = DYB for the sector addressed by the DYBRD or DYBP command is set to ‘1’, not protecting that sector from program or erase operations.

Table 76. Nonvolatile Data Learning Register (NVDLR)

Bits	Field Name	Function	Type	Default State	Description
7 to 0	NVDLP	Nonvolatile Data Learning Pattern	OTP	00h	OTP value that may be transferred to the host during DDR read command latency (dummy) cycles to provide a training pattern to help the host more accurately center the data capture point in the received data bits.

Table 77. Volatile Data Learning Register (NVDLR)

Bits	Field Name	Function	Type	Default State	Description
7 to 0	VDLP	Volatile Data Learning Pattern	Volatile	Takes the value of NVDLR during POR or Reset	Volatile copy of the NVDLP used to enable and deliver the Data Learning Pattern (DLP) to the outputs. The VDLP may be changed by the host during system operation.

11.5 Initial Delivery State

The device is shipped from Cypress with nonvolatile bits set as follows:

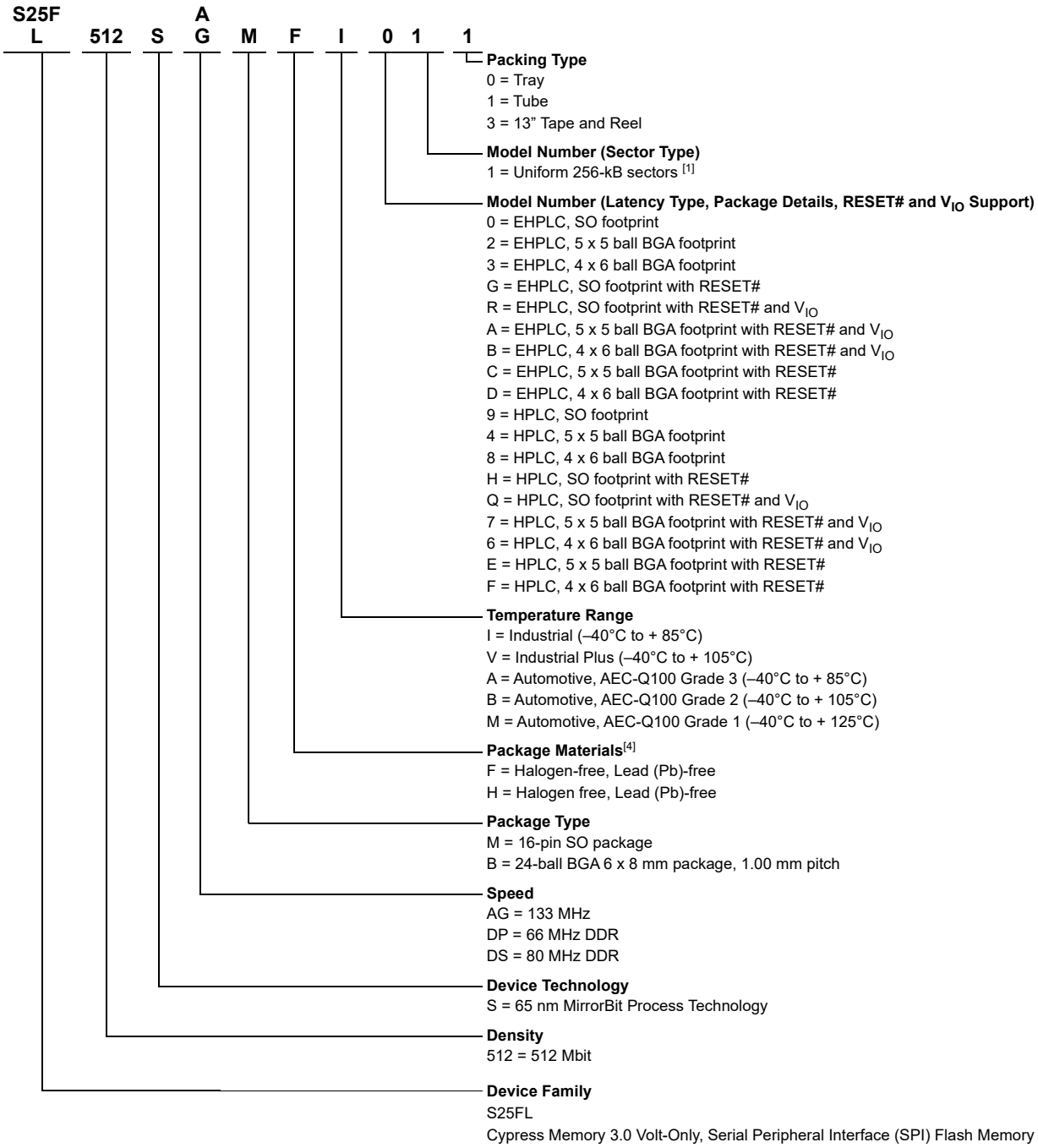
- The entire memory array is erased: i.e. all bits are set to 1 (each byte contains FFh).
- The OTP address space has the first 16 bytes programmed to a random number. All other bytes are erased to FFh.
- The SFDP address space contains the values as defined in the description of the SFDP address space.
- The ID-CFI address space contains the values as defined in the description of the ID-CFI address space.
- The Status Register 1 contains 00h (all SR1 bits are cleared to 0's).
- The Configuration Register 1 contains 00h.
- The Autoboot register contains 00h.
- The Password Register contains FFFFFFFF-FFFFFFFFh
- All PPB bits are 1.
- The ASP Register contents depend on the ordering options selected:

Table 78. ASP Register Content

Ordering Part Number Model	ASPR Default Value
01, 21, 31, R1, A1, B1, C1, D1,91, Q1, 71, 61, 81	FE7Fh
K1, L1. S1, T1, Y1, Z1, M1, N1, U1, V1, W1, X1	FE4Fh

12 Ordering Information

The ordering part number is formed by a valid combination of the following:



Notes

1. Uniform 256-kB sectors = All sectors are uniform 256-kB with a 512B programming buffer.
2. EHPLC = Enhanced High Performance Latency Code table.
3. HPLC = High Performance Latency Code table.
4. Halogen free definition is in accordance with IE 61249-2-21 specification.

Valid Combinations — Standard

Valid Combinations list configurations planned to be supported in volume for this device. Consult your local sales office to confirm availability of specific valid combinations and to check on newly released combinations.

Valid Combinations — Standard					
Base Ordering Part Number	**Speed Option**	**Package and Temperature**	**Model Number**	**Packing Type**	**Package Marking [1]**
S25FL512S	AG	MFI, MFV	01, G1, R1	0, 1, 3	FL512S + A + (Temp) + F + (Model Number)
		BHI, BHV	21, 31, A1, B1, C1, D1	0, 3	FL512S + A + (Temp) + H + (Model Number)
	DP	MFI, MFV	01, G1	0, 1, 3	FL512S + D + (Temp) + F + (Model Number)
		BHI, BHV	21, 31, C1, D1	0, 3	FL512S + D + (Temp) + H + (Model Number)
	DS	MFI, MFV	01, G1, R1	0, 1, 3	FL512S + S + (Temp) + F + (Model Number)
		BHI, BHV	21, 31, A1, B1, C1, D1	0, 3	FL512S + S + (Temp) + H + (Model Number)

Note
1. Example, S25FL512SAGMFI000 package marking would be FL512SAIF00.

Valid Combinations — Automotive Grade / AEC-Q100

The table below lists configurations that are Automotive Grade / AEC-Q100 qualified and are planned to be available in volume. The table will be updated as new combinations are released. Consult your local sales representative to confirm availability of specific combinations and to check on newly released combinations.

Production Part Approval Process (PPAP) support is only provided for AEC-Q100 grade products.

Products to be used in end-use applications that require ISO/TS-16949 compliance must be AEC-Q100 grade products in combination with PPAP. Non–AEC-Q100 grade products are not manufactured or documented in full compliance with ISO/TS-16949 requirements.

AEC-Q100 grade products are also offered without PPAP support for end-use applications that do not require ISO/TS-16949 compliance.

Valid Combinations — Automotive Grade / AEC-Q100					
Base Ordering Part Number	**Speed Option**	**Package and Temperature**	**Model Number**	**Packing Type**	**Package Marking**
S25FL512S	AG	MFA, MFB, MFM	01, G1, R1	0, 1, 3	FL512S + A + (Temp) + F + (Model Number)
		BHA, BHB, BHM	21, 31, A1, B1, C1, D1	0, 3	FL512S + A + (Temp) + H + (Model Number)
	DP	BHB	21, C1	0, 3	FL512S + D + (Temp) + H + (Model Number)
	DS	MFA, MFB, MFM	01, G1, R1	0, 1, 3	FL512S + S + (Temp) + F + (Model Number)
		BHA, BHB, BHM	21, 31, A1, B1, C1, D1	0, 3	FL512S + S + (Temp) + H + (Model Number)

13. Revision History

Document History Page

Document Title: S25FL512S, 512 Mbit (64 Mbyte) 3.0 V SPI Flash Memory Document Number: 001-98284				
Rev.	**ECN No.**	**Orig. of Change**	**Submission Date**	**Description of Change**
**	–	BWHA	12/20/2011	Initial release
*A	–	BWHA	03/02/2012	General: Changed data sheet designation from Advance Information to Preliminary Performance Summary: Current Consumption table: corrected Serial Read 50 MHz and Serial Read 133 MHz values DC Characteristics: DC Characteristics table: corrected ICC1 values SDR AC Characteristics: AC Characteristics (Single Die Package, VIO = VCC 2.7V to 3.6V) table: corrected TCSH and TSU Max values AC Characteristics (Single Die Package, VIO 1.65V to 2.7V, VCC 2.7V to 3.6V) table: corrected TCSH and TSU Max values Embedded Algorithm Performance Tables: Program and Erase Performance table: corrected TW Typ and Max values Device ID and Common Flash Interface (ID-CFI) Address Map: Updated table: CFI Alternate Vendor-Specific Extended Query Parameter 0
*B	–	BWHA	05/02/2012	Global: Added 105°C updates Ordering Information: Updated Valid Combinations table Embedded Algorithm Performance Tables: Updated table: Program and Erase Performance
*C	–	BWHA	06/13/2012	SDR AC Characteristics: Updated tHO value from 0 Min to 2 ns Min
*D	–	BWHA	04/12/2013	Global: Data Sheet designation updated from Preliminary to Full Production
*E	–	BWHA	12/20//2013	Global 80 MHz DDR Read operation added Performance Summary: Updated Maximum Read Rates DDR (VIO = VCC = 3V to 3.6V) table Current Consumption table: added Quad DDR Read 80 MHz Migration Notes FL Generations Comparison table: updated DDR values for FL-S SDR AC Characteristics:Updated Clock Timing figure DDR AC Characteristics: Updated AC Characteristics — DDR Operation table DDR Output Timing: Updated SPI DDR Data Valid Window figure and Notes Ordering Information: Added 80 MHz to Speed option Valid Combinations table: added DS to Speed Option
*F	–	BWHA	01/08/2014	DDR AC Characteristics: Removed AC Characteristics 80 MHz Operation table
*G	–	BWHA	12/18/2014	SDR AC Characteristics: AC Characteristics (Single Die Package, V_{IO} = V_{CC} 2.7V to 3.6V) table: removed t_V (Min) value AC Characteristics (Single Die Package, V_{IO} 1.65V to 2.7V, V_{CC} 2.7V to 3.6V) table: removed t_V (Min) value Bank Address Register: Bank Address Register (BAR) table: corrected Bit 0 Serial Flash Discoverable Parameters (SFDP) Address Map: Updated section SFDP Overview Map table: updated Field Definitions: updated SFDP Header table Device ID and Common Flash Interface (ID-CFI) Address Map: Field Definitions: added CFI Alternate Vendor-Specific Extended Query Parameter A5h, JEDEC SFDP Rev B table

Document History Page (Continued)

Document Title: S25FL512S, 512 Mbit (64 Mbyte) 3.0 V SPI Flash Memory Document Number: 001-98284				
Rev.	**ECN No.**	**Orig. of Change**	**Submission Date**	**Description of Change**
*H	–	BWHA	01/21/2015	Capacitance Characteristics: Capacitance table: added T_A = 25°C under Test Conditions SDR AC Characteristics: AC Characteristics (Single Die Package, V_{IO} = V_{CC} 2.7V to 3.6V) table: changed t_{SU} (Min) Configuration Register 1 (CR1): Latency Codes for DDR Enhanced High Performance table: added 80 MHz Command Set Summary: S25FL512S Command Set (sorted by function) table: updated Maximum Frequency (MHz) of DDR Command Descriptions to 80 MHz Read Memory Array Commands: Changed 66 MHz to 80 MHz throughout section Software Interface Reference: S25FL512S Instruction Set (sorted by instruction) table: updated Maximum Frequency (MHz) of DDR Command Descriptions to 80 MHz
*I	4871631	BWHA	08/24/2015	Replaced “Automotive Temperature Range” with “Industrial Plus Temperature Range” in all instances across the document. Updated Signal Descriptions: Updated Versatile I/O Power Supply (V_{IO}): Updated description. Updated to Cypress template.
*J	5347120	TOCU	09/20/2016	Added ECC related information in all instances across the document. Added “Extended”, “Automotive, AEC-Q100 Grade 3”, “Automotive, AECQ100 Grade 2”, “Automotive, AEC-Q100 Grade 1” temperature range related information in all instances across the document. Added Logic Block Diagram. Updated Electrical Specifications: Added Thermal Resistance. Updated Power-Up and Power-Down: Updated Table 6: Changed minimum value of V_{CC} (low) parameter from 1.0 V to 1.6 V. Changed minimum value of t_{PD} parameter from 1.0 µs to 10.0 µs. Updated Timing Specifications: Updated SDR AC Characteristics: Updated Table 11: Updated Table 12: RUpdated DDR AC Characteristics: Updated Table 13: Changed minimum value of t_{HO} parameter corresponding to 66 MHz from 0 ns to 1.5 ns. Removed minimum value of t_V parameter. Updated Address Space Maps: Updated Registers: Added ECC Status Register (ECCSR). Added Table 17, Register Descriptions on page 48

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Document Title: S25FL512S, 512 Mbit (64 Mbyte) 3.0 V SPI Flash Memory Document Number: 001-98284				
Rev.	**ECN No.**	**Orig. of Change**	**Submission Date**	**Description of Change**
*J (cont.)	5347120	TOCU	09/20/2016	Updated Commands: Updated Command Set Summary: Updated Extended Addressing: Updated Table 39: Updated Register Access Commands: Updated Write Registers (WRR 01h): Updated description. Added ECC Status Register Read (ECCRD 18h). Updated Program Flash Array Commands: Updated Program Granularity: Added Automatic ECC. Added Data Integrity. Updated Ordering Information: No change in part numbers. Added Valid Combinations — Automotive Grade / AEC-Q100. Updated to new template.
*K	5613561	ECAO	03/17/2017	Updated t_{SU} in Table 11, AC Characteristics (Single Die Package, V_{IO} = V_{CC} 2.7V to 3.6V) on page 32. Updated Cypress logo and Sales page.
*L	5700261	BWHA	05/22/2017	Remove Extended Temperature Range MPN option Section 12, Ordering Information on page 141. Updated Package Drawings Section 6.1, SOIC 16-Lead Package on page 39, Section 6.2, FAB024 24-Ball BGA Package on page 41, Section 6.3, FAC024 24-Ball BGA Package on page 43. Updated Section 9.5.3, Quad Page Program (QPP 32h or 38h, or 4QPP 34h) on page 97. Added “DP” speed option in Valid Combinations — Automotive Grade / AEC-Q100 on page 142
*M	5959962	BWHA	11/10/2017	Updated Table 5 on page 24. Corrected JEDEC Sector Map Parameter Dword-2 in Table 66 on page 131. Updated Ordering Information on page 141 definition of letters in OPN indicating package material. Updated DDR Data Valid Timing Using DLP on page 38, Example. Updated Package Drawings on Physical Interface on page 39. Change the description of CR1[4] from “RFU” to “DNU” in Table 19 on page 50.
*N	5969843	BWHA	12/15/2017	Added Model C1 to DP speed option of Valid Combination in Valid Combinations — Automotive Grade / AEC-Q100 on page 142. Updated Sales page.
*O	6099450	BWHA	03/21/2018	Table 12 and Table 13: Removed the Max value of t_{CSH} and updated the Max value of t_{SU} as “3000”.
*P	6215133	BWHA	06/22/2018	Updated DDR Data Valid Timing Using DLP on page 38. Updated Package Materials in Ordering Information on page 141

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